

OCP NIC 3.0 Design Specification

Version 0.84

Author: OCP Server Workgroup, OCP NIC subgroup

Table of Contents

1	Overview		10
	1.1 Lice	nse	10
	1.2 Ackr	owledgements	11
	1.3 Refe	rences	12
	1.3.1	Trademarks	13
	1.4 Acro	nyms	14
		ground	
		view	
	1.6.1	Mechanical Form Factor Overview	
	1.6.2	Electrical Overview	
	1.6.2		
	1.6.2	, , , , , , , , , , , , , , , , , , , ,	_
	_	-NIC Use Cases	
2	_	Card Form Factor	
2		n Factor Options	
		·	
	2.1.1	SFF Faceplate Configurations	
	2.1.2	LFF Faceplate Configurations	
		Side I/O Implementations	
		Level Assembly (SFF and LFF)	
		plate Subassembly (SFF and LFF)	
	2.4.1	Faceplate Subassembly – Exploded View	
	2.4.2	Faceplate Subassembly – Bill of Materials (BOM)	
	2.4.3	SFF Generic I/O Faceplate	
	2.4.4	LFF Generic I/O Faceplate	
	2.4.5	Ejector Lever (SFF)	
	2.4.6	Ejector Levers (LFF)	38
	2.4.7	Ejector Lock (SFF and LFF)	39
	2.4.8	Ejector Bushing (SFF and LFF)	
	2.4.9	Ejector Wave Washer (SFF and LFF)	40
	2.5 Card	Keep Out Zones	41
	2.5.1	SFF Keep Out Zones	41
	2.5.2	LFF Keep Out Zones	44
	2.6 Base	board Keep Out Zones	46
		ation Requirements	
	2.7.1	SFF Insulator	47
	2.7.2	LFF Insulator	
	2.8 Criti	cal-to-Function (CTF) Dimensions (SFF and LFF)	
	2.8.1	CTF Tolerances	
	2.8.2	SFF Pull Tab CTF Dimensions	
	2.8.3	SFF OCP NIC 3.0 Card with Ejector Latch CTF Dimensions	
	2.8.4	SFF OCP NIC 3.0 Baseboard CTF Dimensions	
	2.8.5	LFF OCP NIC 3.0 Card CTF Dimensions	
	2.8.6	LFF OCP NIC 3.0 Baseboard CTF Dimensions	
		ling Requirements	
	2.9.1	General Guidelines for Label Contents	
	2.9.1	MAC Address Labeling Requirements	
	2.9.2	1 , 5	
	2.9.2	1	
	2.9.2	, ,	
	2.9.2		
_		hanical CAD Package Examples	
3		erface Definition – Card Edge and Baseboard	
		Edge Gold Finger Requirements	
	3.1.1	Gold Finger Mating Sequence	
		board Connector Requirements	
	3.2.1	Right Angle Connector	
	3.2.2	Right Angle Offset	71

3.2.3	Straddle Mount Connector	
3.2.4	Straddle Mount Offset and PCB Thickness Options	73
3.2.5	LFF Connector Locations	74
3.3 Pin	Definition	74
3.3.1	Primary Connector	
3.3.2	Secondary Connector	
3.4 Sign	nal Descriptions	
3.4.1	PCIe Interface Pins	
3.4.2	PCIe Present and Bifurcation Control Pins	
3.4.3	SMBus Interface Pins	
3.4.4	NC-SI over RBT Interface Pins	
3.4.5	Scan Chain Pins	
3.4.6	Power Supply Pins	
3.4.7	USB 2.0 (A68/A69) – Primary Connector Only	
3.4.8	UART (A68/A69) – Secondary Connector Only	
3.4.9	RFU[1:4] Pins.	
	e Bifurcation Mechanism	
3.5.1	PCIe OCP NIC 3.0 Card to Baseboard Bifurcation Configuration (PRSNTA#, PRSNTB[3:0]#)	
3.5.2	PCIe Baseboard to OCP NIC 3.0 Card Bifurcation Configuration (BIF[2:0]#)	
3.5.3	PCIe Bifurcation Decoder	
3.5.4	Bifurcation Detection Flow	
3.5.5	PCIe Bifurcation Examples	
3.5 3.5		
3.5 3.5	· · ·	
3.5		
	e REFCLK and PERST# Mapping	
3.6.1	SFF PCIe REFCLK and PERST# Mapping	
3.6.2	LFF PCIe REFCLK and PERST# Mapping	
3.6.3	REFCLK and PERST# Mapping Expansion	
	t Numbering and LED Implementations	
3.7.1	OCP NIC 3.0 Port Naming and Port Numbering	
3.7.2	OCP NIC 3.0 Card LED Configuration	
3.7.3	OCP NIC 3.0 Card LED Ordering	
3.7.4	Baseboard LEDs Configuration over the Scan Chain	
3.8 Pov	ver Capacity and Power Delivery	129
3.8.1	NIC Power Off	130
3.8.2	ID Mode	130
3.8.3	Aux Power Mode (S5)	130
3.8.4	Main Power Mode (S0)	130
3.9 Pov	ver Supply Rail Requirements and Slot Power Envelopes	131
	Swap Considerations for +12V_EDGE and +3.3V_EDGE Rails	
3.11 Pov	ver Sequence Timing Requirements	133
3.12 Dig	ital I/O Specifications	135
Manageme	nt and Pre-OS Requirements	136
4.1 Side	eband Management Interface and Transport	136
	SI Traffic	
	nagement Controller (MC) MAC Address Provisioning	
	nperature Reporting	
	ver Consumption Reporting	
	ggable Transceiver Module Status and Temperature Reporting	
	nagement and Pre-OS Firmware Inventory and Update	
4.7.1	Secure Firmware	
4.7.2	Firmware Inventory	
4.7.3	Firmware Inventory and Update in Multi-Host Environments	
4.8 NC- 4.8.1	SI Package Addressing and Hardware Arbitration Requirements	
4.0.1	IN THE VALUE OF THE CONTRACT CONTRACTOR OF THE C	142

4

4.9. SMBus 2.0 Addressing Requirements 4.10. FRU EEPROM. 4.10.1 FRU EEPROM. 4.10.2 FRU EEPROM. 4.10.3 FRU Template. 5 Routing Guidelines and Signal Integrity Considerations 5.1 NC-SI over RBT. 5.1.1 Timing Budget. 5.2 SMBus 2.0. 5.3 PCIE. 5.3.1.1 REFCLX requirements. 5.3.1.1 REFCLX requirements. 5.3.1.1 REFCLX requirements. 5.3.1.1 REFCLX requirements. 5.3.1.2 Add-in Card Electrical Budgets. 5.3.1.3 Baseboard Channel Budget. 5.3.1.5 Differential Impedance (Informative). 5.3.1 Test Fixtures. 5.3.2.1 Load Board. 5.3.2.2 Baseboard. 5.3.3.1 Test Methodology. 5.3.3.1 Fest Setup. 6.1 Hoft Abise Cooling. 6.1.2 Cold Aisle Cooling. 6.2.1 EFF Card ASIC Cooling. Hot Aisle. 6.2.2 LFF Card ASIC Cooling. Hot Aisle. 6.2.3 SFF Card ASIC Cooling. Cold Aisle. 6.2.4 LFF Card ASIC Cooling. Cold Aisle. 6.2.5 LFF Card ASIC Cooling. Cold Aisle. 6.2.4 LFF Card ASIC Cooling. Cold Aisle. 6.2.5 LFF Card ASIC Cooling. Cold Aisle. 6.2.6 Test Fixture. 6.4.1 Test Fixture for SFF Card. 6.4.2 Test Fixture for SFF Card. 6.4.3 Test Fixture for SFF Card. 6.4.4 Thermal Test Fixture. 6.6.5 Card Senors Requirements. 6.6.6 Card Cooling Tiers. 6.6.7 Non-Operational Shock & Wibartion Testing. 6.7.1 Shock & Vibe Test Fixture. 6.8 Dye and Pull Test Method. 6.9 Gold Finger Plating Requirements. 6.9 Gold Finger Plating Requirements. 6.9 Look Finger Plating Requirements. 6.9 Line Side Gold Finger Plating Requirements. 6.9 Line Side Gold Finger Plating Requirements. 6.9 Line Side Gold Finger Durability Requirements. 7.1 Required Compliance. 7.1.1 Required Compliance. 7.1.2 Recommended Compliance. 7.1.3 Recommended Compliance. 7.1.4 Required Environmental Compliance. 7.2 Recommended Compliance.		4.8.2	Arbitration Ring Connections	143
4.9.1 SMBus Address Map 4.10 FRU EEPROM. Address, Size and Availability. 4.10.2 FRU EEPROM Content Requirements. 4.10.3 FRU Template. 5 Routing Guidelines and Signal Integrity Considerations. 5.1 N.CS over RBT. 5.1 Timing Budget. 5.2 SMBus 2.0 5.3 PCE 5.3.1 Channel Requirements. 5.3.1.1 RFCLK requirements. 5.3.1.2 Add-in Card Electrical Budgets. 5.3.1.2 Add-in Card Electrical Budgets. 5.3.1.2 SBBus 2.0 5.3.1.3 Baseboard Channel Budget. 5.3.1.4 SFF-TA-1002 Connector Channel Budget. 5.3.1.5 Differential Impedance (Informative). 5.3.2.1 Load Board. 5.3.2.1 Load Board. 5.3.3 Test Rixtures. 5.3.2.2 Baseboard. 5.3.3 Test Methodology. 5.3.3.1 Test Setup. 6 Thermal and Environmental. 6.1 Airflow Direction. 6.1.1 Hot Asise Cooling. 6.2.1 SFF Card ASIC Cooling — Hot Aisle. 6.2.1 SFF Card ASIC Cooling — Hot Aisle. 6.2.1 SFF Card ASIC Cooling — Hot Aisle. 6.3.3 FFF amal Simulation (CFP) Modeling. 6.4 Thermal Fishture and Cooling. 6.4 Thermal Fishture Cooling. 6.5 Test Fixture. 6.6.1 Test Fixture. 6.6.2 Cold Aisle Cooling. 6.6.3 Thermal Simulation (CFP) Modeling. 6.6.4 Thermal Test Fixture (CFP) Modeling. 6.6.5 Test Fixture Fixture. 6.6.6 Card Cooling Ters. 6.6.1 Hot Aisle Cooling Ters. 6.6.2 Cold Aisle Cooling Ters. 6.6.3 Thermal Simulation (CFP) Modeling. 6.7 Test Fixture Requirements. 6.8 Dye and Pull Test Method. 6.9 Gold Finger Plating Requirements. 6.9 Gold Finger Plating Requirements. 6.9 Cold Finger Plating Requirements. 6.9 Line Side Gold Finger Plating Requirements. 6.9 Calcoming Ters. 6.9 Calcoming Ters. 6.1 Hot Aisle Compliance. 7.1 Required Compliance. 7.1 Required Compliance. 7.1 Required Compliance. 7.1 Required Environmental Compliance. 7.1 Required Compliance. 7.2 Recommended Compliance. 7.2 Recommended Compliance.		_		
4.10.1 FRU EEPROM 4.10.1 FRU EEPROM Address, Size and Availability 4.10.2 FRU EEPROM Content Requirements 4.10.3 FRU Template 5 Routing Guidelines and Signal Integrity Considerations 5.1 NC-SI over RBT 5.1.1 Timing Budget 5.2 SMBus 2.0 5.3 PCIe				
4.10.1 FRU EEPROM Address, Size and Availability. 4.10.2 FRU EEPROM Content Requirements. 4.10.3 FRU Template. 5 Routing Guidelines and Signal Integrity Considerations. 5.1 N.C.SI over RBT 5.1 Timing Budget. 5.2 SMBus 2.0		_	·	
4.10.2 FRU EEPROM Content Requirements 4.10.3 FRU Template 5.1 NC-SI over RBT 5.1.1 Timing Budget 5.2 SMBus 2.0 5.3 PCIe 5.3.1.1 REFCLK requirements 5.3.1.1 REFCLK requirements 5.3.1.2 Add-in Card Electrical Budgets 5.3.1.3 Baseboard Channel Budget 5.3.1.5 Differential Impedance (Informative) 5.3.2 Test Fixtures 5.3.2.1 Load Board 5.3.2.2 Baseboard 5.3.3.3 Test Methodology 5.3.3.1 Test Setup 6 Thermal and Environmental 6.1 Airflow Direction 6.1.1 Hot Aisle Cooling 6.2 Thermal Design Guidelines 6.2.2 LFF Card ASIC Cooling – Hot Aisle 6.2.3 FFC ard ASIC Cooling – Hot Aisle 6.2.4 LF Card ASIC Cooling – Gold Aisle 6.3 Thermal Simulation (CFD) Modeling 6.4 Thermal Test Fixture 6.4.1 Test Fixture For LFF Card 6.4.2 Test Fixture For LFF Card 6.4.3 Test Fixture For LFF Card 6.4.4 Test Fixture For LFF Card 6.4.5 Test Fixture For LFF Card 6.4.1 Test Fixture For LFF Card 6.4.2 Test Fixture For LFF Card 6.4.3 Test Fixture For LFF Card 6.4.1 Test Fixture For LFF Card 6.4.2 Test Fixture For LFF Card 6.4.3 Test Fixture For LFF Card 6.4.1 Test Fixture For LFF Card 6.4.2 Test Fixture For LFF Card 6.4.3 Test Fixture For LFF Card 6.4.4 Thermal Test Fixture Candlestick Sensors. 6.5 Card Sensor Requirements 6.6.1 Hot Aisle Cooling Tiers 6.6.2 Cold Aisle Cooling Tiers 6.6.3 Thermal Simulation (CFD) Modeling 6.4 Thermal Test Fixture Candlestick Sensors. 6.5 Card Sensor Requirements 6.6.1 Hot Aisle Cooling Tiers 6.6.2 Cold Aisle Cooling Tiers 6.6.3 Test Fixture Bruth Product Safety Wibration Testing 6.7.1 Shock & Wibe Test Fixture 6.7.2 Test Procedure 6.8 Dye and Pull Test Method 6.9 Gold Finger Plating Requirements 6.9.1 Hot Side Gold Finger Plating Requirements 6.9.2 Line Side Gold Finger Plating Requirements 6.9.3 Test Required Environmental Compliance 7.1.1 Required Environmental Compliance 7.1.2 Required Environmental Compliance 7.1.3 Required Founduct Safety Compliance 7.1.4 Required Environmental Compliance				
4.10.3 FRU Template 5 Routing Guidelines and Signal Integrity Considerations 5.1 NC-SI over RBT 5.1.1 Timing Budget 5.2 SMBus 2.0 5.3 PCIe. 5.3.1. REFCIK requirements. 5.3.1.1 REFCIK requirements. 5.3.1.2 Add-in Card Electrical Budgets 5.3.1.3 Baseboard Channel Budget 5.3.1.5 Differential Impedance (Informative) 5.3.1.5 Differential Impedance (Informative) 5.3.2.1 Load Board 5.3.2.1 Test Fixtures. 5.3.2.1 Load Board 5.3.3.1 Test Setup 5.3.3.1 Test Setup 5.3.3.1 Test Setup 6.1 Airflow Direction. 6.1.1 Hoft Aisle Cooling 6.2 Cold Aisle Cooling 6.2 Thermal Design Guidelines 6.2.1 SF Card ASIC Cooling - Hot Aisle 6.2.2 LFF Card ASIC Cooling - Hot Aisle 6.2.3 SFF Card ASIC Cooling - Cold Aisle 6.3 Thermal Simulation (CFD) Modeling 6.4 Thermal Test Fixture 6.4.1 Test Fixture for SFF Card 6.4.3 Test Fixture For SFF Card 6.4.4 Thermal Test Fixture 6.4.1 Test Fixture For LFF Card 6.4.2 Test Fixture For LFF Card 6.4.3 Test Fixture For LFF Card 6.4.4 Thermal Test Fixture 6.4.1 Test Fixture For LFF Card 6.4.2 Test Fixture For LFF Card 6.4.3 Test Fixture For LFF Card 6.4.4 Thermal Test Fixture 6.5 Card Gooling Tiers 6.6 Card Cooling Tiers 6.6.1 Hot Aisle Cooling Tiers 6.6.2 Cold Aisle Cooling Tiers 6.6.3 Dye and Pull Test Method 6.9 Gold Finger Plating Requirements 6.9.1 Host Side Gold Finger Plating Requirements 6.9.1 Host Side Gold Finger Plating Requirements 6.9.2 Line Side Gold Finger Putsing Requirements 6.9.1 Line Side Gold Finger Putsing Requirements 6.9.2 Line Side Gold Finger Putsing Requirements 6.9.1 Required Environmental Compliance 7.1.1 Required Environmental Compliance 7.1.2 Required Environmental Compliance 7.1.1 Required Environmental Compliance 7.1.1 Required Environmental Compliance 7.1.2 Recommended Environmental Compliance		_		
5.1 NC-SI over RBT		_		
5.1 NC-5I over RBT 5.1.1 Timing Budget 5.2 SMBus 2.0 5.3 PCle 5.3.1 Channel Requirements 5.3.1.1 REFCLK requirements 5.3.1.2 Add-in Card Electrical Budgets 5.3.1.3 Baseboard Channel Budget 5.3.1.5 Differential Impedance (Informative) 5.3.1.5 Differential Impedance (Informative) 5.3.2 Test Fixtures 5.3.2.1 Load Board 5.3.2.2 Baseboard 5.3.3 Test Methodology 5.3.3 Test Methodology 5.3.3.1 Test Setup 6.1 Airflow Direction 6.1.1 Hot Aisle Cooling 6.1.2 Cold Aisle Cooling 6.1.2 Cold Aisle Cooling 6.2.1 SFF Card ASIC Cooling - Hot Aisle 6.2.2 Thermal Design Guidelines 6.2.3 SFF Card ASIC Cooling - Hot Aisle 6.2.4 LFF Card ASIC Cooling - Cold Aisle 6.2.5 LFF Card ASIC Cooling - Cold Aisle 6.2.6 LFF Card ASIC Cooling - Cold Aisle 6.2.1 Test Fixture 6.2.4 Thermal Test Fixture 6.2.5 Thermal Is mulation (CFD) Modeling 6.4 Thermal Test Fixture 6.4.1 Test Fixture for SFF Card 6.4.2 Test Fixture for SFF Card 6.4.3 Test Fixture for SFF Card 6.4.4 Thermal Test Fixture 6.5 Card Gooling Tiers 6.6.1 Hot Aisle Cooling Tiers 6.6.2 Cold Aisle Cooling Tiers 6.6.3 Thermal Shock & Viba Test Fixture 6.4 Thermal Test Fixture for SFF Card 6.5 Card Cooling Tiers 6.6.1 Hot Aisle Cooling Tiers 6.6.2 Cold Aisle Cooling Tiers 6.6.3 Thermal Shock & Viba Test Fixture 6.7 Non-Operational Shock & Viba Test Fixture 6.8 Dye and Pull Test Method 6.9 Gold Finger Plating Requirements 6.9 Line Side Gold Finger Plurability Requirements 6.9 Cold Aisle Gold Finger Plurability Requirements 6.9 Line Side Gold Finger Plurability Requirements 6.9 Cold Finger Plating Requirements 6.9 Cold				
5.1 Timing Budget. 5.2 SMBus 2.0	5	_		
5.2 SMBus 2.0 5.3 PCIe 5.3.1 Channel Requirements 5.3.1.1 REFCLK requirements 5.3.1.2 Add-in Card Electrical Budgets 5.3.1.3 Baseboard Channel Budget 5.3.1.4 SFF-TA-1002 Connector Channel Budget 5.3.1.5 Differential Impedance (Informative) 5.3.2 Test Fixtures 5.3.2.1 Load Board 5.3.2.2 Baseboard 5.3.3.3 Test Methodology 5.3.3.1 Test Setup 6.1 Airflow Direction 6.1.1 Hot Aisle Cooling 6.1.2 Cold Aisle Cooling 6.1.2 Cold Aisle Cooling 6.2.1 SFF Card ASIC Cooling - Hot Aisle 6.2.2 LFF Card ASIC Cooling - Hot Aisle 6.2.3 SFF Card ASIC Cooling - Cold Aisle 6.2.4 LFF Card ASIC Cooling - Cold Aisle 6.2.5 LFF Card ASIC Cooling - Cold Aisle 6.2.6 LFF Card ASIC Cooling - Cold Aisle 6.2.1 Test Fixture for LFF Card 6.4.1 Test Fixture for LFF Card 6.4.1 Test Fixture for LFF Card 6.4.2 Test Fixture for LFF Card 6.4.3 Test Fixture for LFF Card 6.4.4 Thermal Test Fixture 6.5 Card Sensor Requirements 6.6 Card Cooling Tiers 6.7 Non-Operational Shock & Vibration Testing 6.7.1 Shock & Vibe Test Fixture 6.9 Gold Finger Plating Requirements 6.9 Gold Finger Plating Requirements 6.9 Gold Finger Plating Requirements 6.9 Line Side Gold Finger Durability Requirements 6.9 Line Side Gold Finger Durability Requirements 7.1 Required Compliance 7.1.1 Required Immunity (ESD) Compliance 7.1.2 Recommended Compliance 7.2 Recommended Compliance 7.2 Recommended Environmental Compliance 7.2 Recommended Compliance				
5.3 PCIe. 5.3.1 Channel Requirements. 5.3.1.1 REFCLK requirements. 5.3.1.2 Add-in Card Electrical Budgets. 5.3.1.3 Baseboard Channel Budget. 5.3.1.4 SFF-TA-1002 Connector Channel Budget. 5.3.1.5 Differential Impedance (Informative) 5.3.2 Test Fixtures. 5.3.2.1 Load Board. 5.3.2.2 Baseboard. 5.3.2.2 Baseboard. 5.3.3.3 Test Methodology. 5.3.3.1 Test Setup. 6.1 Airflow Direction. 6.1.1 Hot Aisle Cooling. 6.1.2 Cold Aisle Cooling. 6.2.1 Erramal Design Guidelines. 6.2.1 SFF Card ASIC Cooling — Hot Aisle. 6.2.2 LFF Card ASIC Cooling — Flot Aisle. 6.2.3 SFF Card ASIC Cooling — Cold Aisle. 6.2.4 LFF Card ASIC Cooling — Cold Aisle. 6.2.5 Thermal Statistic — Cold Aisle. 6.2.6 Thermal Statistic — Cold Aisle. 6.2.1 Test Fixture for SFF Card. 6.4.1 Test Fixture for SFF Card. 6.4.2 Test Fixture for LFF Card. 6.4.3 Test Fixture for LFF Card. 6.4.4 Thermal Test Fixture. 6.4.4 Thermal Test Fixture. 6.4.4 Thermal Test Fixture Conditions. 6.5 Card Sensor Requirements. 6.6 Card Cooling Tiers. 6.6.1 Hot Aisle Cooling Tiers. 6.6.1 Hot Aisle Cooling Tiers. 6.6.2 Cold Aisle Cooling Tiers. 6.6.3 Dye and Pull Test Method. 6.9 Gold Finger Plating Requirements. 6.9.1 Hot Side Gold Finger Plating Requirements. 6.9.2 Line Side Gold Finger Durability Requirements. 7.1 Required Compliance. 7.1.1 Required Product Safety Compliance. 7.1.2 Recommended Compliance. 7.1.3 Required Product Safety Compliance. 7.1.4 Recommended Compliance. 7.1.5 Recommended Environmental Compliance. 7.1.1 Recommended Compliance. 7.1.2 Recommended Environmental Compliance.		_		
5.3.1. Channel Requirements 5.3.1.2 Add-in Card Electrical Budgets 5.3.1.3 Baseboard Channel Budget 5.3.1.4 SFF-TA-1002 Connector Channel Budget 5.3.1.5 Differential Impedance (Informative) 5.3.2 Test Fixtures. 5.3.2.1 Load Board 5.3.2.2 Baseboard 5.3.3.3 Test Methodology 5.3.3.1 Test Stup. 6 Thermal and Environmental 6.1 Airflow Direction. 6.1.1 Hot Aisle Cooling. 6.1.2 Cold Aisle Cooling. 6.1.2 Cold Aisle Cooling. 6.2.1 SFF Card ASIC Cooling – Hot Aisle 6.2.2 LFF Card ASIC Cooling – Hot Aisle 6.2.3 SFF Card ASIC Cooling – Cold Aisle 6.2.4 LFF Card ASIC Cooling – Cold Aisle 6.3 Thermal Simulation (CFD) Modeling 6.4 Thermal Test Fixture 6.4.1 Test Fixture for FFF Card 6.4.2 Test Fixture for SFF Card 6.4.3 Test Fixture Airflow Direction 6.5 Card Cooling Tiers 6.6 Card Cooling Tiers 6.6.1 Hot Aisle Cooling Tiers 6.6.2 Cold Aisle Cooling Tiers 6.6.3 Hot Aisle Cooling Tiers 6.6.1 Hot Aisle Cooling Tiers 6.6.2 Line Side Gold Finger Plating Requirements <td< th=""><th></th><td></td><td></td><td></td></td<>				
5.3.1.1 REFCLK requirements. 5.3.1.2 Add-in Card Electrical Budgets. 5.3.1.3 Baseboard Channel Budget. 5.3.1.5 Differential Impedance (informative). 5.3.2 Test Fixtures. 5.3.2.1 Load Board. 5.3.2.2 Baseboard 5.3.3 Test Methodology. 5.3.3.1 Test Setup. 6 Thermal and Environmental. 6.1 Hot Aisle Cooling. 6.1.2 Cold Aisle Cooling. 6.1.2 Cold Aisle Cooling. 6.2.1 SFF Card ASIC Cooling — Hot Aisle. 6.2.2 LFF Card ASIC Cooling — Cold Aisle. 6.2.3 SFF Card ASIC Cooling — Cold Aisle. 6.2.4 LFF Card ASIC Cooling — Cold Aisle. 6.3 Thermal Test Fixture. 6.4.1 Test Fixture for LFF Card. 6.4.2 Test Fixture for LFF Card. 6.4.3 Test Fixture for LFF Card. 6.4.4 Thermal Test Fixture Candlestick Sensors. 6.5 Card Sensor Requirements. 6.6.1 Hot Aisle Cooling Tiers. 6.6.2 Cold Aisle Cooling Tiers. 6		5.3 PCle.		149
5.3.1.2 Add-in Card Electrical Budgets 5.3.1.3 Baseboard Channel Budget 5.3.1.4 SFF-TA-1002 Connector Channel Budget 5.3.1.5 Differential Impedance (Informative) 5.3.2 Test Fixtures 5.3.2.1 Load Board 5.3.2.2 Baseboard 5.3.3.1 Test Methodology 5.3.3.1 Test Methodology 5.3.3.1 Test Setup 6 Thermal and Environmental 6.1 Airflow Direction 6.1.1 Hot Aisle Cooling 6.1.2 Cold Aisle Cooling 6.1.2 Cold Aisle Cooling 6.2.1 SFF Card ASIC Cooling - Hot Aisle 6.2.2 LFF Card ASIC Cooling - Hot Aisle 6.2.3 SFF Card ASIC Cooling - Hot Aisle 6.2.4 LFF Card ASIC Cooling - Cold Aisle 6.2.5 LFF Card ASIC Cooling - Cold Aisle 6.2.6 LFF Card ASIC Cooling - Cold Aisle 6.3 Thermal Simulation (CFD) Modeling 6.4 Thermal Test Fixture 6.4.1 Test Fixture for SFF Card 6.4.2 Test Fixture for SFF Card 6.4.3 Test Fixture for SFF Card 6.4.4 Thermal Test Fixture Candlestick Sensors 6.5 Card Sensor Requirements 6.6 Card Cooling Tiers 6.6.1 Hot Aisle Cooling Tiers 6.6.2 Cold Aisle Cooling Tiers 6.6.1 Hot Aisle Cooling Tiers 6.7 Non-Operational Shock & Vibration Testing 6.7.1 Shock & Vibr Test Fixture 6.8 Dye and Pull Test Method 6.9 Gold Finger Plating Requirements 6.9 Gold Finger Plating Requirements 6.9 Gold Finger Plating Requirements 6.9 Required Compliance 7.1 Required Compliance 7.1.1 Required Immunity (ESD) Compliance 7.1.2 Recommended Compliance 7.1.3 Recommended Compliance 7.1.4 Recommended Compliance 7.2.1 Recommended Compliance		5.3.1	Channel Requirements	149
5.3.1.3 Baseboard Channel Budget 5.3.1.4 SFF-TA-100Z Connector Channel Budget 5.3.1.5 Differential Impedance (Informative) 5.3.2 Test Fixtures. 5.3.2.1 Load Board 5.3.2.2 Baseboard 5.3.3.3 Test Methodology 5.3.3.1 Test Setup. 6 Thermal and Environmental 6.1 Airflow Direction. 6.1.1 Hot Aisle Cooling 6.1.2 Cold Aisle Cooling 6.1.2 Cold Aisle Cooling 6.2.1 Thermal Design Guidelines 6.2.1 SFF Card ASIC Cooling - Hot Aisle 6.2.2 LFF Card ASIC Cooling - Hot Aisle 6.2.3 SFF Card ASIC Cooling - Cold Aisle 6.2.4 LFF Card ASIC Cooling - Cold Aisle 6.2.4 LFF Card ASIC Cooling - Cold Aisle 6.2.4 LFF Card ASIC Cooling - Cold Aisle 6.2.4 Thermal Test Fixture 6.4.1 Test Fixture for SFF Card 6.4.2 Test Fixture for SFF Card 6.4.2 Test Fixture for SFF Card 6.4.3 Test Fixture for SFF Card 6.4.4 Thermal Test Fixture Candlestick Sensors 6.5 Card Sensor Requirements 6.6 Card Cooling Tiers 6.6.1 Hot Aisle Cooling Tiers 6.6.2 Cold Aisle Cooling Tiers 6.6.1 Hot Aisle Cooling Tiers 6.6.2 Cold Aisle Cooling Tiers 6.6.1 Hot Aisle Cooling Tiers 6.6.2 Test Procedure 6.8 Dye and Pull Test Method. 6.9 Gold Finger Plating Requirements 6.9.1 Host Side Gold Finger Plating Requirements 6.9.1 Host Side Gold Finger Plating Requirements 7.1 Required Compliance 7.1.1 Required Environmental Compliance 7.1.2 Required Immunity (ESD) Compliance 7.1.3 Required Immunity (ESD) Compliance 7.1.4 Recommended Compliance 7.1.5 Recommended Compliance 7.1.6 Recommended Environmental Compliance		5.3.1	.1 REFCLK requirements	149
5.3.1.4 SFF-TA-1002 Connector Channel Budget 5.3.1.5 Differential Impedance (Informative) 5.3.2.1 Test Fixtures 5.3.2.1 Load Board 5.3.2.2 Baseboard 5.3.3.1 Test Methodology 5.3.3.1 Test Setup 6 Thermal and Environmental 6.1 Airflow Direction 6.1.1 Hot Aisle Cooling 6.1.2 Cold Aisle Cooling 6.2.1 SFF Card ASIC Cooling – Hot Aisle 6.2.1 SFF Card ASIC Cooling – Hot Aisle 6.2.2 LFF Card ASIC Cooling – Hot Aisle 6.2.3 SFF Card ASIC Cooling – Cold Aisle 6.2.4 LFF Card ASIC Cooling – Cold Aisle 6.2.4 LFF Card ASIC Cooling – Cold Aisle 6.2.4 Thermal Simulation (CFD) Modeling 6.4 Thermal Test Fixture 6.4.1 Test Fixture for SFF Card 6.4.2 Test Fixture for LFF Card 6.4.3 Test Fixture for LFF Card 6.4.4 Thermal Test Fixture Candlestick Sensors 6.5 Card Sensor Requirements 6.6 Card Cooling Tiers 6.6.1 Hot Aisle Cooling Tiers 6.6.2 Cold Aisle Cooling Tiers 6.6.2 Cold Aisle Cooling Tiers 6.6.3 Dye and Pull Test Method 6.9 Gold Finger Plating Requirements 6.9.1 Host Side Gold Finger Plating Requirements 6.9.1 Host Side Gold Finger Plating Requirements 6.9.2 Line Side Gold Finger Plating Requirements 6.9.1 Required Environmental Compliance 7.1.1 Required Environmental Compliance 7.1.2 Required Find Compliance 7.1.3 Required Find Compliance 7.1.4 Required Immunity (ESD) Compliance 7.1.2 Recommended Environmental Compliance 7.1.2 Recommended Compliance 7.1.3 Recommended Compliance 7.1.4 Recommended Environmental Compliance		5.3.1	.2 Add-in Card Electrical Budgets	149
5.3.1		5.3.1	3 Baseboard Channel Budget	149
5.3.2 Test Fixtures 5.3.2.1 Load Board 5.3.2.2 Baseboard 5.3.3.3 Test Methodology 5.3.3.1 Test Setup 6 Thermal and Environmental 6.1 Airflow Direction 6.1.1 Hot Aisle Cooling 6.1.2 Cold Aisle Cooling 6.2.1 SFF Card ASIC Cooling – Hot Aisle 6.2.1 SFF Card ASIC Cooling – Hot Aisle 6.2.2 LFF Card ASIC Cooling – Hot Aisle 6.2.3 SFF Card ASIC Cooling – Cold Aisle 6.2.4 LFF Card ASIC Cooling – Cold Aisle 6.2.5 Thermal Test Fixture (FD) Modeling 6.4 Thermal Test Fixture for SFF Card 6.4.1 Test Fixture for SFF Card 6.4.2 Test Fixture Airflow Direction 6.4.4 Thermal Test Fixture Candlestick Sensors 6.5 Card Sensor Requirements 6.6 Card Cooling Tiers 6.6.1 Hot Aisle Cooling Tiers 6.6.2 Cold Aisle Cooling Tiers 6.6.3 Dye and Pull Test Method 6.9 Gold Finger Plating Requirements 6.9 Gold Finger Plating Requirements 6.9 Gold Finger Plating Requirements 6.9.1 Host Side Gold Finger Plating Requirements 6.9.2 Line Side Gold Finger Plating Requirements 6.9.1 Line Side Gold Finger Plating Requirements 6.9.1 Required Environmental Compliance 7.1.2 Required Environmental Compliance 7.1.3 Required Immunity (ESD) Compliance 7.1.4 Recommended Environmental Compliance 7.1.1 Recommended Environmental Compliance 7.1.2 Recommended Environmental Compliance 7.1.1 Recommended Environmental Compliance		5.3.1	.4 SFF-TA-1002 Connector Channel Budget	149
5.3.2.1 Load Board 5.3.2.2 Baseboard 5.3.3.1 Test Methodology. 5.3.3.1 Test Setup. 6 Thermal and Environmental 6.1 Airflow Direction 6.1.1 Hot Aisle Cooling 6.1.2 Cold Aisle Cooling 6.1.2 SFF Card ASIC Cooling – Hot Aisle 6.2.1 SFF Card ASIC Cooling – Hot Aisle 6.2.2 LFF Card ASIC Cooling – Hot Aisle 6.2.3 SFF Card ASIC Cooling – Cold Aisle 6.2.4 LFF Card ASIC Cooling – Cold Aisle 6.3 Thermal Test Fixture for LFF Card 6.4 Thermal Test Fixture 6.4.1 Test Fixture for LFF Card 6.4.2 Test Fixture for LFF Card 6.4.3 Test Fixture for LFF Card 6.4.4 Thermal Test Fixture Candlestick Sensors 6.5 Card Sensor Requirements 6.6 Card Cooling Tiers 6.6.1 Hot Aisle Cooling Tiers 6.6.2 Cold Aisle Cooling Tiers 6.6.1 Hot Aisle Cooling Tiers 6.6.2 Cold Aisle Cooling Tiers 6.6.3 Dye and Pull Test Method 6.9 Gold Finger Plating Requirements 6.9 Gold Finger Plating Requirements 6.9.1 Host Side Gold Finger Durability Requirements 6.9.2 Line Side Gold Finger Durability Requirements 6.9.1 Required Compliance 7.1.1 Required Emic Compliance 7.1.2 Required Immunity (ESD) Compliance 7.1.3 Required Immunity (ESD) Compliance 7.1.4 Required Immunity (ESD) Compliance 7.2.1 Recommended Environmental Compliance		5.3.1	5 Differential Impedance (Informative)	149
5.3.2 Baseboard 5.3.3 Test Methodology 5.3.3.1 Test Setup Thermal and Environmental 6.1 Airflow Direction 6.1.1 Hot Aisle Cooling 6.1.2 Cold Aisle Cooling 6.1.2 Thermal Design Guidelines 6.2.1 SFF Card ASIC Cooling – Hot Aisle 6.2.2 LFF Card ASIC Cooling – Hot Aisle 6.2.3 SFF Card ASIC Cooling – Cold Aisle 6.2.4 LFF Card ASIC Cooling – Cold Aisle 6.3 Thermal Simulation (CFD) Modeling 6.4 Thermal Test Fixture 6.4.1 Test Fixture for SFF Card 6.4.2 Test Fixture for SFF Card 6.4.3 Test Fixture Airflow Direction 6.4.4 Thermal Test Fixture Candlestick Sensors 6.5 Card Sensor Requirements 6.6 Card Cooling Tiers 6.6.1 Hot Aisle Cooling Tiers 6.6.2 Cold Aisle Cooling Tiers 6.6.1 Hot Aisle Cooling Tiers 6.6.2 Cold Aisle Cooling Tiers 6.6.3 Thermal Shock & Vibration Testing 6.7.1 Shock & Vibe Test Fixture 6.7.2 Test Procedure 6.8 Dye and Pull Test Method 6.9 Gold Finger Plating Requirements 6.9.1 Host Side Gold Finger Plating Requirements 6.9.2 Line Side Gold Finger Plating Requirements 6.9.1 Required Compliance 7.1.1 Required Environmental Compliance 7.1.2 Required Immunity (ESD) Compliance 7.1.3 Required Immunity (ESD) Compliance 7.1.4 Recommended Environmental Compliance 7.2.1 Recommended Environmental Compliance		5.3.2	Test Fixtures	150
5.3.3.1 Test Methodology 5.3.3.1 Test Setup 6 Thermal and Environmental 6.1 Airflow Direction 6.1.1 Hot Aisle Cooling 6.2.2 Cold Aisle Cooling 6.2.2 LFF Card ASIC Cooling – Hot Aisle 6.2.3 SFF Card ASIC Cooling – Hot Aisle 6.2.4 LFF Card ASIC Cooling – Cold Aisle 6.4.1 Test Fixture for SFF Card 6.4.2 Test Fixture for LFF Card 6.4.2 Test Fixture for LFF Card 6.4.3 Test Fixture for LFF Card 6.4.4 Thermal Test Fixture Candlestick Sensors 6.5 Card Sensor Requirements 6.6 Card Cooling Tiers 6.6.1 Hot Aisle Cooling Tiers 6.6.2 Cold Aisle Cooling Tiers 6.6.3 Non-Operational Shock & Vibration Testing 6.7.1 Shock & Vibe Test Fixture 6.7.2 Test Procedure 6.8 Dye and Pull Test Method 6.9 Gold Finger Plating Requirements 6.9.1 Host Side Gold Finger Plating Requirements 6.9.2 Line Side Gold Finger Durability Requirements 6.9.1 Host Side Gold Finger Plating Requirements 6.9.2 Line Side Gold Finger Durability Requirements 7.1 Required Environmental Compliance 7.1.1 Required Environmental Compliance 7.1.2 Required Immunity (ESD) Compliance 7.1.3 Required Immunity (ESD) Compliance 7.2.1 Recommended Environmental Compliance		5.3.2	1 Load Board	150
5.3.3.1 Test Setup 6 Thermal and Environmental 6.1 Airflow Direction 6.1.1 Hot Aisle Cooling 6.1.2 Cold Aisle Cooling 6.2.1 SFF Card ASIC Cooling — Hot Aisle 6.2.2 LFF Card ASIC Cooling — Hot Aisle 6.2.3 SFF Card ASIC Cooling — Cold Aisle 6.2.4 LFF Card ASIC Cooling — Cold Aisle 6.2.5 Thermal Design Guidelines 6.2.6 LFF Card ASIC Cooling — Cold Aisle 6.2.7 Thermal Test Fixture Cooling — Cold Aisle 6.2.8 Thermal Simulation (CFD) Modeling 6.4 Thermal Test Fixture for SFF Card 6.4.1 Test Fixture for SFF Card 6.4.2 Test Fixture for SFF Card 6.4.3 Test Fixture Airflow Direction 6.4.4 Thermal Test Fixture Candlestick Sensors 6.5 Card Sensor Requirements 6.6 Card Cooling Tiers 6.6.1 Hot Aisle Cooling Tiers 6.6.2 Cold Aisle Cooling Tiers 6.6.3 Cool Aisle Cooling Tiers 6.6.4 Non-Operational Shock & Vibration Testing 6.7.1 Shock & Vibe Test Fixture 6.7.2 Test Procedure 6.8 Dye and Pull Test Method 6.9 Gold Finger Plating Requirements 6.9.1 Hots Side Gold Finger Plating Requirements 6.9.2 Line Side Gold Finger Plating Requirements 6.9.3 Required Compliance 7.1.1 Required Environmental Compliance 7.1.2 Required Environmental Compliance 7.1.3 Required Froduct Safety Compliance 7.1.4 Required Immunity (ESD) Compliance 7.2.7 Recommended Compliance 7.2.7 Recommended Compliance		5.3.2	2 Baseboard	151
5.3.3.1 Test Setup 6 Thermal and Environmental 6.1 Airflow Direction 6.1.1 Hot Aisle Cooling 6.1.2 Cold Aisle Cooling 6.2.1 SFF Card ASIC Cooling — Hot Aisle 6.2.2 LFF Card ASIC Cooling — Hot Aisle 6.2.3 SFF Card ASIC Cooling — Cold Aisle 6.2.4 LFF Card ASIC Cooling — Cold Aisle 6.2.5 Thermal Design Guidelines 6.2.6 LFF Card ASIC Cooling — Cold Aisle 6.2.7 Thermal Test Fixture Cooling — Cold Aisle 6.2.8 Thermal Simulation (CFD) Modeling 6.4 Thermal Test Fixture for SFF Card 6.4.1 Test Fixture for SFF Card 6.4.2 Test Fixture for SFF Card 6.4.3 Test Fixture Airflow Direction 6.4.4 Thermal Test Fixture Candlestick Sensors 6.5 Card Sensor Requirements 6.6 Card Cooling Tiers 6.6.1 Hot Aisle Cooling Tiers 6.6.2 Cold Aisle Cooling Tiers 6.6.3 Cool Aisle Cooling Tiers 6.6.4 Non-Operational Shock & Vibration Testing 6.7.1 Shock & Vibe Test Fixture 6.7.2 Test Procedure 6.8 Dye and Pull Test Method 6.9 Gold Finger Plating Requirements 6.9.1 Hots Side Gold Finger Plating Requirements 6.9.2 Line Side Gold Finger Plating Requirements 6.9.3 Required Compliance 7.1.1 Required Environmental Compliance 7.1.2 Required Environmental Compliance 7.1.3 Required Froduct Safety Compliance 7.1.4 Required Immunity (ESD) Compliance 7.2.7 Recommended Compliance 7.2.7 Recommended Compliance		5.3.3	Test Methodology	151
6.1 Airflow Direction 6.1.1 Hot Aisle Cooling 6.1.2 Cold Aisle Cooling 6.2 Thermal Design Guidelines 6.2.1 SFF Card ASIC Cooling – Hot Aisle 6.2.2 LFF Card ASIC Cooling – Hot Aisle 6.2.3 SFF Card ASIC Cooling – Cold Aisle 6.2.4 LFF Card ASIC Cooling – Cold Aisle 6.3 Thermal Simulation (CFD) Modeling 6.4 Thermal Test Fixture 6.4.1 Test Fixture for SFF Card 6.4.2 Test Fixture for LFF Card 6.4.3 Test Fixture Airflow Direction 6.4.4 Thermal Test Fixture Candlestick Sensors 6.5 Card Sensor Requirements 6.6 Card Cooling Tiers 6.6.1 Hot Aisle Cooling Tiers 6.6.2 Cold Aisle Cooling Tiers 6.6.1 Hot Aisle Cooling Tiers 6.6.1 Non-Operational Shock & Vibration Testing 6.7.1 Shock & Vibe Test Fixture 6.7.2 Test Procedure 6.8 Dye and Pull Test Method. 6.9 Gold Finger Plating Requirements 6.9.1 Host Side Gold Finger Plating Requirements 6.9.1 Line Side Gold Finger Plating Requirements 6.9.2 Line Side Gold Finger Plating Requirements 7.1.1 Required Compliance 7.1.1 Required Environmental Compliance 7.1.1 Required Fiveronmental Compliance 7.1.2 Recommended Compliance 7.1.3 Required Immunity (ESD) Compliance 7.2 Recommended Compliance 7.2.1 Recommended Environmental Compliance				
6.1 Airflow Direction. 6.1.1 Hot Aisle Cooling 6.1.2 Cold Aisle Cooling 6.2.2 Thermal Design Guidelines. 6.2.1 SFF Card ASIC Cooling – Hot Aisle 6.2.2 LFF Card ASIC Cooling – Hot Aisle 6.2.3 SFF Card ASIC Cooling – Cold Aisle 6.2.4 LFF Card ASIC Cooling – Cold Aisle 6.2.5 Thermal Simulation (CFD) Modeling 6.4 Thermal Test Fixture 6.4.1 Test Fixture for SFF Card 6.4.2 Test Fixture for LFF Card 6.4.3 Test Fixture Airflow Direction 6.4.4 Thermal Test Fixture Candlestick Sensors. 6.5 Card Sensor Requirements 6.6 Card Cooling Tiers. 6.6.1 Hot Aisle Cooling Tiers. 6.6.2 Cold Aisle Cooling Tiers. 6.6.3 Cooling Tiers 6.7 Non-Operational Shock & Vibration Testing 6.7.1 Shock & Vibe Test Fixture 6.7.2 Test Procedure 6.8 Dye and Pull Test Method 6.9 Gold Finger Plating Requirements 6.9.1 Hots Side Gold Finger Plating Requirements 6.9.2 Line Side Gold Finger Durability Requirements 6.9.1 Required Compliance 7.1.1 Required Environmental Compliance. 7.1.2 Required Environmental Compliance. 7.1.3 Required Forduct Safety Compliance. 7.1.4 Required Immunity (ESD) Compliance. 7.1.5 Recommended Environmental Compliance. 7.2.1 Recommended Environmental Compliance.	6		·	
6.1.1 Hot Aisle Cooling. 6.1.2 Cold Aisle Cooling. 6.2.1 Thermal Design Guidelines. 6.2.1 SFF Card ASIC Cooling — Hot Aisle. 6.2.2 LFF Card ASIC Cooling — Hot Aisle. 6.2.3 SFF Card ASIC Cooling — Cold Aisle. 6.2.4 LFF Card ASIC Cooling — Cold Aisle. 6.2.4 LFF Card ASIC Cooling — Cold Aisle. 6.2 Thermal Simulation (CFD) Modeling. 6.4 Thermal Test Fixture — 6.4.1 Test Fixture for SFF Card. 6.4.2 Test Fixture for LFF Card. 6.4.3 Test Fixture for LFF Card. 6.4.4 Thermal Test Fixture Candlestick Sensors. 6.5 Card Sensor Requirements 6.6 Card Cooling Tiers. 6.6.1 Hot Aisle Cooling Tiers. 6.6.2 Cold Aisle Cooling Tiers. 6.6.2 Cold Aisle Cooling Tiers. 6.6.3 Non-Operational Shock & Vibration Testing. 6.7.1 Shock & Vibe Test Fixture. 6.7.2 Test Procedure. 6.8 Dye and Pull Test Method. 6.9 Gold Finger Plating Requirements. 6.9.1 Host Side Gold Finger Plating Requirements. 6.9.2 Line Side Gold Finger Plating Requirements. 7.1.1 Required Compliance. 7.1.1 Required Environmental Compliance. 7.1.2 Required EMC Compliance. 7.1.3 Required Froduct Safety Compliance. 7.1.4 Required Immunity (ESD) Compliance. 7.2.7 Recommended Environmental Compliance. 7.2.1 Recommended Environmental Compliance.	•			
6.1.2 Cold Aisle Cooling 6.2 Thermal Design Guidelines 6.2.1 SFF Card ASIC Cooling – Hot Aisle 6.2.2 LFF Card ASIC Cooling – Hot Aisle 6.2.3 SFF Card ASIC Cooling – Cold Aisle 6.2.4 LFF Card ASIC Cooling – Cold Aisle 6.3 Thermal Simulation (CFD) Modeling 6.4 Thermal Test Fixture 6.4.1 Test Fixture for SFF Card 6.4.2 Test Fixture for SFF Card 6.4.3 Test Fixture Airflow Direction 6.4.4 Thermal Test Fixture Candlestick Sensors 6.5 Card Sensor Requirements 6.6 Card Cooling Tiers 6.6.1 Hot Aisle Cooling Tiers 6.6.2 Cold Aisle Cooling Tiers 6.7 Non-Operational Shock & Vibration Testing 6.7.1 Shock & Vibe Test Fixture 6.7.2 Test Procedure 6.8 Dye and Pull Test Method 6.9 Gold Finger Plating Requirements 6.9.1 Host Side Gold Finger Plating Requirements 6.9.1 Host Side Gold Finger Plating Requirements 6.9.1 Required Compliance 7.1.1 Required Environmental Compliance 7.1.2 Required Environmental Compliance 7.1.3 Required Product Safety Compliance 7.1.4 Required Immunity (ESD) Compliance 7.2 Recommended Environmental Compliance 7.2.1 Recommended Environmental Compliance		-		_
6.2 Thermal Design Guidelines 6.2.1 SFF Card ASIC Cooling – Hot Aisle 6.2.2 LFF Card ASIC Cooling – Hot Aisle 6.2.3 SFF Card ASIC Cooling – Cold Aisle 6.2.4 LFF Card ASIC Cooling – Cold Aisle 6.2.5 Thermal Simulation (CFD) Modeling 6.4 Thermal Test Fixture 6.4.1 Test Fixture for SFF Card 6.4.2 Test Fixture for LFF Card 6.4.3 Test Fixture for LFF Card 6.4.4 Thermal Test Fixture Candlestick Sensors 6.5 Card Sensor Requirements 6.6 Card Cooling Tiers 6.6.1 Hot Aisle Cooling Tiers 6.6.2 Cold Aisle Cooling Tiers 6.6.2 Cold Aisle Cooling Tiers 6.7 Non-Operational Shock & Vibration Testing 6.7.1 Shock & Vibe Test Fixture 6.7.2 Test Procedure 6.8 Dye and Pull Test Method 6.9 Gold Finger Plating Requirements 6.9.1 Host Side Gold Finger Plating Requirements 6.9.2 Line Side Gold Finger Durability Requirements 7.1 Required Compliance 7.1.1 Required Environmental Compliance 7.1.2 Required EMC Compliance 7.1.3 Required Immunity (ESD) Compliance 7.1.4 Required Immunity (ESD) Compliance 7.2.7 Recommended Compliance 7.2.1 Recommended Environmental Compliance			6	
6.2.1 SFF Card ASIC Cooling – Hot Aisle 6.2.2 LFF Card ASIC Cooling – Hot Aisle 6.2.3 SFF Card ASIC Cooling – Cold Aisle 6.2.4 LFF Card ASIC Cooling – Cold Aisle 6.3 Thermal Simulation (CFD) Modeling 6.4 Thermal Test Fixture 6.4.1 Test Fixture for SFF Card 6.4.2 Test Fixture for LFF Card 6.4.3 Test Fixture Airflow Direction 6.4.4 Thermal Test Fixture Candlestick Sensors 6.5 Card Sensor Requirements 6.6 Card Cooling Tiers 6.6.1 Hot Aisle Cooling Tiers 6.6.2 Cold Aisle Cooling Tiers 6.7 Non-Operational Shock & Vibration Testing 6.7.1 Shock & Vibe Test Fixture 6.7.2 Test Procedure 6.8 Dye and Pull Test Method 6.9 Gold Finger Plating Requirements 6.9.1 Host Side Gold Finger Plating Requirements 6.9.2 Line Side Gold Finger Plating Requirements 6.9.1 Required Compliance 7.1.1 Required Environmental Compliance 7.1.2 Required EMC Compliance 7.1.3 Required Product Safety Compliance 7.1.4 Required Immunity (ESD) Compliance 7.2 Recommended Environmental Compliance 7.2.1 Recommended Environmental Compliance		_		
6.2.2 LFF Card ASIC Cooling – Hot Aisle 6.2.3 SFF Card ASIC Cooling – Cold Aisle 6.2.4 LFF Card ASIC Cooling – Cold Aisle 6.3 Thermal Simulation (CFD) Modeling 6.4 Thermal Test Fixture 6.4.1 Test Fixture for SFF Card 6.4.2 Test Fixture for LFF Card 6.4.3 Test Fixture Airflow Direction 6.4.4 Thermal Test Fixture Candlestick Sensors 6.5 Card Sensor Requirements 6.6 Card Cooling Tiers 6.6.1 Hot Aisle Cooling Tiers 6.6.2 Cold Aisle Cooling Tiers 6.7 Non-Operational Shock & Vibration Testing 6.7.1 Shock & Vibe Test Fixture 6.7.2 Test Procedure 6.8 Dye and Pull Test Method 6.9 Gold Finger Plating Requirements 6.9.1 Host Side Gold Finger Plating Requirements 6.9.2 Line Side Gold Finger Purability Requirements 6.9.1 Required Compliance 7.1.1 Required Environmental Compliance 7.1.2 Required Emvironmental Compliance 7.1.3 Required Immunity (ESD) Compliance 7.1.4 Required Immunity (ESD) Compliance 7.2. Recommended Environmental Compliance 7.2.1 Recommended Environmental Compliance			-	
6.2.3 SFF Card ASIC Cooling – Cold Aisle 6.2.4 LFF Card ASIC Cooling – Cold Aisle 6.3 Thermal Simulation (CFD) Modeling 6.4 Thermal Test Fixture 6.4.1 Test Fixture for SFF Card 6.4.2 Test Fixture for LFF Card 6.4.3 Test Fixture Airflow Direction 6.4.4 Thermal Test Fixture Candlestick Sensors 6.5 Card Sensor Requirements 6.6 Card Cooling Tiers 6.6.1 Hot Aisle Cooling Tiers 6.6.2 Cold Aisle Cooling Tiers 6.6.3 Non-Operational Shock & Vibration Testing 6.7 Non-Operational Shock & Vibration Testing 6.7.1 Shock & Vibe Test Fixture 6.7.2 Test Procedure 6.8 Dye and Pull Test Method 6.9 Gold Finger Plating Requirements 6.9.1 Host Side Gold Finger Plating Requirements 6.9.2 Line Side Gold Finger Durability Requirements 6.9.1 Required Compliance 7.1.1 Required Environmental Compliance 7.1.2 Required EMC Compliance 7.1.3 Required Product Safety Compliance 7.1.4 Required Immunity (ESD) Compliance 7.2.7 Recommended Compliance 7.2.1 Recommended Environmental Compliance 7.2.1 Recommended Environmental Compliance 7.2.1 Recommended Environmental Compliance			•	
6.2.4 LFF Card ASIC Cooling — Cold Aisle 6.3 Thermal Simulation (CFD) Modeling 6.4 Thermal Test Fixture 6.4.1 Test Fixture for SFF Card 6.4.2 Test Fixture for LFF Card 6.4.3 Test Fixture Airflow Direction 6.4.4 Thermal Test Fixture Candlestick Sensors. 6.5 Card Sensor Requirements 6.6 Card Cooling Tiers 6.6.1 Hot Aisle Cooling Tiers 6.6.2 Cold Aisle Cooling Tiers 6.7 Non-Operational Shock & Vibration Testing 6.7.1 Shock & Vibe Test Fixture 6.7.2 Test Procedure 6.8 Dye and Pull Test Method 6.9 Gold Finger Plating Requirements 6.9.1 Host Side Gold Finger Plating Requirements 6.9.2 Line Side Gold Finger Durability Requirements 6.9.1 Required Compliance 7.1.1 Required Environmental Compliance 7.1.2 Required EMC Compliance 7.1.3 Required Immunity (ESD) Compliance 7.1.4 Required Immunity (ESD) Compliance 7.2.2 Recommended Compliance 7.2.1 Recommended Environmental Compliance 7.2.1 Recommended Environmental Compliance 7.2.2 Recommended Compliance 7.2.1 Recommended Environmental Compliance 7.2.1 Recommended Environmental Compliance 7.2.1 Recommended Environmental Compliance 7.2.1 Recommended Environmental Compliance		-	· · · · · · · · · · · · · · · · · · ·	
6.3 Thermal Simulation (CFD) Modeling 6.4 Thermal Test Fixture 6.4.1 Test Fixture for SFF Card 6.4.2 Test Fixture for LFF Card 6.4.3 Test Fixture Airflow Direction 6.4.4 Thermal Test Fixture Candlestick Sensors 6.5 Card Sensor Requirements 6.6 Card Cooling Tiers 6.6.1 Hot Aisle Cooling Tiers 6.6.2 Cold Aisle Cooling Tiers 6.6.7 Non-Operational Shock & Vibration Testing 6.7.1 Shock & Vibe Test Fixture 6.7.2 Test Procedure 6.8 Dye and Pull Test Method 6.9 Gold Finger Plating Requirements 6.9.1 Host Side Gold Finger Plating Requirements 6.9.2 Line Side Gold Finger Durability Requirements 6.9.2 Line Side Gold Finger Durability Requirements 7.1.1 Required Compliance 7.1.2 Required Environmental Compliance 7.1.3 Required EMC Compliance 7.1.4 Required Immunity (ESD) Compliance 7.2. Recommended Compliance 7.2.1 Recommended Environmental Compliance			•	
6.4 Thermal Test Fixture 6.4.1 Test Fixture for SFF Card 6.4.2 Test Fixture for LFF Card 6.4.3 Test Fixture Airflow Direction 6.4.4 Thermal Test Fixture Candlestick Sensors. 6.5 Card Sensor Requirements 6.6 Card Cooling Tiers 6.6.1 Hot Aisle Cooling Tiers 6.6.2 Cold Aisle Cooling Tiers 6.6.7 Non-Operational Shock & Vibration Testing 6.7.1 Shock & Vibe Test Fixture 6.7.2 Test Procedure 6.8 Dye and Pull Test Method 6.9 Gold Finger Plating Requirements 6.9.1 Host Side Gold Finger Plating Requirements 6.9.2 Line Side Gold Finger Durability Requirements 7.1.1 Required Compliance 7.1.1 Required Environmental Compliance 7.1.2 Required Immunity (ESD) Compliance 7.1.4 Required Immunity (ESD) Compliance 7.2 Recommended Compliance 7.2.1 Recommended Environmental Compliance		-		
6.4.1 Test Fixture for SFF Card 6.4.2 Test Fixture for LFF Card 6.4.3 Test Fixture Airflow Direction 6.4.4 Thermal Test Fixture Candlestick Sensors 6.5 Card Sensor Requirements 6.6 Card Cooling Tiers 6.6.1 Hot Aisle Cooling Tiers 6.6.2 Cold Aisle Cooling Tiers 6.7 Non-Operational Shock & Vibration Testing 6.7.1 Shock & Vibe Test Fixture 6.7.2 Test Procedure 6.8 Dye and Pull Test Method 6.9 Gold Finger Plating Requirements 6.9.1 Host Side Gold Finger Plating Requirements 6.9.2 Line Side Gold Finger Durability Requirements 7.1.1 Required Compliance 7.1.1 Required Environmental Compliance 7.1.2 Required EMC Compliance 7.1.3 Required Immunity (ESD) Compliance 7.1.4 Required Immunity (ESD) Compliance 7.2 Recommended Compliance 7.2.1 Recommended Environmental Compliance				
6.4.2 Test Fixture for LFF Card 6.4.3 Test Fixture Airflow Direction 6.4.4 Thermal Test Fixture Candlestick Sensors. 6.5 Card Sensor Requirements 6.6 Card Cooling Tiers 6.6.1 Hot Aisle Cooling Tiers 6.6.2 Cold Aisle Cooling Tiers 6.7 Non-Operational Shock & Vibration Testing 6.7.1 Shock & Vibe Test Fixture 6.7.2 Test Procedure 6.8 Dye and Pull Test Method 6.9 Gold Finger Plating Requirements 6.9.1 Host Side Gold Finger Plating Requirements 6.9.2 Line Side Gold Finger Durability Requirements 6.9.1 Required Compliance 7.1.1 Required Emvironmental Compliance 7.1.2 Required EMC Compliance 7.1.3 Required Immunity (ESD) Compliance 7.1.4 Required Immunity (ESD) Compliance 7.2 Recommended Compliance 7.2.1 Recommended Environmental Compliance				
6.4.3 Test Fixture Airflow Direction 6.4.4 Thermal Test Fixture Candlestick Sensors 6.5 Card Sensor Requirements 6.6 Card Cooling Tiers 6.6.1 Hot Aisle Cooling Tiers 6.6.2 Cold Aisle Cooling Tiers 6.7 Non-Operational Shock & Vibration Testing 6.7.1 Shock & Vibe Test Fixture 6.7.2 Test Procedure 6.8 Dye and Pull Test Method 6.9 Gold Finger Plating Requirements 6.9.1 Host Side Gold Finger Plating Requirements 6.9.2 Line Side Gold Finger Durability Requirements 7.1 Required Compliance 7.1.1 Required Environmental Compliance 7.1.2 Required EMC Compliance 7.1.3 Required Product Safety Compliance 7.1.4 Required Immunity (ESD) Compliance 7.2.1 Recommended Compliance 7.2.1 Recommended Compliance		_		
6.4.4 Thermal Test Fixture Candlestick Sensors 6.5 Card Sensor Requirements 6.6 Card Cooling Tiers 6.6.1 Hot Aisle Cooling Tiers 6.6.2 Cold Aisle Cooling Tiers 6.7 Non-Operational Shock & Vibration Testing 6.7.1 Shock & Vibe Test Fixture 6.7.2 Test Procedure 6.8 Dye and Pull Test Method 6.9 Gold Finger Plating Requirements 6.9.1 Host Side Gold Finger Plating Requirements 6.9.2 Line Side Gold Finger Durability Requirements 7.1 Required Compliance 7.1.1 Required Environmental Compliance 7.1.2 Required EMC Compliance 7.1.3 Required Immunity (ESD) Compliance 7.1.4 Required Immunity (ESD) Compliance 7.2 Recommended Compliance 7.2.1 Recommended Environmental Compliance		-		
6.5 Card Sensor Requirements 6.6 Card Cooling Tiers 6.6.1 Hot Aisle Cooling Tiers 6.6.2 Cold Aisle Cooling Tiers 6.7 Non-Operational Shock & Vibration Testing 6.7.1 Shock & Vibe Test Fixture 6.7.2 Test Procedure 6.8 Dye and Pull Test Method 6.9 Gold Finger Plating Requirements 6.9.1 Host Side Gold Finger Plating Requirements 6.9.2 Line Side Gold Finger Durability Requirements 6.9.3 Regulatory 7.1 Required Compliance 7.1.1 Required Environmental Compliance 7.1.2 Required EMC Compliance 7.1.3 Required Product Safety Compliance 7.1.4 Required Immunity (ESD) Compliance 7.2 Recommended Compliance 7.2.1 Recommended Environmental Compliance				
6.6 Card Cooling Tiers 6.6.1 Hot Aisle Cooling Tiers 6.6.2 Cold Aisle Cooling Tiers 6.7 Non-Operational Shock & Vibration Testing 6.7.1 Shock & Vibe Test Fixture 6.7.2 Test Procedure 6.8 Dye and Pull Test Method 6.9 Gold Finger Plating Requirements 6.9.1 Host Side Gold Finger Plating Requirements 6.9.2 Line Side Gold Finger Durability Requirements 7.1 Required Compliance 7.1.1 Required Environmental Compliance 7.1.2 Required EMC Compliance 7.1.3 Required Product Safety Compliance 7.1.4 Required Immunity (ESD) Compliance 7.2 Recommended Compliance 7.2.1 Recommended Environmental Compliance		-		
6.6.1 Hot Aisle Cooling Tiers 6.6.2 Cold Aisle Cooling Tiers 6.7 Non-Operational Shock & Vibration Testing. 6.7.1 Shock & Vibe Test Fixture. 6.7.2 Test Procedure. 6.8 Dye and Pull Test Method. 6.9 Gold Finger Plating Requirements 6.9.1 Host Side Gold Finger Plating Requirements 6.9.2 Line Side Gold Finger Durability Requirements 7.1 Required Compliance. 7.1.1 Required Environmental Compliance 7.1.2 Required EMC Compliance 7.1.3 Required Product Safety Compliance 7.1.4 Required Immunity (ESD) Compliance 7.2 Recommended Compliance. 7.2.1 Recommended Environmental Compliance.			·	
6.6.2 Cold Aisle Cooling Tiers 6.7 Non-Operational Shock & Vibration Testing		6.6 Card	•	
6.7 Non-Operational Shock & Vibration Testing 6.7.1 Shock & Vibe Test Fixture 6.7.2 Test Procedure 6.8 Dye and Pull Test Method 6.9 Gold Finger Plating Requirements 6.9.1 Host Side Gold Finger Plating Requirements 6.9.2 Line Side Gold Finger Durability Requirements 7.1 Regulatory 7.1 Required Compliance 7.1.1 Required Environmental Compliance 7.1.2 Required EMC Compliance 7.1.3 Required Product Safety Compliance 7.1.4 Required Immunity (ESD) Compliance 7.2 Recommended Compliance 7.2.1 Recommended Environmental Compliance				
6.7.1 Shock & Vibe Test Fixture 6.7.2 Test Procedure 6.8 Dye and Pull Test Method 6.9 Gold Finger Plating Requirements 6.9.1 Host Side Gold Finger Plating Requirements 6.9.2 Line Side Gold Finger Durability Requirements 7.1 Required Compliance 7.1.1 Required Environmental Compliance 7.1.2 Required EMC Compliance 7.1.3 Required Product Safety Compliance 7.1.4 Required Immunity (ESD) Compliance 7.2 Recommended Compliance 7.2.1 Recommended Environmental Compliance				
6.7.2 Test Procedure 6.8 Dye and Pull Test Method. 6.9 Gold Finger Plating Requirements 6.9.1 Host Side Gold Finger Plating Requirements 6.9.2 Line Side Gold Finger Durability Requirements 7.1.1 Required Compliance 7.1.1 Required Environmental Compliance 7.1.2 Required EMC Compliance 7.1.3 Required Product Safety Compliance 7.1.4 Required Immunity (ESD) Compliance 7.2 Recommended Compliance 7.2.1 Recommended Environmental Compliance		6.7 Non-0	· ·	
6.8 Dye and Pull Test Method. 6.9 Gold Finger Plating Requirements 6.9.1 Host Side Gold Finger Plating Requirements 6.9.2 Line Side Gold Finger Durability Requirements 7.1 Required Compliance 7.1.1 Required Environmental Compliance 7.1.2 Required EMC Compliance 7.1.3 Required Product Safety Compliance 7.1.4 Required Immunity (ESD) Compliance 7.1.5 Recommended Compliance 7.1.6 Recommended Environmental Compliance			Shock & Vibe Test Fixture	
6.9 Gold Finger Plating Requirements 6.9.1 Host Side Gold Finger Plating Requirements 6.9.2 Line Side Gold Finger Durability Requirements 7.1.1 Required Compliance		-	Test Procedure	
6.9.1 Host Side Gold Finger Plating Requirements 6.9.2 Line Side Gold Finger Durability Requirements 7 Regulatory		6.8 Dye a	nd Pull Test Method	173
6.9.2 Line Side Gold Finger Durability Requirements Regulatory		6.9 Gold	Finger Plating Requirements	175
7.1 Required Compliance		6.9.1	Host Side Gold Finger Plating Requirements	175
7.1 Required Compliance		6.9.2	Line Side Gold Finger Durability Requirements	175
7.1.1 Required Environmental Compliance 7.1.2 Required EMC Compliance 7.1.3 Required Product Safety Compliance 7.1.4 Required Immunity (ESD) Compliance 7.2 Recommended Compliance 7.2.1 Recommended Environmental Compliance	7	Regulatory		176
7.1.2 Required EMC Compliance 7.1.3 Required Product Safety Compliance 7.1.4 Required Immunity (ESD) Compliance 7.2 Recommended Compliance 7.2.1 Recommended Environmental Compliance		7.1 Requ	ired Compliance	176
7.1.2 Required EMC Compliance 7.1.3 Required Product Safety Compliance 7.1.4 Required Immunity (ESD) Compliance 7.2 Recommended Compliance 7.2.1 Recommended Environmental Compliance		•	Required Environmental Compliance	
7.1.3 Required Product Safety Compliance		7.1.2	Required EMC Compliance	
7.1.4 Required Immunity (ESD) Compliance			Required Product Safety Compliance	
7.2 Recommended Compliance		_	· · · · · · · · · · · · · · · · · · ·	
7.2.1 Recommended Environmental Compliance				
·				
		7.2.1	Recommended FMC Compliance	177 178

8	Revision History	[,]

List of Figures

Figure 1: Representative SFF OCP NIC 3.0 Card with Dual QSFP Ports	16
Figure 2: Representative LFF OCP NIC 3.0 Card with Dual QSFP Ports and on-board DRAM	
Figure 3: SFF and LFF Block Diagrams (not to scale)	18
Figure 4: Primary Connector (4C+) and Secondary Connector (4C) (LFF) OCP NIC 3.0 Cards	22
Figure 5: Primary Connector (4C+) Only (LFF) OCP NIC 3.0 Cards	23
Figure 6: Primary Connector (4C+) with 4C and 2C (SFF) OCP NIC 3.0 Cards	23
Figure 7: SFF NIC Configuration Views	2!
Figure 8: SFF NIC Line Side 3D Views	20
Figure 9: SFF NIC Chassis Mounted 3D Views	2
Figure 10: LFF NIC Configuration Views	29
Figure 11: LFF NIC Line Side 3D Views	30
Figure 12: LFF NIC Chassis Mounted 3D Views	3:
Figure 13: PBA Exploded Views (SFF and LFF)	33
Figure 14: Faceplate Assembly Exploded Views (SFF and LFF)	34
Figure 15: SFF Generic I/O Faceplate with Pulltab Version (2D View)	36
Figure 16: SFF Generic I/O Faceplate – Ejector Version (2D View)	36
Figure 17: SFF Generic I/O Faceplate – Internal Lock Version (2D View)	3
Figure 18: LFF Generic I/O Faceplate – Ejector Version (2D View)	3
Figure 19: SFF I/O Faceplate – Ejector Lever (2D View)	38
Figure 20: LFF I/O Faceplate – Ejector Lever (2D View)	38
Figure 21: Ejector Lock	39
Figure 22: Ejector Bushing	39
Figure 23: Wave Washer	40
Figure 24: SFF Keep Out Zone – Top View	4:
Figure 25: SFF Keep Out Zone – Top View – Detail A	4:
Figure 26: SFF Keep Out Zone – Bottom View	42
Figure 27: SFF Keep Out Zone – Side View	42
Figure 28: SFF Keep Out Zone – Side View – Detail D	43
Figure 29: LFF Keep Out Zone – Top View	44
Figure 30: LFF Keep Out Zone – Top View – Detail A	4
Figure 31: LFF Keep Out Zone – Bottom View	4
Figure 32: LFF Keep Out Zone – Side View	40
Figure 33: LFF Keep Out Zone – Side View – Detail D	46
Figure 34: SFF Bottom Side Insulator (3D View)	4
Figure 35: SFF Bottom Side Insulator (Top and Side View)	4
Figure 36: SFF Bottom Side Insulator (alternate) (Top and Side View)	48
Figure 37: LFF Bottom Side Insulator (3D View)	48
Figure 38: LFF Bottom Side Insulator (Top and Side View)	49
Figure 39: LFF Bottom Side Insulator (alternate) (Top and Side View)	50
Figure 40: SFF OCP NIC 3.0 Card with Pull Tab CTF Dimensions (Top View)	5:
Figure 41: SFF OCP NIC 3.0 Card with Pull Tab CTF Dimensions (Front View)	52
Figure 42: SFF OCP NIC 3.0 Card with Pull Tab CTF Dimensions (Side View)	52
Figure 43: SFF OCP NIC 3.0 Card with Ejector CTF Dimensions (Top View)	53
Figure 44: SFF OCP NIC 3.0 Card with Ejector CTF Dimensions (Front View)	
Figure 45: SFF OCP NIC 3.0 Card with Ejector CTF Dimensions (Side View)	53
Figure 46: SFF Baseboard Chassis CTF Dimensions (Rear View)	54
Figure 47: SFF Baseboard Chassis to Card Thumb Screw CTF Dimensions (Side View)	54
Figure 48: SFF Baseboard Chassis to Ejector lever Card CTF Dimensions (Side View)	5!
Figure 49: SFF Baseboard Chassis CTF Dimensions (Rear Rail Guide View)	5!
Figure 50: SFF Baseboard Chassis CTF Dimensions (Rail Guide Detail) – Detail C	5
Figure 51: LFF OCP NIC 3.0 Card with Ejector CTF Dimensions (Top View)	56
Figure 52: LFF OCP NIC 3.0 Card with Ejector CTF Dimensions (Front View)	5f

Figure 53: LFF OCP NIC 3.0 Card with Ejector CTF Dimensions (Side View)	
Figure 54: LFF Baseboard Chassis CTF Dimensions (Rear View)	
Figure 55: LFF Baseboard Chassis CTF Dimensions (Side View)	
Figure 56: LFF Baseboard Chassis CTF Dimensions (Rail Guide View)	
Figure 57: LFF Baseboard Chassis CTF Dimensions (Rail Guide – Detail C)	58
Figure 58: SFF Label Area Example	
Figure 59: MAC Address Label Example 1 – Quad Port with Single Host, Single Managed Controller	
Figure 60: MAC Address Label Example 2 – Octal Port with Single Host, Dual Managed Controller	
Figure 61: MAC Address Label Example 3 – Quad Port with Dual Hosts, Dual Managed Controllers	
Figure 62: MAC Address Label Example 4 – Single Port with Quad Host, Single Managed Controller	
Figure 63: SFF Primary Connector Gold Finger Dimensions – x16 – Top Side ("B" Pins)	
Figure 64: LFF Gold Finger Dimensions – x32 – Top Side ("B" Pins)	
Figure 65: LFF Gold Finger Dimensions – x32 – Bottom Side ("A" Pins)	
Figure 66: 168-pin Base Board Primary Connector – Right Angle	
Figure 67: 140-pin Base Board Secondary Connector – Right Angle	
Figure 68: OCP NIC 3.0 Card and Host Offset for Right Angle Connectors	
Figure 69: 168-pin Base Board Primary Connector – Straddle Mount	
Figure 70: 140-pin Base Board Secondary Connector – Straddle Mount	
Figure 71: OCP NIC 3.0 Card and Baseboard PCB Thickness Options for Straddle Mount Connectors	
Figure 72: 0 mm Offset (Coplanar) for 0.062" Thick Baseboards	
Figure 73: 0.3 mm Offset for 0.076" Thick Baseboards	
Figure 74: Primary and Secondary Connector Locations for LFF Support with Right Angle Connectors Figure 75: Primary and Secondary Connector Locations for LFF Support with Straddle Mount Connectors	
Figure 76: PCIe Present and Bifurcation Control Pins (Baseboard Controlled BIF[0:2]#)	
Figure 77: PCIe Present and Bifurcation Control Pins (Baseboard Controlled Bir[0.2]#)	
Figure 78: Example SMBus Connections	
Figure 79: NC-SI over RBT Connection Example – Single Primary Connector	
Figure 80: NC-SI over RBT Connection Example – Dual Primary Connectors	
Figure 81: Example Scan Chain Timing Diagram	94
Figure 82: Scan Chain Connection Example	
Figure 83: Example Power Supply Topology	
Figure 84: USB 2.0 Connection Example – Basic Connectivity	
Figure 85: USB 2.0 Connection Example – USB-Serial / USB-JTAG Connectivity	
Figure 86: UART Connection Example	
Figure 87: Single Host (1 x16) and 1 x16 OCP NIC 3.0 Card (Single Controller)	
Figure 88: Single Host (2 x8) and 2 x8 OCP NIC 3.0 Card (Dual Controllers)	
Figure 89: Quad Hosts (4 x4) and 4 x4 OCP NIC 3.0 Card (Single Controller)	
Figure 90: Quad Hosts (4 x4) and 4 x4 OCP NIC 3.0 Card (Quad Controllers)	
Figure 91: Single Host with no Bifurcation (1 x16) and 2 x8 OCP NIC 3.0 Card (Dual Controllers)	
Figure 92: SFF PCIe REFCLK Mapping – Single Host – 1, 2 and 4 links	
Figure 93: SFF PCIe REFCLK Mapping – Dual Host – 2 and 4 links	
Figure 94: SFF PCIe REFCLK Mapping – Quad Host – 4 Links	
Figure 95: LFF PCIe REFCLK Mapping – Single Host – 1, 2 and 4 links	
Figure 96: LFF PCIe REFCLK Mapping – Dual Host – 2 and 4 links	
Figure 97: LFF PCIe REFCLK Mapping – Quad Host – 4 Links	
Figure 98: Port and LED Ordering – Example SFF Link/Activity and Speed LED Placement	
Figure 99: Baseboard Power States	
Figure 100: Power-Up Sequencing	
Figure 101: Power-Down Sequencing	
Figure 102: PCIe Load Board Test Fixture for OCP NIC 3.0 SFF	
Figure 103: PCIe Base Board Test Fixture for OCP NIC 3.0 SFF	
Figure 104: Airflow Direction for Hot Aisle Cooling (SFF and LFF)	
Figure 105: Airflow Direction for Cold Aisle Cooling (SFF and LFF)	
Figure 106: ASIC Supportable Power for Hot Aisle Cooling – SFF	
Figure 107: OCP NIC 3.0 SFF Reference Design and CFD Geometry	
Figure 108: Server System Airflow Capability – SFF Card Hot Aisle Cooling	
Figure 109: ASIC Supportable Power for Hot Aisle Cooling – LFF Card	
Figure 110: OCP NIC 3.0 LFF Reference Design and CFD Geometry	

Open Compute Project • OCP NIC 3.0

Rev 0.84

Figure 111: Server System Airflow Capability – LFF Card Hot Aisle Cooling	159
Figure 112: ASIC Supportable Power for Cold Aisle Cooling – SFF Card	160
Figure 113: Server System Airflow Capability – SFF Cold Aisle Cooling	160
Figure 114: ASIC Supportable Power Comparison – SFF Card	161
Figure 115: ASIC Supportable Power for Cold Aisle Cooling – LFF Card	162
Figure 116: Server System Airflow Capability – LFF Cold Aisle Cooling	163
Figure 117: ASIC Supportable Power Comparison – LFF Card	163
Figure 118: SFF Thermal Test Fixture Preliminary Design	
Figure 119: SFF Thermal Test Fixture Preliminary Design – Cover Removed	166
Figure 120: SFF Card Thermal Test Fixture PCB	166
Figure 121: LFF Card Thermal Test Fixture Design	167
Figure 122: LFF Card Thermal Test Fixture Design – Cover Removed	167
Figure 123: LFF Card Thermal Test Fixture PCB	
Figure 124: Thermal Test Fixture Airflow Direction	169
Figure 125: SFF Fixture, Hot Aisle Flow - Candlestick Air Velocity vs. Volume FlowFlow	170
Figure 126: LFF Fixture, Hot Aisle Flow - Candlestick Air Velocity vs. Volume Flow	
Figure 127: Dye and Pull Type Locations	
Figure 128: Dye Coverage Percentage	

List of Tables

Table 1: Acknowledgements – By Company	11
Table 2: Acronyms	
Table 3: OCP 3.0 Form Factor Dimensions	
Table 4: Baseboard to OCP NIC Form Factor Compatibility Chart	19
Table 5: Example Non-NIC Use Cases	21
Table 6: OCP NIC 3.0 Card Definitions	
Table 7: OCP NIC 3.0 Line Side I/O Implementations	32
Table 8: Bill of Materials for the SFF and LFF Faceplate Assemblies	35
Table 9: CTF Default Tolerances (SFF and LFF OCP NIC 3.0)	51
Table 10: MAC Address Label Example 1 – Quad Port with Single Host, Single Managed Controller	61
Table 11: MAC Address Label Example 2 – Octal Port with Single Host, Dual Managed Controller	61
Table 12: MAC Address Label Example 3 – Quad Port with Dual Hosts, Dual Managed Controller	62
Table 13: MAC Address Label Example 4 – Single Port with Quad Host, Single Managed Controller	63
Table 14: NIC Implementation Examples and 3D CAD	
Table 15: Contact Mating Positions for the Primary Connector	66
Table 16: Contact Mating Positions for the Secondary Connector	68
Table 17: Right Angle Connector Options	70
Table 18: Straddle Mount Connector Options	71
Table 19: Primary Connector Pin Definition (x16) (4C+)	75
Table 20: Secondary Connector Pin Definition (x16) (4C)	
Table 21: Pin Descriptions – PCle	78
Table 22: Pin Descriptions – PCle Present and Bifurcation Control Pins	84
Table 23: Pin Descriptions – SMBus	87
Table 24: Pin Descriptions – NC-SI over RBT	88
Table 25: Pin Descriptions – Scan Chain	95
Table 26: Pin Descriptions – Scan Chain DATA_OUT Bit Definition	97
Table 27: Pin Descriptions – Scan Chain DATA_IN Bit Definition	
Table 28: Pin Descriptions – Power	
Table 29: Pin Descriptions – USB 2.0 – Primary Connector only	105
Table 30: Pin Descriptions – UART – Secondary Connector Only	
Table 31: Pin Descriptions – RFU[1:4]	
Table 32: PCIe Bifurcation Decoder for x32, x16, x8, x4, x2 and x1 Card Widths	112
Table 33: PCIe REFCLK and PERST Associations	
Table 34: SFF PCIe Link / REFCLKn / PERSTn mapping for 1, 2 and 4 Links	119
Table 35: LFF PCIe Link / REFCLKn / PERSTn mapping for 1, 2, 4 and 8 Links	
Table 36: OCP NIC 3.0 Card LED Configuration with Two Physical LEDs per Port	127
Table 37: Power States	130
Table 38: Baseboard Power Supply Rail Requirements – Slot Power Envelopes	
Table 39: Power Sequencing Parameters	134
Table 40: Digital I/O DC specifications	135
Table 41: Digital I/O AC specifications	135
Table 42: OCP NIC 3.0 Management Implementation Definitions	136
Table 43: Sideband Management Interface and Transport Requirements	136
Table 44: NC-SI Traffic Requirements	137
Table 45: MC MAC Address Provisioning Requirements	137
Table 46: Temperature Reporting Requirements	139
Table 47: Power Consumption Reporting Requirements	140
Table 48: Pluggable Module Status Reporting Requirements	141
Table 49: Management and Pre-OS Firmware Inventory and Update Requirements	141
Table 50: Slot_ID[1:0] to Package ID[2:0] Mapping	143
Table 51: FRU EEPROM Address Map	
Table 52: FRU EEPROM Record – OEM Record 0xC0, Offset 0x00	145
Table 53: PCIe Electrical Budgets	149
Table 54: PCIe Test Fixtures for OCP NIC 3.0	
Table 55: Hot Aisle Air Temperature Boundary Conditions	153
Table 56: Hot Aisle Airflow Boundary Conditions	
Table 57: Cold Aisle Air Temperature Boundary Conditions	

Open Compute Project • OCP NIC 3.0

Rev 0.84

Table 58: Cold Aisle Airflow Boundary Conditions	154
Table 59: Reference OCP NIC 3.0 SFF Card Geometry	155
Table 60: Reference OCP NIC 3.0 LFF Card Geometry	158
Table 61: Hot Aisle Card Cooling Tier Definitions (LFM)	
Table 62: Cold Aisle Card Cooling Tier Definitions (LFM)	
Table 63: Random Virbation Testing 1.88 G _{RMS} Profile	
Table 64: FCC Class A Radiated and Conducted Emissions Requirements Based on Geographical Location	176
Table 65: Safety Requirements	177
Table 66: Immunity (ESD) Requirements	

1 Overview

1.1 License

As of January 23rd, 2018, the following persons or entities have made this Specification available under the Open Compute Project Hardware License (Permissive) Version 1.0 (OCPHL-P)

OCP NIC Subgroup

An electronic copy of the OCPHL-P is available at:

http://www.opencompute.org/assets/download/01-Contribution-Licenses/OCPHL-Permissive-v1.0.pdf

Your use of this Specification may be subject to other third party rights. THIS SPECIFICATION IS PROVIDED "AS IS." The contributors expressly disclaim any warranties (express, implied, or otherwise), including implied warranties of merchantability, non-infringement, fitness for a particular purpose, or title, related to the Specification. The Specification implementer and user assume the entire risk as to implementing or otherwise using the Specification. IN NO EVENT WILL ANY PARTY BE LIABLE TO ANY OTHER PARTY FOR LOST PROFITS OR ANY FORM OF INDIRECT, SPECIAL, INCIDENTAL, OR CONSEQUENTIAL DAMAGES OF ANY CHARACTER FROM ANY CAUSES OF ACTION OF ANY KIND WITH RESPECT TO THIS SPECIFICATION OR ITS GOVERNING AGREEMENT, WHETHER BASED ON BREACH OF CONTRACT, TORT (INCLUDING NEGLIGENCE), OR OTHERWISE, AND WHETHER OR NOT THE OTHER PARTY HAS BEEN ADVISED OF THE POSSIBILITY OF SUCH DAMAGE.

1.2 Acknowledgements

The OCP NIC 3.0 specification was created under a collaboration from many OCP member companies, and facilitated by the OCP NIC Subgroup under the OCP Server Workgroup.

The OCP NIC Subgroup would like to acknowledge the following member companies for their contributions to the OCP NIC 3.0 specification:

Table 1: Acknowledgements – By Company

Amphenol Corporation Keysight Technologies Broadcom Limited Lenovo Group Ltd

Cavium, Inc. Mellanox Technologies, Ltd Dell, Inc. Netronome Systems, Inc. Facebook, Inc. Quanta Computer Inc. **Hewlett Packard Enterprise Company TE Connectivity Corporation**

Intel Corporation University of New Hampshire InterOperability Lab

1.3 References

- DMTF Standard. *DSP0222, Network Controller Sideband Interface (NC-SI) Specification.* Distributed Management Task Force (DMTF), Rev 1.1.0, September 23rd, 2015.
- DMTF Standard. *DSP0222, Network Controller Sideband Interface (NC-SI) Specification.* Distributed Management Task Force (DMTF), Rev 1.2.0, Work-In-Progress.
- DMTF Standard. DSP0236, Management Component Transport Protocol (MCTP) Base Specification. Distributed Management Task Force (DMTF), Rev 1.3.0, November 24th, 2016.
- DMTF Standard. DSP0237, Management Component Transport Protocol (MCTP) SMBus/I2C
 Transport Binding Specification. Distributed Management Task Force (DMTF), Rev 1.1.0, May 21st, 2017.
- DMTF Standard. DSP0238, Management Component Transport Protocol (MCTP) PCIe VDM
 Transport Binding Specification. Distributed Management Task Force (DMTF), Rev 1.0.2, December 7th, 2014.
- DMTF Standard. DSP0239, MCTP IDs and Codes Specification. Distributed Management Task Force (DMTF), Rev 1.5.0, December 17th, 2017.
- DMTF Standard. DSP0240, Platform Level Data Model (PLDM) Base Specification. Distributed Management Task Force (DMTF), Rev 1.0.0, April 23rd, 2009.
- DMTF Standard. DSP0240, Platform Level Data Model (PLDM) over MCTP Binding Specification. Distributed Management Task Force (DMTF), Rev 1.0.0, April 23rd, 2009.
- DMTF Standard. DSP0245, Platform Level Data Model (PLDM) IDs and Codes Specification.
 Distributed Management Task Force (DMTF), Rev 1.2.0, November 24th, 2016.
- DMTF Standard. DSP0248, Platform Level Data Model (PLDM) for Platform Monitoring and Control Specification. Distributed Management Task Force (DMTF), Rev 1.1.1, January 10th, 2017.
- DMTF Standard. DSP0249, Platform Level Data Model (PLDM) State Sets Specification. Distributed Management Task Force (DMTF), Rev 1.0.0, March 16th, 2009.
- DMTF Standard. DSP0261, NC-SI over MCTP Binding Specification. Distributed Management Task Force (DMTF), Rev 1.2.0, August 26th, 2017.
- EDSFF. Enterprise and Datacenter SSD Form Factor Connector Specification. Enterprise and Datacenter SSD Form Factor Working Group, Rev 0.9 (draft), August 2nd 2017.
- IPC. IPC-TM-650 Test Methods Manual number 2.4.53. Dye and Pull Test Method (Formerly Known as Dye and Pry), Association Connecting Electronics Industries, August 2017.
- IPMI Platform Management FRU Information Storage Definition, v1.0 Document Revision 1.3, March 24th, 2015.
- National Institute of Standards and Technology (NIST). Special Publication 800-193, Platform Firmware Resiliency Guidelines, draft, May 2017.
- NXP Semiconductors. I²C-bus specification and user manual. NXP Semiconductors, Rev 6, April 4th, 2014.
- Open Compute Project. OCP NIC Subgroup. Online. http://www.opencompute.org/wiki/Server/Mezz
- PCI-SIG[®]. *PCI Express* Base Specification, Revision 3.0 December 7th, 2015.
- PCI-SIG®. PCI Express® Base Specification, Revision 4.0 Version 1.0, October 5th, 2017.
- PCI-SIG®. PCI Express® Card Electromechanical Specification, Revision 3.0, July 21st, 2013.

- PCI-SIG®. PCI Express® Card Electromechanical Specification, Revision 4.0 (draft).
- SMBus Management Interface Forum. *System Management Bus (SMBus) Specification*. System Management Interface Forum, Inc, Version 2.0, August 3rd, 2000.
- SNIA. SFF-TA-1002, Specification for Protocol Agnostic Multi-Lane High Speed Connector. SNIA SFF TWG Technology Affiliate, Rev 1.1 draft, January 18th, 2018.
- UEFI Specification Version 2.5, http://www.uefi.org/sites/default/files/resources/UEFI%202 5.pdf,
 April 2015.
- USB Implementers Forum. *Universal Serial Bus Specification*, Revision 2.0, April 27th, 2000.

1.3.1 Trademarks

Names and brands may be claimed as trademarks by their respective companies.

PCIe® and PCI Express® are the registered trademarks of PCI-SIG.

1.4 Acronyms

For the purposes of the OCP NIC 3.0 specification, the following acronyms apply:

Table 2: Acronyms

Acronym Definition				
AIC	Add-in Card			
ASIC	Application Specific Integrated Circuit			
BGA	Ball Grid Array			
ВМС	Baseboard Management Controller			
ВОМ	Bill of Materials			
CAD	Computer Aided Design			
CBB	Compliance Base Board			
CEM	Card Electromechanical			
CFD	Computational Fluid Dynamics			
CFM	Cubic Feet per Minute			
CLB	Compliance Load Board			
CTD	Chain of Trust for Detection			
CTF	Critical to Function			
CTU	Chain of Trust for Update			
DMTF	Distributed Management Task Force			
DRAM	Dynamic Random Access Memory			
EDSFF	Enterprise and Datacenter SSD Form Factor			
EMI	Electro Magnetic Interference			
ESD	Electrostatic Discharge			
EU	European Union			
FCC	Federal Communications Commission			
FRU	Field Replaceable Unit			
1/0	Input / Output			
I2C	Inter-Integrated Circuit - two wire serial protocol			
IEC	International Electrotechnical Commission			
IPC	Institute for Printed Circuits			
IPMI	Intelligent Platform Management Interface			
ISO	International Organization for Standardization			
LED	Light Emitting Diode			
LFF	Large Form Factor			
LFM	Linear Feet per Minute			
MAC	Media Access Control			
MC	Management Controller			
MCTP	Management Component Transport Protocol			
ME	Management Entity			
NC	No Connect			
NC-SI	Network Controller Sideband Interface			
NEBS	Network Equipment Building-System			
NIC	Network Interface Card			
ОСР	Open Compute Project			
ODM Original Design Manufacturer				

0514					
	OEM Original Equipment Manufacturer PRA Printed Board Assembly				
PBA	Printed Board Assembly				
PCB	Printed Circuit Board				
PCI™ Peripheral Component Interconnect PCI Syrross®					
PCIe® PCI Express®					
PDR	Platform Descriptor Record				
PLDM					
QSFP					
QZ	Quiet Zone				
RA	Right Angle				
RBT	RMII Based Transport				
REACH	Registration, Evaluation, Authorization and Restriction of Chemicals				
RFU	Reserved Future Use				
RJ45	Registered Jack 45 (IEC 60603-7 8P8C connector)				
RoHS Restriction of Hazardous Substances Directive					
RSVD Reserved					
RTU Root of Trust for Update					
SFF					
SFP Small Form Factor Pluggable					
SMBus	System Management Bus				
SMT	Surface Mount Technology				
TBD	To be Determined				
TDP	Thermal Design Power				
UART	Universal Asynchronous Receiver-Transmitter				
UUID	,				
UEFI	Unified Extensible Firmware Interface				
USB	Universal Serial Bus				
VDM	Vendor Defined Messages				
WEEE	Waste Electrical and Electronic Equipment				

1.5 Background

The OCP NIC 3.0 specification is a follow-on to the OCP Mezz 2.0 rev 1.00 design specification. The OCP NIC 3.0 specification supports two basic card sizes: Small Form Factor (SFF), and Large Form Factor (LFF). The SFF allows for up to 16 PCIe® lanes on the card edge while the LFF supports up to 32 PCIe lanes. Compared to the OCP Mezz Card 2.0 Design Specification, the updated OCP NIC 3.0 specification provides a broader solution space for the NIC and system vendors to support the following use case scenarios:

- NICs with a higher Thermal Design Power (TDP)
- Power delivery supports up to 80 W to a single connector (SFF) card, and up to 150 W to a dual connector (LFF) card
 - Note: Baseboard vendors need to evaluate if there is sufficient airflow to thermally cool the OCP NIC 3.0 card. Refer to Section 6 for additional details.
- Supports up to PCle Gen 4 (16 GT/s) on the baseboard and OCP NIC 3.0 card
 - o Connector is electrically compatible with PCIe Gen 5 (32 GT/s)
- Support for up to 32 lanes of PCIe per OCP NIC 3.0 card
- Support for single host, multi-root complex, and multi-host environments
- Supports a greater board area for more complex OCP NIC 3.0 card designs
- Support for Smart NIC implementations with on-board DRAM and accelerators
- Simplification of FRU installation and removal while reducing overall down time

A representative SFF OCP NIC 3.0 card is shown in Figure 1 and a representative LFF is shown in Figure 2.

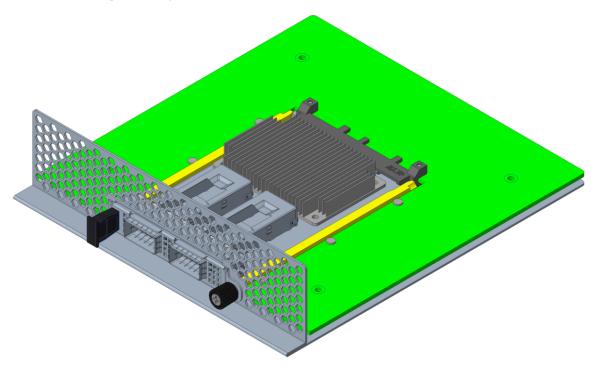


Figure 1: Representative SFF OCP NIC 3.0 Card with Dual QSFP Ports

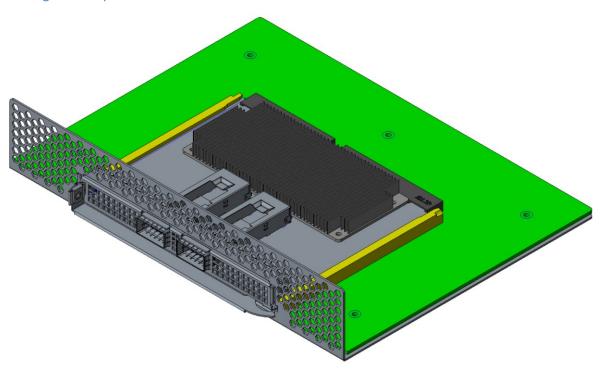


Figure 2: Representative LFF OCP NIC 3.0 Card with Dual QSFP Ports and on-board DRAM

In order to achieve the features outlined in this specification, OCP NIC 3.0 compliant cards are not backwards compatible with OCP Mezz 2.0 cards.

This specification is created under OCP Server workgroup – OCP NIC subgroup. An electronic copy of this specification can be found on the Open Compute Project and the OCP Marketplace websites:

http://www.opencompute.org/wiki/Server/Mezz#Specifications and Designs

https://www.opencompute.org/contributions?query=OCP%20NIC%203.0

1.6 Overview

1.6.1 Mechanical Form Factor Overview

The OCP NIC 3.0 specification defines a third generation mechanical form factor that allows for interoperability between compliant baseboards and OCP NIC 3.0 cards.

OCP NIC 3.0 cards have two form factors – SFF and LFF. These cards are shown in Figure 3 below. The components shown in the figures are for illustrative purposes. The SFF uses one connector (Primary Connector) on the baseboard. The LFF uses one or two connectors (Primary Connector only or both the Primary and Secondary Connectors) on the baseboard.

Both the Primary and Secondary Connectors and card edge gold fingers are defined in and compliant to SFF-TA-1002. The Primary Connector is the "4C+" variant, the Secondary Connector is the "4C" version. On the OCP NIC 3.0 card side, the card edge is implemented with gold fingers. The SFF gold finger area only occupies the Primary Connector area for up to 16 PCIe lanes. The LFF gold finger area may occupy both the Primary and Secondary Connectors for up to 32 PCIe lanes, or optionally just the Primary Connector for up to 16 PCIe lane implementations.

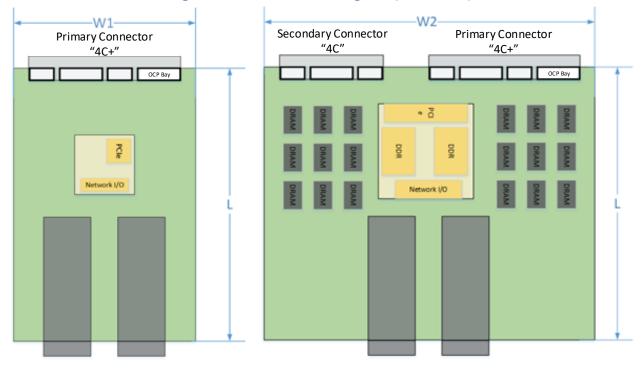


Figure 3: SFF and LFF Block Diagrams (not to scale)

The two form factor dimensions are shown in Table 3.

Form	Width	Depth	Primary	Secondary	Typical Use Case
Factor			Connector	Connector	
SFF	W1 = 76	L = 115	"4C+"	N/A	Low profile and NIC with a
	mm	mm	168 pins		similar profile as an OCP NIC
					2.0 card; up to 16 PCIe lanes.
LFF	W2 = 139	L = 115	"4C+"	"4C"	Larger PCB width to support
	mm	mm	168 pins	140 pins	additional NICs; up to 32 PCIe
					lanes.

Table 3: OCP 3.0 Form Factor Dimensions

The OCP NIC 3.0 design allows downward compatibility between the two card sizes. Table 4 shows the compatibility between the baseboard and NIC combinations. A SFF baseboard slot may only accept a SFF sized NIC. A LFF baseboard slot may accept a SFF or LFF NIC.

Baseboard	NIC Size / Supported PCIe Width		
Slot Size	SFF	LFF	
SFF	Up to 16 PCIe lanes	Not Supported	
LFF	Up to 16 PCIe lanes	Up to 32 PCIe lanes	

Table 4: Baseboard to OCP NIC Form Factor Compatibility Chart

There are two baseboard connector mounting options available for system designers: straddle mount and right angle (RA). The straddle mount connector option allows the OCP NIC and baseboard to exist in a co-planer position. To achieve this, a cutout exists on the baseboard and is defined in this specification. Alternatively, the right angle option allows the OCP NIC to be installed on top of the baseboard. A baseboard cutout is not required for the right angle connector. The right angle option allows the baseboard to use this area for additional routing or backside component placement. The straddle mount and right angle connectors are shown in Section 3.2.

For both the baseboard and OCP NIC 3.0 card, this specification defines the component and routing keep out areas. Refer to Section 2.5 for details.

Both the straddle mount and right angle implementations shall accept the same OCP NIC 3.0 card and shall be supported in the baseboard chassis regardless of the baseboard connector selection (right angle or straddle mount) so long as the baseboard slot and OCP NIC 3.0 card sizes are a supported combination as shown in Table 4.

This specification defines the form factor at the OCP NIC 3.0 card level, including the front panel, latching mechanism and card guide features.

More details about the card form factor is shown in Section 2.

1.6.2 Electrical Overview

This specification defines the electrical interface between baseboard and the OCP NIC 3.0 card. The electrical interface is implemented with a right angle or straddle mount connector on baseboard and gold finger on the OCP NIC 3.0 card. As previously noted in the mechanical overview, each card may implement a Primary Connector or Primary + Secondary Connector. Cards using only the Primary Connector are suitable for both the SFF and LFF and may support up to 16 lanes of PCIe. The Secondary Connector, when used in conjunction with the Primary Connector, allows LFF implementations and may support up to 32 lanes of PCIe.

1.6.2.1 Primary Connector

The Primary Connector provides all OCP specific management functions as well as up to 16 lanes of PCIe between the OCP NIC and the system motherboard.

Management Function Overview (OCP Bay):

- DMTF DSP0222 compliant Network Controller Sideband Interface (NC-SI) RMII Based Transport (RBT) Physical Interface
- Power management and status reporting
 - o Power break for emergency power reduction
 - State change control
- Control / status serial bus
 - NIC-to-Host status
 - Port LED Link/Activity
 - Environmental Indicators
 - Host-to-NIC configuration Information
- Multi-host PCIe support signals (2x PCIe resets, 2x reference clocks)
 - The OCP bay provides PERST2#, PERST3#, REFCLK2 and REFCLK3. This enables support for up to four hosts when used in conjunction with PERST0#, PERST1#, REFCLK0 and REFCLK1 in the Primary 4C region.
- PCIe Wake signal

See Section 3.4 for a complete list of pin and function descriptions for the OCP Bay portion of the Primary Connector. The OCP Bay pins are prefixed with "OCP_" in the pin location column.

Interface Overview (4C Connector):

- 16x differential transmit/receive pairs
 - Up to PCle Gen 4 (16 GT/s) support
 - Connector is electrically compatible with PCIe Gen 5 (32 GT/s)
- 2x 100 MHz differential reference clocks
- Control signals
 - 2x PCIe Resets
 - Link Bifurcation Control
 - Card power disable/enable
- SMBus 2.0
- USB 2.0 interface

- Power
 - o +12V_EDGE
 - o +3.3V_EDGE
 - o Power distribution between the aux and main power domains is up to the baseboard vendor

See Section 3.4 for a complete list of pin and function descriptions for the 4C+ connector.

1.6.2.2 Secondary Connector

The Secondary Connector provides an additional 16 lanes of PCIe and their respective control signals.

Interface Overview (4C Connector):

- 16x differential transmit/receive pairs
 - O Up to PCle Gen 4 (16 GT/s) support
 - Connector is electrically compatible with PCIe Gen 5 (32 GT/s)
- 2x 100 MHz differential reference clocks
- Control signals
 - o 2x PCIe Resets
 - Link Bifurcation Control
 - Card power disable/enable
- SMBus 2.0
- UART (transmit and receive)
- Power
 - o +12V EDGE
 - +3.3V_EDGE
 - o Power distribution between the aux and main power domains is up to the baseboard vendor

See Section 3.4 for a complete list of pin and function descriptions for the 4C connector.

1.7 Non-NIC Use Cases

The OCP NIC 3.0 specification is mainly targeted for Network Interface Card applications. It is possible to use the same OCP NIC 3.0 card form factor, baseboard interface and mechanical design to enable non-NIC use cases. These non-NIC use cases use the same baseboard/OCP NIC 3.0 card interface as defined in Section 3. The non-NIC use cases are not covered in the current revision of the OCP NIC 3.0 specification. Example non-NIC use cases implement various external I/O interfaces and are shown in Table 5.

Table 5: Example Non-NIC Use Cases

Example Use Case	Card External I/O Interface(s)
PCIe Retimer Card	PCIe
Accelerator Card	N/A
NVMe Card	N/A
Storage HBA / RAID Card	TBD

2 Mechanical Card Form Factor

2.1 Form Factor Options

OCP NIC 3.0 provides two fundamental form factor options: a SFF (76 mm x 115 mm) and a LFF (139 mm x 115 mm).

These form factors support a Primary Connector and optionally, a Secondary Connector. The Primary Connector is defined to be a SFF-TA-1002 compliant 4C+ connector. The 4C+ connector is a 4C complaint implementation plus a 28-pin "OCP bay" for OCP NIC 3.0 specific pins. The Secondary Connector is the 4C connector as defined in SFF-TA-1002. The 4C specification supports up to 32 differential pairs for a x16 PCIe connection per connector. For host platforms, the 28-pin OCP bay is required for all Primary Connector implementations.

The SFF uses the Primary 4C+ connector to provide up to a x16 PCle interface to the host. The additional 28-pin OCP bay carries sideband management interfaces as well as OCP NIC 3.0 specific control signals for multi-host PCle support. The SFF card provides sufficient faceplate area to accommodate up to 2x QSFP modules, 4x SFP modules, or 4x RJ45 for BASE-T operation. The SFF supports up to 80 W of delivered power to the card edge. An example SFF is shown in Figure 1.

The LFF uses the Primary 4C+ connector to provide the same functionality as the SFF along with an additional Secondary 4C connector to provide up to a x32 PCIe interface. The LFF Card may utilize both the Primary and Secondary Connectors, or just the Primary Connector for lower PCIe lane count applications. Table 6 summarizes the LFF permutations. The LFF supports higher power envelopes and provides additional board area for more complex designs. The LFF supports up to 150 W of delivered power to the card edge across the two connectors. An example LFF is shown in Figure 2.

For LFF Cards, implementations may use both the Primary and Secondary Connector (as shown in Figure 4), or may use the Primary Connector only (as shown in Figure 5) for the card edge gold fingers.

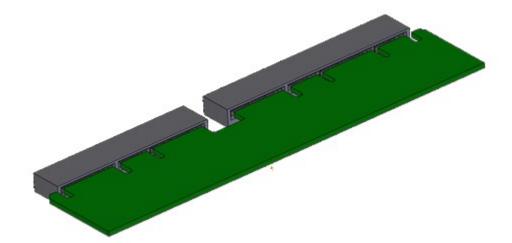


Figure 4: Primary Connector (4C+) and Secondary Connector (4C) (LFF) OCP NIC 3.0 Cards

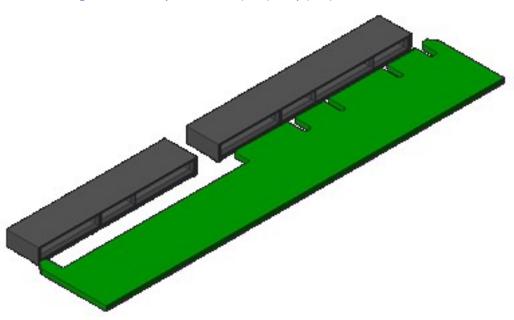


Figure 5: Primary Connector (4C+) Only (LFF) OCP NIC 3.0 Cards

For both form factors, an OCP NIC 3.0 card may optionally implement a subset of pins to support less than a x16 PCIe connection. This may be implemented using a 2C+ card edge per SFF-TA-1002. The baseboard Primary Connector shall use a 4C+ in all cases. Figure 6 illustrates the supported 4C+ and 2C+ card edge configurations on a 4C+ Primary Connector.

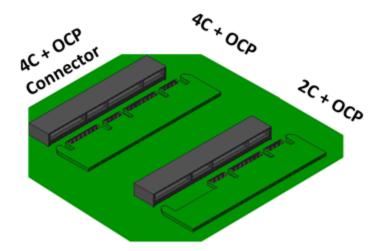


Figure 6: Primary Connector (4C+) with 4C and 2C (SFF) OCP NIC 3.0 Cards

Table 6 summarizes the supported card form factors. SFF cards support the Primary Connector and up to 16 PCIe lanes. LFF cards support implementations with both the Primary and Secondary Connectors and up to 32 PCIe lanes, or a Primary Connector only implementation with up to 16 PCIe lanes.

OCP NIC 3.0 Card **Baseboard Secondary Baseboard Primary** Size and PCle Lane Connector (4C) Connector (4C+) Count x16 PCle x16 PCle OCP Bay SFF (x8) Not used with SFF 2C+ Card Edge x8 (Lanes 7:0) PCle OCP Bay x16 (Lanes 15:0) PCIe SFF (x16) Not used with SFF 4C+ Card Edge OCP Bay Not used with LFF 2C+ Card Edge x8 (Lanes 7:0) PCle OCP Bay LFF (x8) LFF (x16) Not used with LFF 4C+ Card Edge x16 (Lanes 15:0) PCle OCP Bay LFF (x32) x16 (Lanes 31:16) PCIe x16 (Lanes 15:0) PCIe OCP Bay

Table 6: OCP NIC 3.0 Card Definitions

2.1.1 SFF Faceplate Configurations

The SFF configuration views are shown below. Three different faceplates are available for the SFF – a pull tab, ejector latch and an internal lock version are available. The same SFF OCP NIC 3.0 PBA assembly accepts all three faceplates types and may be interchanged depending on the end application. The drawings shown in Figure 7 below illustrate a representative front, side and top views of the SFF.

Where space is permitted on the faceplate, square vents sized to a maximum of 3.0 mm x 3.0 mm must be added to help optimize airflow while maintaining the integrity of the faceplate structure. EMI considerations should also be taken into account during the design process. Refer to the images shown in Figure 8 for example square vent configurations depending on the line side I/O connectors.

Depending on the OCP NIC 3.0 card implementation, I/O connectors may be placed anywhere within the allowable connector keep in regions as defined by the SFF PBA mechanical drawings and faceplate drawings of Section 2.5.1.

The OCP NIC 3.0 outline provides an optional feature to lock the card into the chassis. This is accomplished with two notches – one on each side of the card guide rail. A baseboard may choose to use one or both notches for the internal locking mechanism. Only one notch is required to hold the card in place. The OCP NIC 3.0 outline provides a notch location on both guide rails to provide flexible configurations to baseboard vendors. If the locking feature is implemented on the baseboard, the OCP NIC 3.0 card may only be inserted or removed after pressing on an internal locking mechanism. This retention notch is compatible with all chassis implementations. Please refer to the SFF dimensions in Section 2.5.1 for details. The internal locking mechanism is not available on LFF cards.

Note: The OCP NIC 3.0 card supplier shall add port identification on the faceplate assembly that meet their manufacturing and customer requirements.

All of the OCP NIC 3.0 CAD files are available for download and use on the OCP NIC 3.0 Wiki site: http://www.opencompute.org/wiki/Server/Mezz

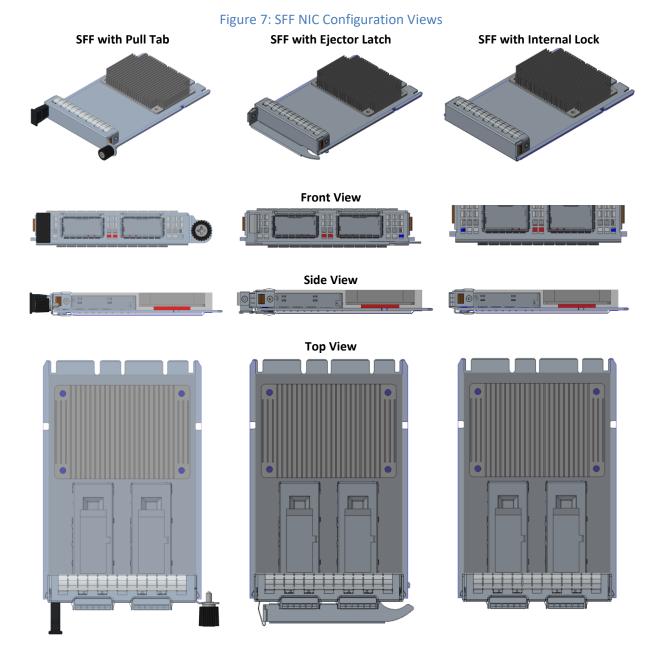


Figure 8 illustrates example SFF 3D views for the supported line side I/O implementations. The line side I/O implementations are discussed in Section 2.2.

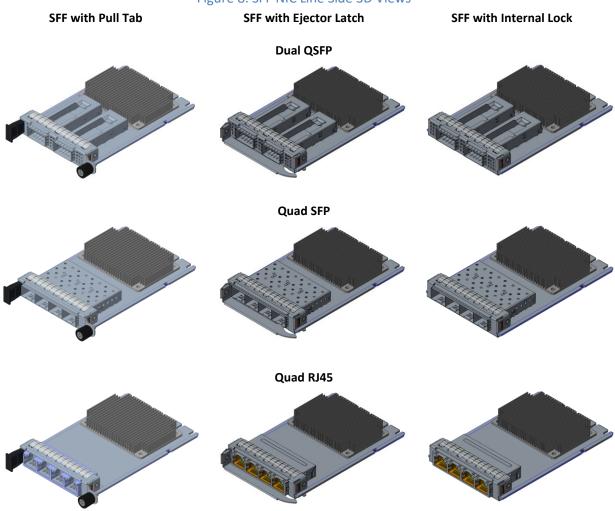
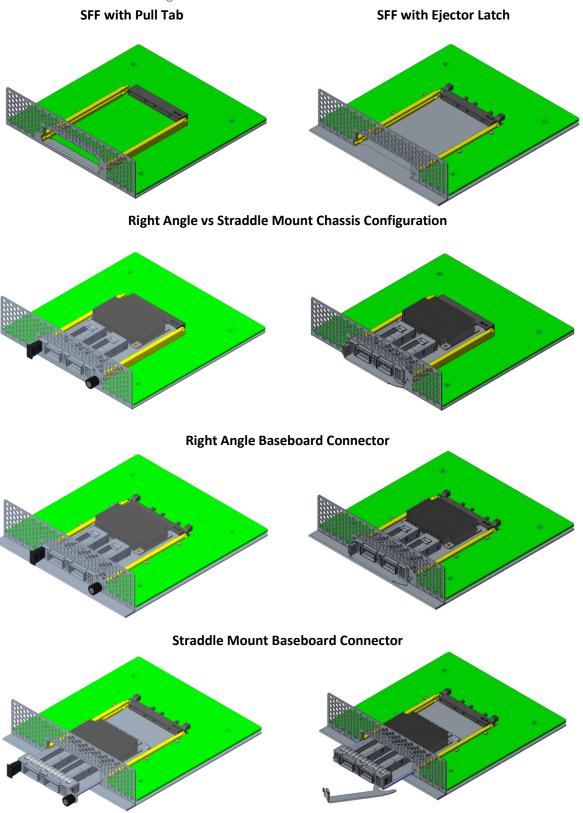


Figure 8: SFF NIC Line Side 3D Views

Figure 9 illustrates example SFF 3D views of the pull tab and ejector latch assemblies mounted in a chassis utilizing a straddle mount connector and a right angle connector. The baseboard connector options are discussed in Section 3.2. The SFF OCP NIC 3.0 card is identical for both chassis connector options.

As previously noted, the OCP NIC 3.0 card provides a notch on the rail edge for an internal locking mechanism to prevent card insertion and removal. The internal locking mechanism is an optional feature and is not shown in the views below.

Figure 9: SFF NIC Chassis Mounted 3D Views



NIC Insertion / Removal (Shown with a Straddle Mount Connector)

2.1.2 LFF Faceplate Configurations

The LFF configuration views are shown below. A single faceplate implementation is available for the LFF — with a single ejector latch. The long ejector is the default configuration, however, a short ejector version is available for non-shadowed front I/O configurations and is being considered for future development. Similar to the SFF, if additional LFF faceplate implementations become available, the same LFF OCP NIC 3.0 PBA assembly shall be able to accept new faceplate types and may be interchanged depending on the end application. The drawings shown in Figure 10 below illustrate a representative front, side and top views of the LFF.

Where space is permitted on the faceplate, square vents sized to a maximum of 3.0 mm x 3.0 mm must be added to help optimize airflow while maintaining the integrity of the faceplate structure. EMI considerations should also be taken into account during the design process. Refer to the images shown in Figure 11 for example square vent configurations depending on the line side I/O connectors.

Depending on the OCP NIC 3.0 card implementation, I/O connectors may be placed anywhere within the allowable connector keep in regions as defined by the PBA mechanical drawings and faceplate drawings of Section 2.5

Note: The OCP NIC 3.0 card supplier shall add port identification on the faceplate assembly that meet their manufacturing and customer requirements.

All of the OCP NIC 3.0 CAD files are available for download and use on the OCP NIC 3.0 Wiki site: http://www.opencompute.org/wiki/Server/Mezz

Front View
Side View

Figure 10: LFF NIC Configuration Views

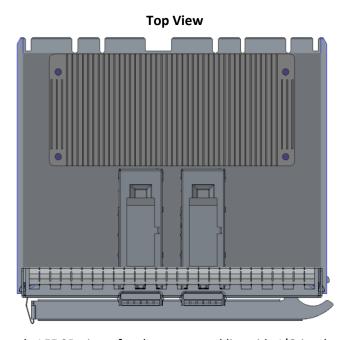


Figure 11 illustrates example LFF 3D views for the supported line side I/O implementations. The line side I/O implementations are discussed in Section 2.2.

Figure 11: LFF NIC Line Side 3D Views

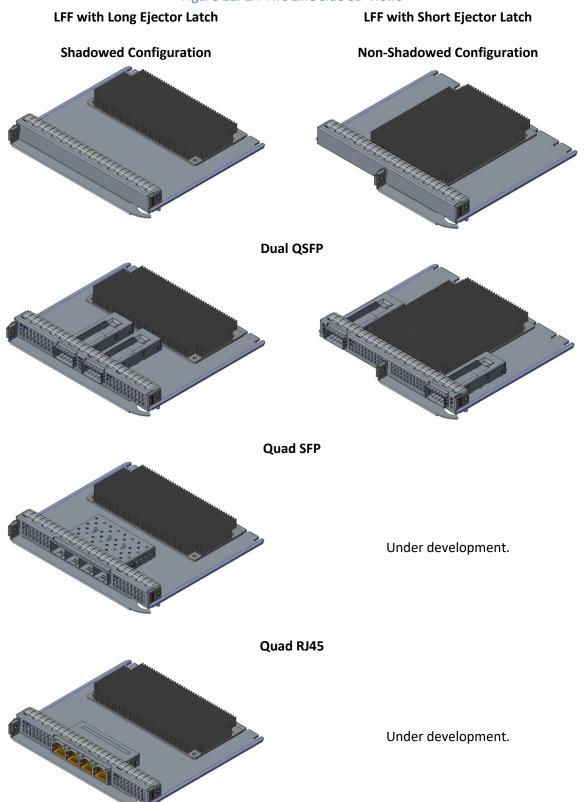


Figure 12 illustrates example LFF 3D views of the ejector latch assembly mounted in a chassis utilizing a straddle mount connector and a right angle connector. The baseboard connector options are discussed in Section 3.2. The LFF OCP NIC 3.0 card is identical for both chassis connector options.

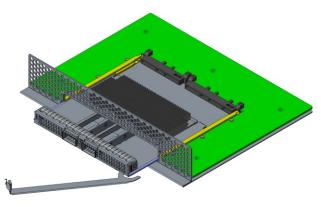
Right Angle Baseboard Connector

Straddle Mount Baseboard Connector

NIC Installed in Baseboard with Right Angle

NIC Installed in Baseboard with Straddle Mount

Figure 12: LFF NIC Chassis Mounted 3D Views



NIC Insertion / Removal (As shown with a Straddle Mount Connector)

2.2 Line Side I/O Implementations

At the time of this writing, the SFF and LFF implementations have been optimized to support the following standard line side I/O implementations:

Form Factor Max Topology Connector Count SFF 2x QSFP+/QSFP28

Table 7: OCP NIC 3.0 Line Side I/O Implementations

SFF 4x SFP28+/SFP28 SFF 4x RJ45 LFF 2x QSFP+/QSFP28 LFF 4x SFP+/SFP28 LFF 4x RJ45

Note: For brevity, references to QSFP+, and QSFP28 shall be referred to as QSFP for the remainder of this document. Similarly, references to SFP+, and SFP28 shall be referred to as SFP.

Additional combinations and connector types are permissible as I/O form factor technologies and thermal capabilities evolve.

2.3 Top Level Assembly (SFF and LFF)

The images in Figure 13 illustrate the exploded top level assemblies for both the SFF and the LFF.

SFF with Ejector Latch

SFF with Internal Lock

LFF with Ejector Latch

Figure 13: PBA Exploded Views (SFF and LFF)

Diagram callouts #8, and #11 through #15 are installed at the NIC assembly level:

Item #8 and #11 – Wave washer and bushing are part of the ejector latch mechanism.

Item #12 & #13 – Screws used to attach the faceplate assembly to the OCP NIC 3.0 PBA.

Item #14 – 2x SMT nuts installed on to the PBA assembly using the reflow process.

Item #15 – Insulator is located on the secondary side and is installed on the PBA prior to the faceplate.

2.4 Faceplate Subassembly (SFF and LFF)

The following section define the generic SFF and LFF faceplates.

2.4.1 Faceplate Subassembly – Exploded View

The images in Figure 14 illustrate the three faceplates subassemblies as exploded views. The bill of materials is shown in Section 2.4.2.

Figure 14: Faceplate Assembly Exploded Views (SFF and LFF)

2.4.2 Faceplate Subassembly – Bill of Materials (BOM)

Table 8 shows the bill of materials for the SFF and LFF assemblies. Item number call outs align with the SFF and LFF numbering of Figure 14.

Note: Dimensionally identical equivalent parts and equivalent materials may be substituted in the assembly. Substituted parts and materials shall meet or exceed the tolerances and requirements specified by the supplier part numbers of Table 8. Refer to the 3D CAD files for hardware specifics not covered by this table.

Table 8: Bill of Materials for the SFF and LFF Faceplate Assemblies

Item#	Item description	Part Number / Drawing	Supplier
1A	Faceplate	See Section 2.4.3:	Custom
1B	·	1A NIC_OCPv3_SFF_Faceplate_Pulltab_20180601.pdf	
1C		1B NIC_OCPv3_SFF_Faceplate_Latch_20180601.pdf	
1D		1C NIC OCPv3 SFF Faceplate IntLock 20180601.pdf	
		See Section 2.4.4:	
		1D NIC_OCPv3_LFF_Faceplate_Latch_20180601.pdf	
2A	Top and Bottom	2A LT18CJ1921 – 13 fingers (Laird)	Laird,
2B	EMI Fingers	TF187VE32F11-2.41-08 (Tech-Etch)	Tech-ETCH
2C	Livii i iligei 3	2B LT18CJ1920 – 11 fingers (Laird)	Teen Even
2D		TF187VE32F11-2.04-08 (Tech-Etch)	
20			
		2C LT18CJ1923 – 27 fingers (Laird) TF187VE32F11-5.03-08 (Tech-Etch)	
		2D LT18CJ1922 – 25 fingers (Laird)	
		TF18G1322 = 23 fingers (Land) TF187VE32F11-4.66-08 (Tech-Etch)	
3	Rivet	1-AC-2421-03_2.4x2.1	Dong Guan KSETT
		_	Hardware
			Technology
4	Side EMI Fingers	LT18DP1911	Laird
5	Thumbscrew	4C-99-343-K081	Southco, Inc.
6A	Pull tab w/2x	CN-99-459	Southco, Inc.
6B	screws		
8	Ejector Wave	See Section 2.4.9 and drawing	Custom
	Compression	NIC_OCPv3_EjectorWasher_20180601.pdf	
	Washer		
9A	Ejector Handle	SFF Ejector: See Section 2.4.5 and drawing	Custom
9B		9A NIC_OCPv3_EjectorHandle_Short_20180601.pdf	
		Note: The SFF ejector is also used on the LFF non-	
		shadowed I/O faceplate configuration.	
		LEE Finatory Con Continue 2 4 6 9 Drawing	
		LFF Ejector: See Section 2.4.6 & Drawing 9B NIC OCPv3 EjectorHandle Long 20180601.pdf	
		96 NIC_OCPVS_EJECTOT Harridge_LOTIG_20180601.put	
10	Ejector Lock	See Section 2.4.7 and drawing	Custom
	,	NIC_OCPv3_EjectorLock_20180601.pdf	
11	Ejector Bushing	See Section 2.4.8 and drawing	Custom
		NIC_OCPv3_EjectorBushing_20180601.pdf	
12	Screw for securing	ICMMBS200403N	WUJIANG Screw
	faceplate to NIC		Tech Precision
			Industry
13	Screw for attaching	FCMMQ200503N	WUJIANG Screw
	faceplate and		Tech Precision
	ejector to NIC		Industry
14	SMT nut (on NIC)	82-950-22-010-05-RL	Fivetech
			Technology Inc.
15A	Insulator	Refer to Section 2.7 for the SFF (15A) and LFF (15B)	Custom
15B		insulator mechanical requirements	

2.4.3 SFF Generic I/O Faceplate

Figure 15 shows the standard SFF I/O bracket with a thumbscrew and pull tab assembly.

Figure 15: SFF Generic I/O Faceplate with Pulltab Version (2D View)

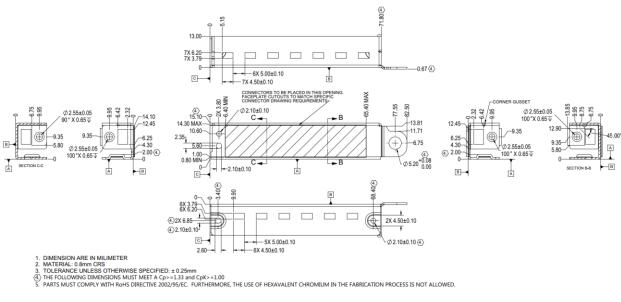
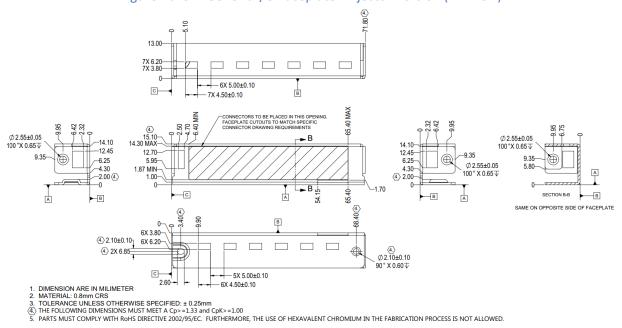


Figure 16: SFF Generic I/O Faceplate – Ejector Version (2D View)



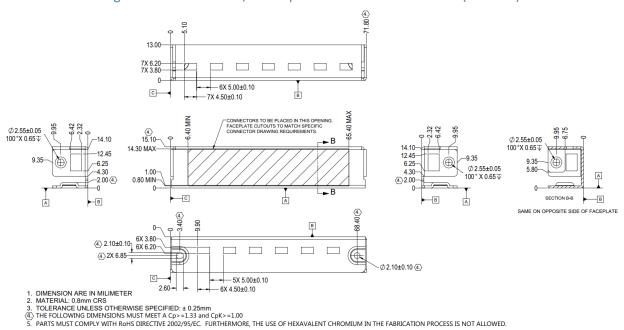
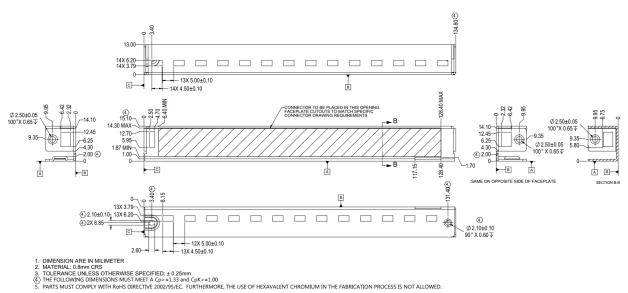


Figure 17: SFF Generic I/O Faceplate – Internal Lock Version (2D View)

2.4.4 LFF Generic I/O Faceplate





2.4.5 **Ejector Lever (SFF)**

This section defines the SFF lever dimensions. Note: this SFF ejector lever is also used on the nonshadowed LFF faceplate configuration.

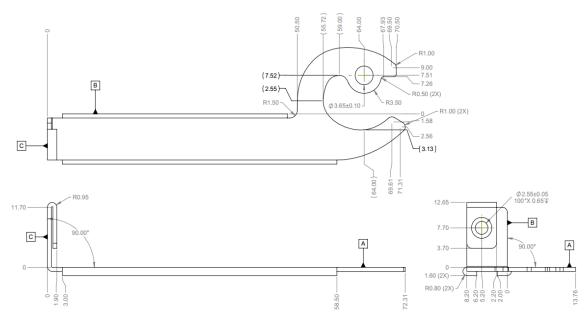


Figure 19: SFF I/O Faceplate – Ejector Lever (2D View)

- 1. DIMENSION ARE IN MILIMETER
- 2. MATERIAL: 0.8mm 301 SS 1/4 HARD
- TOLERANCE UNLESS OTHERWISE SPECIFIED: ± 0.25mm, ±1.0°

2.4.6 **Ejector Levers (LFF)**

This section defines the LFF ejector lever dimensions.

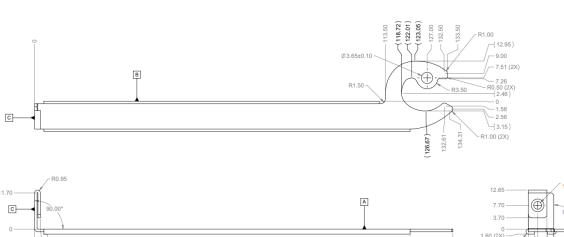


Figure 20: LFF I/O Faceplate – Ejector Lever (2D View)

- 1. DIMENSION ARE IN MILIMETER
- MATERIAL: 0.8mm 301 SS 1/4 HARD TOLERANCE UNLESS OTHERWISE SPECIFIED: ± 0.25mm, ±1.0°
- 4. PARTS MUST COMPLY WITH ROHS DIRECTIVE 2002/95/EC. FÜRTHERMORE, THE USE OF HEXAVALENT CHROMIUM IN THE FABRICATION PROCESS IS NOT ALLOWED.

R0.80 (2X)

2.4.7 Ejector Lock (SFF and LFF)

The SFF and LFF ejector uses a locking mechanism at the end of the handle to retain the lever position. This is shown in Figure 21.

Ø2.55+0.05 С C В В

Figure 21: Ejector Lock

- DIMENSION ARE IN MILIMETER
 MATERIAL: 0.3mm 301 SS 1/2 HARD
 TOLERANCE UNLESS OTHERWISE SPECIFIED: ± 0.25mm, ±1.0°
 PARTS MUST COMPLY WITH ROHS DIRECTIVE 2002/95/EC. FURTHERMORE, THE USE OF HEXAVALENT CHROMIUM IN THE FABRICATION PROCESS IS NOT ALLOWED.

Ejector Bushing (SFF and LFF)

The SFF and LFF card ejector handle uses a bushing as a spacer and rotation anchor. This is shown in Figure 22.

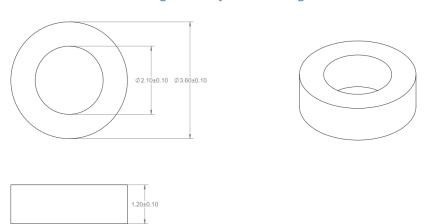


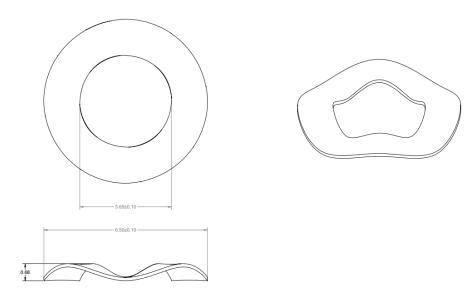
Figure 22: Ejector Bushing

- DIMENSION ARE IN MILIMETER
 MATERIAL: STEEL SAE 1215
 TOLERANCE UNLESS OTHERWISE SPECIFIED: ± 0.25mm, ±1.0°
 PARTS MUST COMPLY WITH RoHS DIRECTIVE 2002/95/EC. FURTHERMORE, THE USE OF HEXAVALENT CHROMIUM IN THE FABRICATION PROCESS IS NOT ALLOWED.

2.4.9 Ejector Wave Washer (SFF and LFF)

The SFF and LFF card ejector handle uses a wave washer between the handle and faceplate assembly. This is shown in Figure 23.

Figure 23: Wave Washer



- DIMENSION ARE IN MILIMETER
 MATERIAL: 65Ms SPRING STEEL, HEAT TREATED
 TOLERANCE UNLESS OTHERWISE SPECIFIED: ± 0.25mm, ±1.0°
 PARTS MUST COMPLY WITH RoHS DIRECTIVE 2002/95/EC. FURTHERMORE, THE USE OF HEXAVALENT CHROMIUM IN THE FABRICATION PROCESS IS NOT ALLOWED.

2.5 Card Keep Out Zones

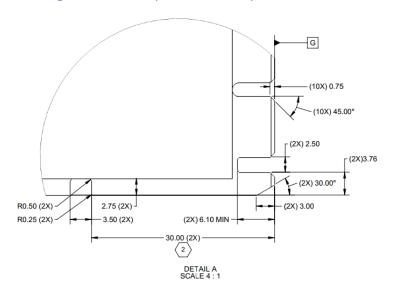
2.5.1 SFF Keep Out Zones

CONNECTOR KEEP IN ZONE REPRESENT MAXIMUM CONNECTOR BODY SIZE. NOT INCLUDING EMI SPRING FINGERS. COMPONENT AND TRACE FREE AREA, TOP & BOTTOM LAYERS. TRACE PERMITTED ON INTERNAL LAYERS UP TO 1.0MM MAX FROM PCB EDGE SMT COMPONENT IS PERMITTED IN THIS AREA WHERE CONNECTOR IS NOT OCCUPIED. CONNECTOR PROTRUSION FROM PCB EDGE 3 (2x)109.76 103.00 MAX 7.00 MIN — T_{2.75 MIN} lacktriangleREFERENCE SFF-TA-1002 CONNECTOR SPEC 29.51 MAX F 76.00 G 37.74 3 3 32.24 2.75 MIN 3 (2X) $03.20^{+0.08}_{0.00}$ COMPONENT KEEP IN COMPONENT AND TRACE FREE AREA, TOP & BOTTOM LAYERS. TRACE PERMITTED ON INTERNAL LAYERS UP TO 1.0MM MAX FROM PCB EDGE (2X) Ø5.50 PLATED PAD — FOR GROUNDING

Figure 24: SFF Keep Out Zone - Top View

- NOTES:
 1. UNLESS OTHERWISE SPECIFIED, DIMENSIONS ARE IN MILIMETER
 2. TOLERANCE UNLESS OTHERWISE SPECIFIED: ±0.13, ±1.0°
- 2. TOLERANCE UNLESS OTHERWISE SPECIFIED: ± 0.13 , $\pm 1.0^{\circ}$ INDICATED DIMENSIONS MUST MEET A Cp>=1.33 AND Cpk>=1.00

Figure 25: SFF Keep Out Zone - Top View - Detail A



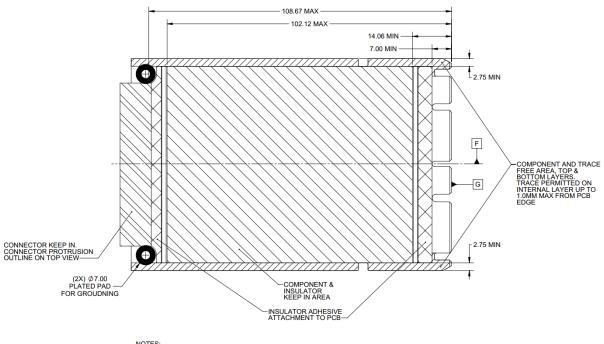
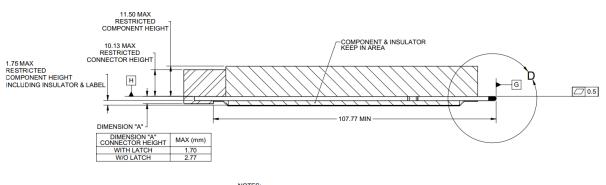


Figure 26: SFF Keep Out Zone - Bottom View

NOTES: 1. UNLESS OTHERWISE SPECIFIED, DIMENSIONS ARE IN MILIMETER 2. TOLERANCE UNLESS OTHERWISE SPECIFIED: ±0.13, ±1.0°

Figure 27: SFF Keep Out Zone – Side View



NOTES:
1. UNLESS OTHERWISE SPECIFIED, DIMENSIONS ARE IN MILIMETER
2. TOLERANCE UNLESS OTHERWISE SPECIFIED: ±0.13, ±1.0°

Note: The area defined by DIMENSION "A" is between the faceplate and the primary side of the board. Grounded through-hole mounting pins are permitted but should avoid making contact with the latching mechanism and EMI fingers. Signal pins are not permitted in this area.

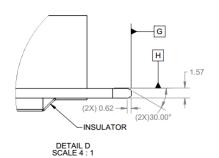


Figure 28: SFF Keep Out Zone – Side View – Detail D

2.5.2 LFF Keep Out Zones

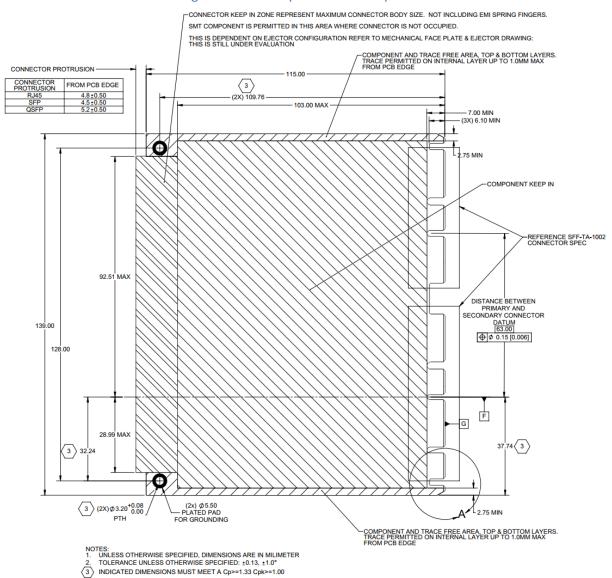


Figure 29: LFF Keep Out Zone - Top View

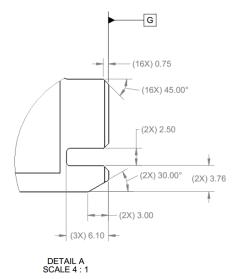
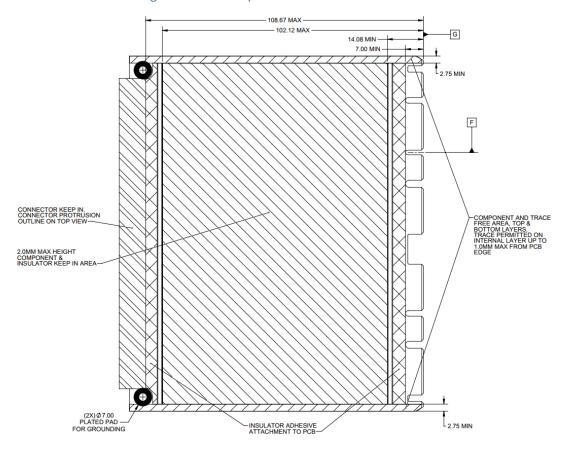


Figure 30: LFF Keep Out Zone – Top View – Detail A

Figure 31: LFF Keep Out Zone – Bottom View



NOTES:
1. UNLESS OTHERWISE SPECIFIED, DIMENSIONS ARE IN MILIMETER
2. TOLERANCE UNLESS OTHERWISE SPECIFIED: ±0.13, ±1.0°

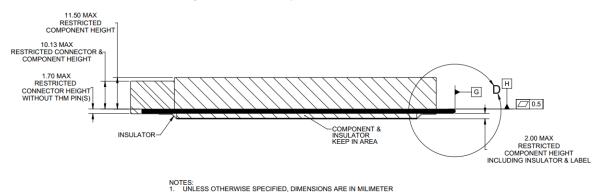
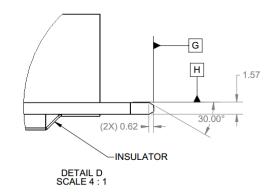


Figure 32: LFF Keep Out Zone – Side View

TOLERANCE UNLESS OTHERWISE SPECIFIED: ±0.13, ±1.0°

Figure 33: LFF Keep Out Zone - Side View - Detail D



2.6 Baseboard Keep Out Zones

Refer to the 3D CAD files for the baseboard keep out zones for both the SFF and LFF designs. The 3D CAD files are available for download on the OCP NIC 3.0 Wiki:

http://www.opencompute.org/wiki/Server/Mezz

2.7 Insulation Requirements

All OCP NIC 3.0 cards shall implement an insulator to prevent the bottom side card components from shorting out to the baseboard chassis. The recommended insulator thickness is 0.25 mm and shall reside within the following mechanical envelope for the SFF and LFF.

2.7.1 **SFF** Insulator

Figure 34: SFF Bottom Side Insulator (3D View)

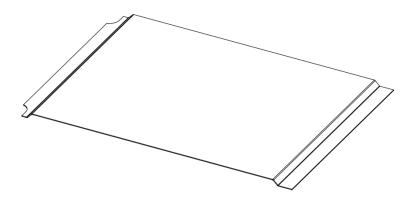
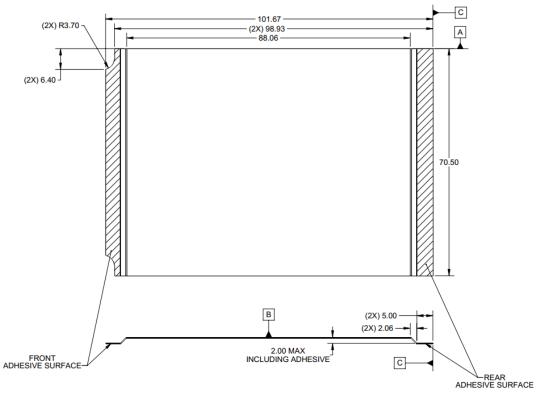


Figure 35: SFF Bottom Side Insulator (Top and Side View)

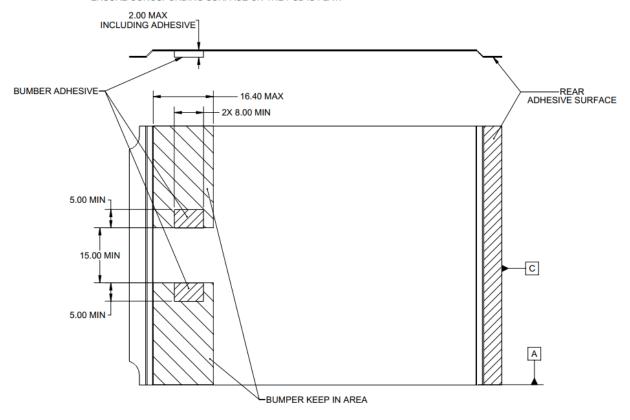


- DIMENSION ARE IN MILIMETER
- MATERIAL: FORMEX GK-10BK or FORMEX N3 (HALOGEN FREE, BLACK OR NATURAL), 0.25mm THICKNESS

- MATERIAL SHALL CONFORM TO 94VTM-0 ADHESIVE 3M 467MP 0.05mm THICKNESS TOLERANCE UNLESS OTHERWISE SPECIFIED: ± 0.30mm, ±1.0°

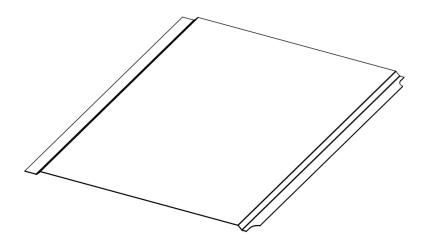
Figure 36: SFF Bottom Side Insulator (alternate) (Top and Side View)

ALTERNATE OPTION USING BUMBER & ADHESIVE FOR ATTACHING THE INSULATOR TO PCB INSTEAD OF USING FRONT ADHESIVE SURFACE. ENSURE COROSPONDING SURFACE ON THE PCB IS FLAT.



2.7.2 LFF Insulator

Figure 37: LFF Bottom Side Insulator (3D View)



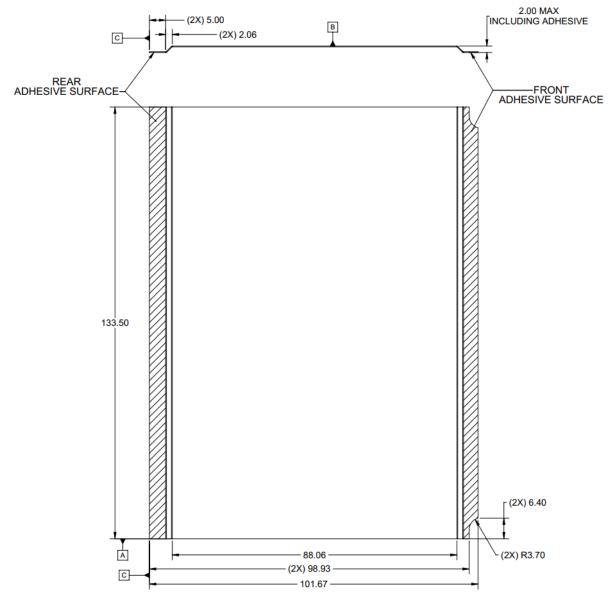
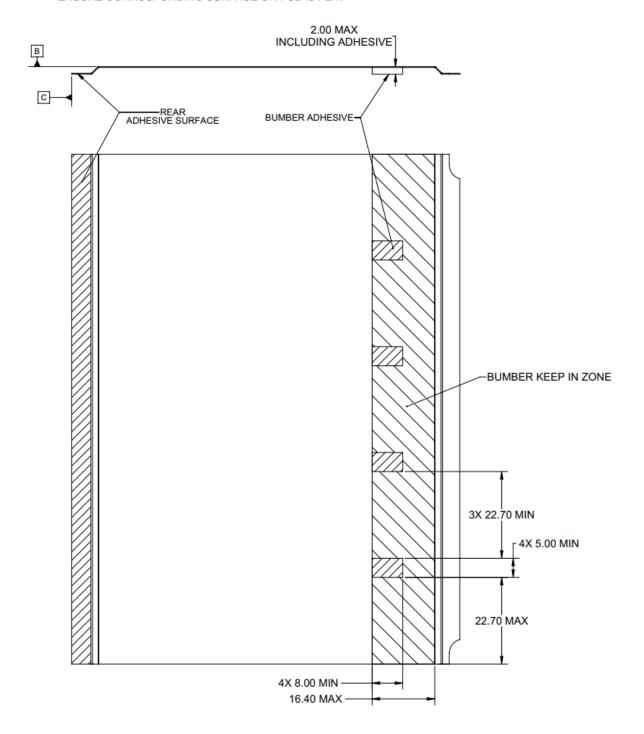


Figure 38: LFF Bottom Side Insulator (Top and Side View)

- 1. DIMENSION ARE IN MILIMETER
- 2. MATERIAL: FORMEX GK-10BK, FORMEX N3 (HALOGEN FREE, BLACK OR NATURAL), 0.25mm THICKNESS
- 3. MATERIAL SHALL CONFORM TO 94VTM-0
- 4. ADHESIVE 3M 467MP 0.05mm THICKNESS
- 5. TOLERANCE UNLESS OTHERWISE SPECIFIED: $\pm~0.30$ mm, ±1.0 °

Figure 39: LFF Bottom Side Insulator (alternate) (Top and Side View)

ALTERNATE OPTION USING BUMBER & ADHESIVE FOR ATTACHING THE INSULATOR TO PCB INSTEAD OF USING FRONT ADHESIVE SURFACE. ENSURE CORROSPONDING SURFACE ON PCB IS FLAT



2.8 Critical-to-Function (CTF) Dimensions (SFF and LFF)

2.8.1 CTF Tolerances

The following CTF tolerances are used in this section and are the same for both the SFF and LFF.

Table 9: CTF Default Tolerances (SFF and LFF OCP NIC 3.0)

CTF DEFAULT TOLERANCES				
DIMENSION RANGE TOLERANCE				
	TWO PLACE DECIMALS: X.XX			
LINEAR:	± 0.30			
ANGULAR:	± 1.00 DEGREES			
HOLE DIAMETER:	± 0.13			

2.8.2 SFF Pull Tab CTF Dimensions

The following dimensions are considered critical-to-function (CTF) for each SFF OCP NIC 3.0 card with a pull tab and thumbscrew. The CTF default tolerances are shown in Section 2.8.1.

Figure 40: SFF OCP NIC 3.0 Card with Pull Tab CTF Dimensions (Top View)

Figure 41: SFF OCP NIC 3.0 Card with Pull Tab CTF Dimensions (Front View)

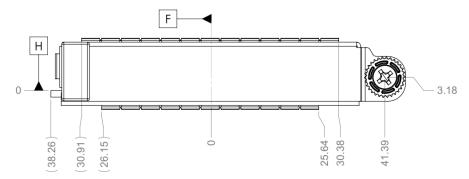


Figure 42: SFF OCP NIC 3.0 Card with Pull Tab CTF Dimensions (Side View)



2.8.3 SFF OCP NIC 3.0 Card with Ejector Latch CTF Dimensions

The following dimensions are considered critical-to-function (CTF) for each SFF OCP NIC 3.0 card with ejector latch. The CTF default tolerances are shown in Section 2.8.1.

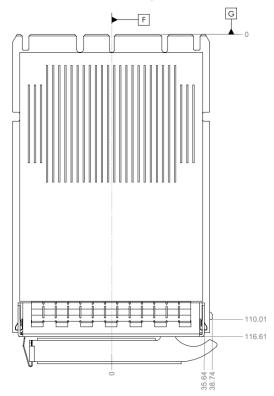


Figure 43: SFF OCP NIC 3.0 Card with Ejector CTF Dimensions (Top View)

Figure 44: SFF OCP NIC 3.0 Card with Ejector CTF Dimensions (Front View)

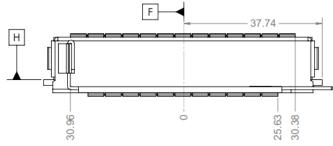
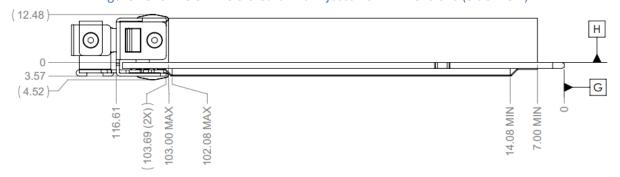


Figure 45: SFF OCP NIC 3.0 Card with Ejector CTF Dimensions (Side View)



2.8.4 SFF OCP NIC 3.0 Baseboard CTF Dimensions

The following dimensions are considered critical-to-function (CTF) for each SFF baseboard chassis. The CTF default tolerances are shown in Section 2.8.1.

Note: The SFF baseboard CTF dimensions are applicable to both the right angle and straddle mount connector configurations. The faceplate opening relative to the baseboard changes due to the connector vertical offset, but all CTF dimensions remain identical.

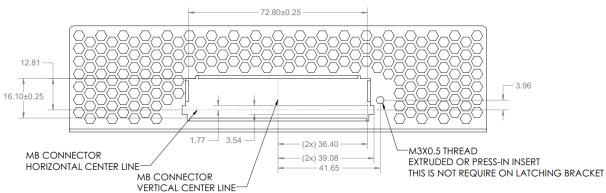
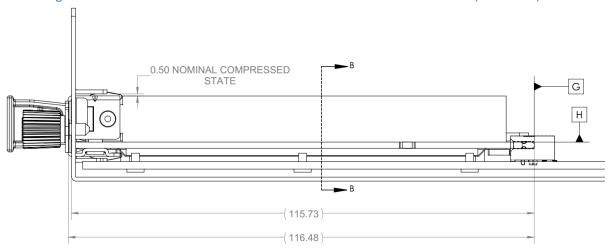


Figure 46: SFF Baseboard Chassis CTF Dimensions (Rear View)





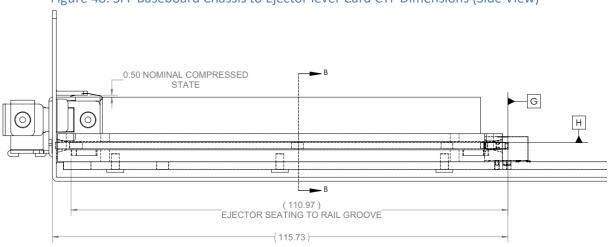


Figure 48: SFF Baseboard Chassis to Ejector lever Card CTF Dimensions (Side View)

Figure 49: SFF Baseboard Chassis CTF Dimensions (Rear Rail Guide View)

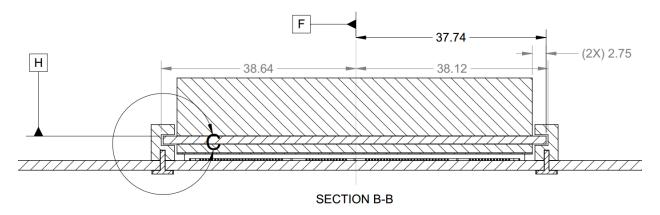
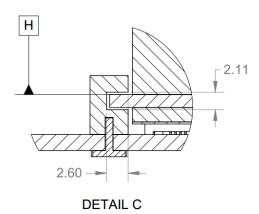


Figure 50: SFF Baseboard Chassis CTF Dimensions (Rail Guide Detail) - Detail C



The right angle and straddle mount card guides are identical between the SFF and LFF cards. The card guide model is included in the 3D CAD packages and may be downloaded from the OCP NIC 3.0 Wiki site: http://www.opencompute.org/wiki/Server/Mezz.

2.8.5 LFF OCP NIC 3.0 Card CTF Dimensions

The following dimensions are considered critical-to-function (CTF) for each LFF OCP NIC 3.0 card. The CTF default tolerances are shown in Section 2.8.1.

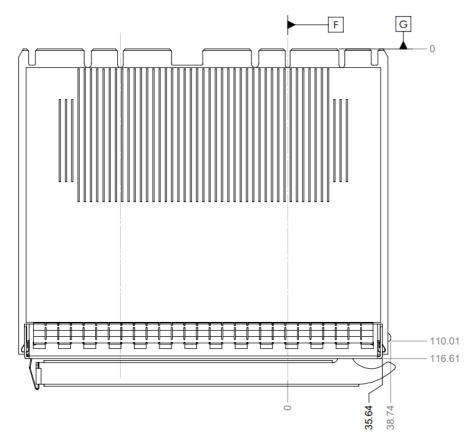
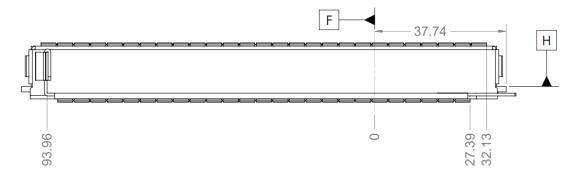


Figure 51: LFF OCP NIC 3.0 Card with Ejector CTF Dimensions (Top View)

Figure 52: LFF OCP NIC 3.0 Card with Ejector CTF Dimensions (Front View)



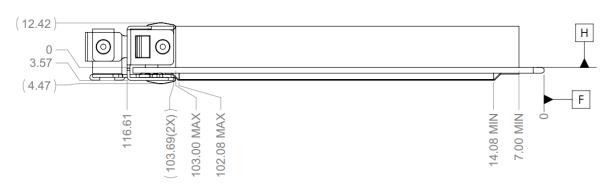


Figure 53: LFF OCP NIC 3.0 Card with Ejector CTF Dimensions (Side View)

2.8.6 LFF OCP NIC 3.0 Baseboard CTF Dimensions

The following dimensions are considered critical-to-function (CTF) for each LFF baseboard chassis. The CTF default tolerances are shown in Section 2.8.1.

Note: The LFF baseboard CTF dimensions are applicable to both the right angle and straddle mount connector configurations. The faceplate opening relative to the baseboard changes due to the connector vertical offset, but all CTF dimensions remain identical.

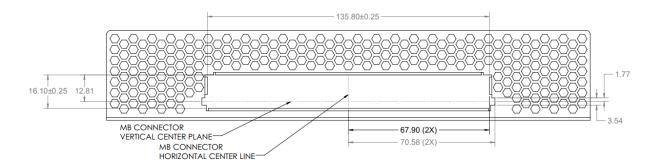


Figure 54: LFF Baseboard Chassis CTF Dimensions (Rear View)

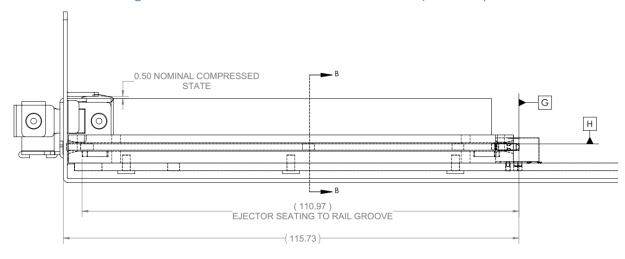


Figure 55: LFF Baseboard Chassis CTF Dimensions (Side View)

Figure 56: LFF Baseboard Chassis CTF Dimensions (Rail Guide View)

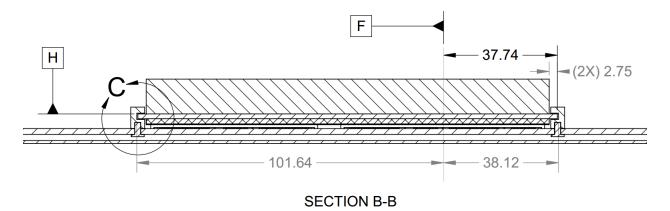
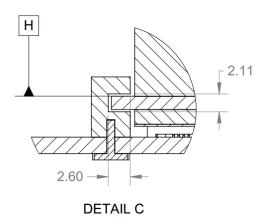


Figure 57: LFF Baseboard Chassis CTF Dimensions (Rail Guide – Detail C)



The right angle and straddle mount card guides are identical between the SFF and LFF. The card guide models are included in the 3D CAD packages and may be downloaded from the OCP NIC 3.0 Wiki site: http://www.opencompute.org/wiki/Server/Mezz.

2.9 Labeling Requirements

OCP NIC 3.0 cards shall implement all (or a subset of) label items listed below as required by each customer. All labels shall be placed on the exposed face of the insulator and within their designated zones. All labels shall be placed within the insulator edge and insulator bend lines to prevent labels from peeling or interfering with the faceplate, chassis card guides and card gold finger edge.

The insulator shall be divided into three different zones:

- Regulatory Zone Used for all regulatory markings and filing numbers
- Customer Zone Used for manufacturer markings or any ODM specific labels
- **OCP NIC 3.0 Zone** Used for MAC addresses, part number labels and optionally the board serial number label if there are no manufacturer requirements to place it on the primary side

Notes:

- Some NIC vendor(s) may require serial number labels to be placed on the primary side of the PBA. This is permitted but it is up to the NIC vendor(s) to find the appropriate location(s) to affix the label. If a label is to be adhered to the PCB, then the label must be ESD safe as defined by ANSI/ESD S541-2008 (between 10⁴ and 10¹¹ Ohms).
- Regulatory marks may be printed on the insulator or affixed via a label
- Each zone size shall be adjustable to accommodate each vendor's labeling requirements
- All labels shall be oriented and readable in the same direction. The readable direction should be with the line side I/O interfaces facing "up"
- Additional labels may be placed on the primary side or on the PCB itself. This is up to the NIC vendor(s) to find the appropriate location(s)

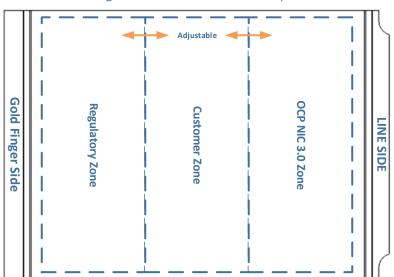


Figure 58: SFF Label Area Example

2.9.1 General Guidelines for Label Contents

Each board shall have a unique label for identification. The label information shall be both in human readable and machine readable formats (linear or 2D data matrix). The labels may include:

- Serial number
- Part Number
- MAC Address
- Manufacturing Date
- Manufacturing Site Information

Barcode Requirements

- Linear Barcodes
- Code 93, Code 128 Auto or Code 128 Subset B
- Minimum narrow bar width X ≥5 mil (0.127 mm)
- 2D data matrix
- Data matrix shall use ECC200 error correction
- Minimum cell size X ≥10 mil (0.254 mm)
- All linear barcode and data matrix labels shall meet the contrast and print growth requirements per ISO/IEC 16022
- All linear barcode and data matrix labels shall have a quality level C or higher per ISO/IER 15415
- All linear barcode and data matrix labels shall define a minimum Quiet Zone (QZ) to ensure the label is correctly registered by the scanner per ISO/IEC 15415
- Linear barcode labels shall use a QZ that is 10 times the width of the narrowest bar or 1/8th inch, whichever is greater.
- Data matrix labels shall have a Quiet Zone (QZ) that is at least one module (X dimension) around the perimeter of the data matrix.
- Multiple Serial Numbers, MAC address may exist in one 2D data matrix, each separated by a comma

Human Readable Font

- Arial or printer font equivalent
- Minimum 5 point font size. 3 point font is acceptable when using 600 DPI printers
- Text must be easily legible under normal lighting 6-to-8 inches away.

The label size and typeface may vary based on each vendor and/or customer's label content and requirements.

2.9.2 MAC Address Labeling Requirements

For an OCP NIC 3.0 card with *m* line side interfaces and *n* RBT management interfaces, the MAC address label shall list the MAC addresses in sequential order starting with line side port 1 to port *m* followed by the controller #0 MAC address to controller *n*. For cards that support multi-host configurations, the label shall associate each MAC address with a host number. The examples below show the MAC addresses presented as a single column, for labels with many MAC addresses, the label may also be formatted in multiple columns for greater readability.

2.9.2.1 MAC Address Label Example 1 – Quad Port with Single Host, Single Managed Controller

As an example, the label content of a quad SFP OCP NIC 3.0 card with a single management MAC address shall be constructed to show human readable data per the Label Data column of Table 10. The

constructed label is shown in Figure 59. For each human readable line, there is a MAC prefix "Px:" for a line side Port, or "MEx:" for a managed controller instance, followed by the MAC address. The port/controller association for each row is shown in the far right column.

Table 10: MAC Address Label Example 1 – Quad Port with Single Host, Single Managed Controller

Label Data	MAC Prefix	MAC Address	Association
P1: AA:BB:CC:DD:EE:F0	P1:	AA:BB:CC:DD:EE:F0	Port 1
P2: AA:BB:CC:DD:EE:F1	P2:	AA:BB:CC:DD:EE:F1	Port 2
P3: AA:BB:CC:DD:EE:F2	P3:	AA:BB:CC:DD:EE:F2	Port 3
P4: AA:BB:CC:DD:EE:F3	P4:	AA:BB:CC:DD:EE:F3	Port 4
ME1: AA:BB:CC:DD:EE:F4	ME1:	AA:BB:CC:DD:EE:F4	Controller #0

Figure 59: MAC Address Label Example 1 – Quad Port with Single Host, Single Managed Controller



P1: AA:BB:CC:DD:EE:F0 P2: AA:BB:CC:DD:EE:F1 P3: AA:BB:CC:DD:EE:F2 P4: AA:BB:CC:DD:EE:F3 ME1: AA:BB:CC:DD:EE:F4

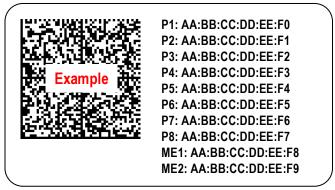
2.9.2.2 MAC Address Label Example 2 – Octal Port with Single Host, Dual Managed Controllers

As a second example, the label content of an octal port (2xQSFP with "breakout" support) OCP NIC 3.0 card with two managed silicon instances is constructed per Table 11. The constructed label is shown in Figure 60. The MAC address label shall also list the four MAC addresses associated with QSFP lanes [1:4] for QSFP connectors that allow "breakout" modes. The Host-MAC address presentation may also be formatted horizontally for easier readability.

Table 11: MAC Address Label Example 2 – Octal Port with Single Host, Dual Managed Controller

Label Data	MAC Prefix	MAC Address	Association
P1: AA:BB:CC:DD:EE:F0	P1:	AA:BB:CC:DD:EE:F0	QSFP1, Port 1
P2: AA:BB:CC:DD:EE:F1	P2:	AA:BB:CC:DD:EE:F1	QSFP1, Port 2
P3: AA:BB:CC:DD:EE:F2	P3:	AA:BB:CC:DD:EE:F2	QSFP1, Port 3
P4: AA:BB:CC:DD:EE:F3	P4:	AA:BB:CC:DD:EE:F3	QSFP1, Port 4
P5: AA:BB:CC:DD:EE:F4	P5:	AA:BB:CC:DD:EE:F4	QSFP2, Port 5
P6: AA:BB:CC:DD:EE:F5	P6:	AA:BB:CC:DD:EE:F5	QSFP2, Port 6
P7: AA:BB:CC:DD:EE:F6	P7:	AA:BB:CC:DD:EE:F6	QSFP2, Port 7
P8: AA:BB:CC:DD:EE:F7	P8:	AA:BB:CC:DD:EE:F7	QSFP2, Port 8
ME1: AA:BB:CC:DD:EE:F8	ME1:	AA:BB:CC:DD:EE:F8	Controller #0
ME2: AA:BB:CC:DD:EE:F9	ME2:	AA:BB:CC:DD:EE:F9	Controller #1

Figure 60: MAC Address Label Example 2 – Octal Port with Single Host, Dual Managed Controller



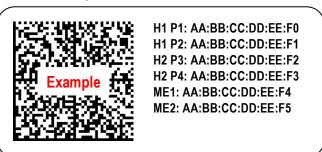
2.9.2.3 MAC Address Label Example 3 – Quad Port with Dual Hosts, Dual Managed Controllers

For multi-host implementations, each MAC address shall be prefixed with the host association "Hx" prior to the port number, where x represents the host number. An example of this is shown in Table 12 and Figure 61.

Table 12: MAC Address Label Example 3 – Quad Port with Dual Hosts, Dual Managed Controller

Label Data	Host	MAC	MAC Address	Association
		Prefix		
P1: AA:BB:CC:DD:EE:F0	H1	P1:	AA:BB:CC:DD:EE:F0	Port 1
P2: AA:BB:CC:DD:EE:F1	H1	P2:	AA:BB:CC:DD:EE:F1	Port 2
P3: AA:BB:CC:DD:EE:F2	H2	P3:	AA:BB:CC:DD:EE:F2	Port 3
P4: AA:BB:CC:DD:EE:F3	H2	P4:	AA:BB:CC:DD:EE:F3	Port 4
ME1:	n/a	ME1:	AA:BB:CC:DD:EE:F4	Controller #0
AA:BB:CC:DD:EE:F4				
ME2:	n/a	ME2:	AA:BB:CC:DD:EE:F5	Controller #1
AA:BB:CC:DD:EE:F5				

Figure 61: MAC Address Label Example 3 – Quad Port with Dual Hosts, Dual Managed Controllers



2.9.2.4 MAC Address Label Example 4 – Singe Port with Quad Host, Single Managed Controller

The following example shows a single port device with quad hosts. To conserve space on the MAC address label, this example only shows the MAC addresses for Port 1 through Port 4. The MAC address for each managed host is Px+1. This is shown in Table 13 and Figure 62.

Table 13: MAC Address Label Example 4 – Single Port with Quad Host, Single Managed Controller

Label Data	Host	MAC	MAC Address	Association
		Prefix		
P1: AA:BB:CC:DD:EE:F0	H1	P1:	AA:BB:CC:DD:EE:F0	Port 1
ME1:	ME1	P1:	AA:BB:CC:DD:EE:F1	Port 1
AA:BB:CC:DD:EE:F1				
P2: AA:BB:CC:DD:EE:F2	H2	P1:	AA:BB:CC:DD:EE:F2	Port 1
ME2:	ME2	P1:	AA:BB:CC:DD:EE:F3	Port 1
AA:BB:CC:DD:EE:F3				
P3: AA:BB:CC:DD:EE:F4	H3	P1:	AA:BB:CC:DD:EE:F4	Port 1
ME3:	ME3	P1:	AA:BB:CC:DD:EE:F5	Port 1
AA:BB:CC:DD:EE:F5				
P4: AA:BB:CC:DD:EE:F6	H4	P1:	AA:BB:CC:DD:EE:F6	Port 1
ME4:	ME4	P1:	AA:BB:CC:DD:EE:F7	Port 1
AA:BB:CC:DD:EE:F7				

Figure 62: MAC Address Label Example 4 – Single Port with Quad Host, Single Managed Controller



H1 P1: AA:BB:CC:DD:EE:F0 H2 P1: AA:BB:CC:DD:EE:F2 H3 P1: AA:BB:CC:DD:EE:F4 H4 P1: AA:BB:CC:DD:EE:F6

2.10 Mechanical CAD Package Examples

Typical OCP NIC 3.0 implementation examples are included in the 3D CAD package. The purpose of these examples is to demonstrate the implementation feasibility. Additional use cases beyond the implementation examples are possible as long they adhere to the OCP NIC 3.0 specification.

Note: For brevity, references to QSFP+, and QSFP28 shall be referred to as QSFP in this document. Similarly, references to SFP+, and SFP28 shall be referred to as SFP.

The 3D CAD files may be obtained from the OCP NIC 3.0 Wiki: http://www.opencompute.org/wiki/Server/Mezz

Table 14: NIC Implementation Examples and 3D CAD

Implementation Example	3D CAD File name
SFF Single/Dual QSFP ports	01_nic_v3_sff2q_1tab_asm.stp
	01_nic_v3_sff2q_latch_asm.stp
SFF Single/Dual SFP ports	N/A
SFF Quad SFP ports	01_nic_v3_sff4s_1tab_asm.stp
	01_nic_v3_sff4s_latch_asm.stp
SFF Quad 10GBASE-T ports	01_nic_v3_sff4r_1tab_asm.stp
	01_nic_v3_sff4r_latch_asm.stp
LFF Single/Dual QSFP ports	01_nic_v3_lff2q_asm.stp
LFF Single/Dual SFP ports	N/A
LFF Quad SFP ports	01_nic_v3_lff4s_asm.stp
LFF Quad 10GBASE-T ports	01_nic_v3_lff4r_asm.stp

3 Electrical Interface Definition – Card Edge and Baseboard

3.1 Card Edge Gold Finger Requirements

The OCP NIC 3.0 cards are compliant to the SFF-TA-1002 specification with respect to the gold fingers and connectors.

SFF cards fit in the Primary Connector. Primary Connector compliant cards are 76 mm x 115 mm and may implement the full 168-pins. The Primary Connector cards may optionally implement a subset of gold finger pins if there is a reduced PCle width requirement (such as 1 x8 and below). In this case, the card edge gold finger may implement a 2C+ design. The overall board thickness is 1.57 mm. The gold finger dimensions for the Primary Connector compliant cards are shown below.

LFF cards support up to a x32 PCIe implementation and may use both the Primary 4C+and Secondary 4C Connectors. LFF cards may implement a reduced PCIe lane count and optionally implement only the Primary Connector.

Note: The "B" pins on the connector are associated with the top side of the OCP NIC 3.0 card. The "A" pins on the connector are associated with the bottom side of the OCP NIC 3.0 card. The A and B side pins are physically on top of each other with zero x-axis offset.

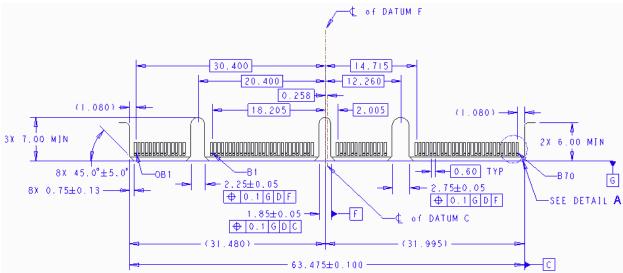


Figure 63: SFF Primary Connector Gold Finger Dimensions – x16 – Top Side ("B" Pins)

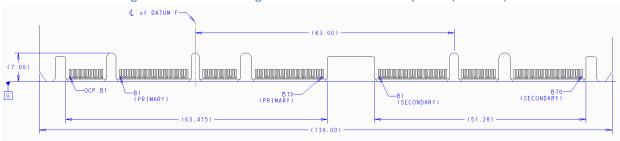
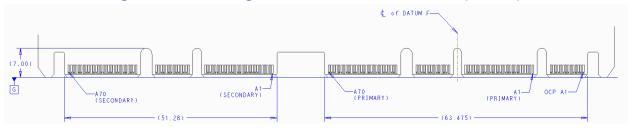


Figure 64: LFF Gold Finger Dimensions – x32 – Top Side ("B" Pins)





3.1.1 Gold Finger Mating Sequence

Per the SFF-TA-1002 specification, the Primary and Secondary Connectors are protocol agnostic and are optimized for high speed differential pairs. For use in the OCP NIC 3.0 application, some pin locations are used for single ended control nets or power and would benefit from a shorter pin length for staggering. As such, the required OCP NIC 3.0 card gold finger staging is shown in Table 15 for a two stage, first-mate, last-break functionality. The two-stage finger length is a normative requirement for the OCP NIC 3.0 card. The host connectors have a single stage mating and do not implement different pin lengths.

The AIC Plug (Free) side refers to the OCP NIC 3.0 card gold fingers; the receptacle (Fixed) side refers to the physical connector on the host platform. This table is based on the SFF-TA-1002 Table A-1 with modifications for OCP NIC 3.0. Refer to the mechanical drawings for pin the first-mate and second-mate lengths.

Note: Pin names in Table 15 and Table 16 are used for first mate/second mate reference only. Full pin definitions are described in Sections 3.3 and 3.4.

Side B				Sic	de A		
	Gold Finger Si	de (Free)	Receptacle		Gold Finger Si	de (Free)	Receptacle
	2 nd Mate	1 st Mate	(Fixed)		2 nd Mate	1 st Mate	(Fixed)
OCP B1	NIC_PWR_GOOD			OCP A1	PERST2#		
OCP B2	MAIN_PWR_EN			OCP A2	PERST3#		
OCP B3	LD#			OCP A3	WAKE#		
OCP B4	DATA_IN			OCP A4	RBT_ARB_IN		
OCP B5	DATA_OUT			OCP A5	RBT_ARB_OUT		
OCP B6	CLK			OCP A6	SLOT_ID1		
OCP B7	SLOT_ID0			OCP A7	RBT_TX_EN		
OCP B8	RBT_RXD1			OCP A8	RBT_TXD1		
OCP B9	RBT_RXD0			OCP A9	RBT_TXD0		
OCP B10	GND			OCP A10	GND		
OCP B11	REFCLKn2			OCP A11	REFCLKn3		
OCP B12	REFCLKp2			OCP A12	REFCLKp3		
OCP B13	GND			OCP A13	GND		

Table 15: Contact Mating Positions for the Primary Connector

OCP B14	RBT_CRS_DV	OCP A14	RBT_CLK_IN	
OCF B14	KBI_CKS_DV	Mechanical Key	NB1_CER_IIV	
B1	+12V_EDGE	A1	GND	
B2	+12V EDGE	A2	GND	
B3	+12V EDGE	A3	GND	
B4	+12V EDGE	A4	GND	
B5	+12V EDGE	A5	GND	
В6	+12V EDGE	A6	GND	
В7	BIFO#	A7	SMCLK	
B8	BIF1#	A8	SMDAT	
В9	BIF2#	A9	SMRST#	
B10	PERSTO#	A10	PRSNTA#	
B11	+3.3V_EDGE	A11	PERST1#	
B12	AUX_PWR_EN	A12	PRSNTB2#	
B13	GND	A13	GND	
B14	REFCLKn0	A14	REFCLKn1	
B15	REFCLKp0	A15	REFCLKp1	
B16	GND	A16	GND	
B17	PETn0	A17	PERn0	
B18	PETp0	A18	PERp0	
B19	GND	A19	GND PER 1	
B20	PETn1	A20	PERn1	
B21	PETp1	A21	PERp1	
B22	GND	A22 A23	GND DEPro2	
B23 B24	PETn2 PETp2	A23 A24	PERn2 PERp2	
B24 B25	GND	A24 A25	GND	
B26	PETn3	A26	PERn3	
B27	PETp3	A27	PERp3	
B28	GND	A28	GND	
520	CITE	Mechanical Key	0.10	
B29	GND	A29	GND	
B30	PETn4	A30	PERn4	
B31	PETp4	A31	PERp4	
B32	GND	A32	GND	
B33	PETn5	A33	PERn5	
B34	PETp5	A34	PERp5	
B35	GND	A35	GND	
B36	PETn6	A36	PERn6	
B37	PETp6	A37	PERp6	
B38	GND	A38	GND	
B39	PETn7	A39	PERn7	
B40 B41	PETp7 GND	A40 A41	PERp7 GND	
B41	PRSNTB0#	A41 A42	PRSNTB1#	
D42	FRSINIDO#	Mechanical Key	FK3N1D1#	
B43	GND	A43	GND	
B44	PETn8	A44	PERn8	
B45	PETp8	A45	PERp8	
B46	GND	A46	GND	
B47	PETn9	A47	PERn9	
B48	PETp9	A48	PERp9	
B49	GND	A49	GND	
B50	PETn10	A50	PERn10	
B51	PETp10	A51	PERp10	
B52	GND	A52	GND	
B53	PETn11	A53	PERn11	
B54	PETp11	A54	PERp11	
B55	GND DET n 1 2	A55	GND DEPo12	
B56 B57	PETn12	A56 A57	PERn12	
B57 B58	PETp12 GND	A57 A58	PERp12 GND	
B59	PETn13	A58 A59	PERn13	
B60	PETP13	A60	PERP13	
B61	GND	A61	GND	
B62	PETn14	A62	PERn14	
B63	PETp14	A63	PERp14	
B64	GND	A64	GND	
B65	PETn15	A65	PERn15	
B66	PETp15	A66	PERp15	
B67	GND	A67	GND	

B68	RFU1, N/C		A68	USB_DATn	
B69	RFU2, N/C		A69	USB_DATp	
B70	PRSNTB3#		A70	PWRBRK0#	

Table 16: Contact Mating Positions for the Secondary Connector

	Side B		Side A			
	Gold Finger Side (Free)	Receptacle		Gold Finger Side (Free)	Receptacle	
	2 nd Mate 1 st Mate	(Fixed)		2 nd Mate 1 st Mate	(Fixed)	
B1	+12V EDGE	(i ixeu)	A1	GND	(Tixeu)	
B2	+12V EDGE	_	A2	GND		
B3	+12V EDGE		A3	GND		
B4	+12V EDGE		A4	GND		
B5	+12V EDGE		A5	GND		
В6	+12V EDGE		A6	GND		
В7	BIFO#		A7	SMCLK		
B8	BIF1#		A8	SMDAT		
В9	BIF2#		A9	SMRST#		
B10	PERST4#		A10	PRSNTA#		
B11	+3.3V_EDGE		A11	PERST5#		
B12	AUX_PWR_EN		A12	PRSNTB2#		
B13	GND		A13	GND		
B14 B15	REFCIKA4	_	A14 A15	REFCIKAS	_	
	REFCLKp4 GND	_		REFCLKp5 GND	_	
B16 B17	PETn16		A16 A17	PERn16		
B17	PETP16		A17	PERP16		
B19	GND		A19	GND		
B20	PETn17		A20	PERn17		
B21	PETp17		A21	PERp17		
B22	GND		A22	GND		
B23	PETn18		A23	PERn18		
B24	PETp18		A24	PERp18		
B25	GND		A25	GND		
B26	PETn19		A26	PERn19		
B27	PETp19		A27	PERp19		
B28	GND		A28	GND		
B29	GND	Mec	hanical Key A29	GND		
B30	PETn20	_	A30	PERn20		
B31	PETp20	_	A31	PERp20		
B32	GND		A32	GND		
B33	PETn21		A33	PERn21		
B34	PETp21		A34	PERp21		
B35	GND		A35	GND		
B36	PETn22		A36	PERn22		
B37	PETp22		A37	PERp22		
B38	GND	_	A38	GND		
B39	PETn23		A39	PERn23		
B40	PETp23		A40	PERp23		
B41 B42	GND		A41 A42	GND PRSNTB1#		
D4Z	PRSNTBO#	Med	hanical Key	LIVON I DT#		
B43	GND	Wiec	A43	GND		
B44	PETn24		A44	PERn24		
B45	PETp24		A45	PERp24		
B46	GND		A46	GND		
B47	PETn25		A47	PERn25		
B48	PETp25		A48	PERp25		
B49	GND		A49	GND		
B50	PETn26		A50	PERn26		
B51	PETp26		A51	PERp26		
B52	GND		A52	GND		
B53	PETn27		A53	PERn27		
B54	PETp27		A54	PERp27		
B55 B56	GND PETn28		A55 A56	GND DEPn28		
B56 B57	PETP28		A56 A57	PERn28 PERp28		
B58	GND		A58	GND		
B59	PETn29		A59	PERn29		
			3			

B60	PETp29	A60	PERp29	
B61	GND	A61	GND	
B62	PETn30	A62	PERn30	
B63	PETp30	A63	PERp30	
B64	GND	A64	GND	
B65	PETn31	A65	PERn31	
B66	PETp31	A66	PERp31	
B67	GND	A67	GND	
B68	RFU3, N/C	A68	UART_RX	
B69	RFU4, N/C	A69	UART_TX	
B70	PRSNTB3#	A70	PWRBRK1#	

3.2 Baseboard Connector Requirements

The OCP NIC 3.0 connectors are compliant to the 4C+ and 4C connectors as defined in the SFF-TA-1002 specification for a right angle or straddle mount form factor. The Primary Connector is a 4C+ implementation with 168-pins. The Secondary Connector is a 4C implementation with 140-pins. Both the Primary and Secondary Connectors includes support for up to 32 differential pairs to support a x16 PCIe connection. Each connector also provides 6 pins of +12V_EDGE, and 1 pin of +3.3V_EDGE for power. This implementation is common between both the Primary and Secondary Connectors. In addition, the 4C+ implementation of the Primary Connector has a 28-pin OCP Bay used for management and support for up to a 4 x2 and 4 x4 multi-host configuration on the Primary Connector. The Primary and Secondary Connector drawings are shown below.

All diagram units are in mm unless otherwise noted.

3.2.1 Right Angle Connector

The following offset and height options are available for the right angle Primary and Secondary Connectors.

Name	Pins	Style and Baseboard Thickness	Offset (mm)
Primary Connector – 4C+	168 pins	Right Angle	4.05 mm
Secondary Connector – 4C	140 pins	Right Angle	4.05 mm

Table 17: Right Angle Connector Options



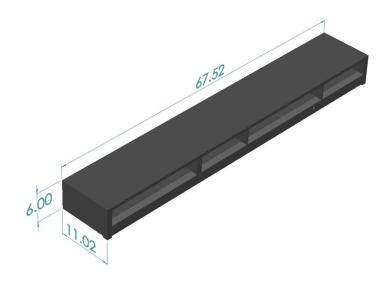


Figure 67: 140-pin Base Board Secondary Connector – Right Angle

3.2.2 Right Angle Offset

The OCP NIC 3.0 right angle connectors have a 4.05 mm offset from the baseboard. This is shown in Figure 68.

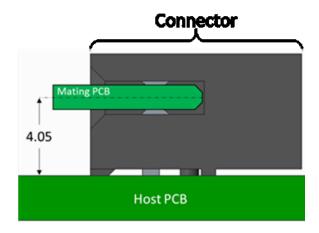


Figure 68: OCP NIC 3.0 Card and Host Offset for Right Angle Connectors

3.2.3 Straddle Mount Connector

The following offset and height options are available for the straddle mount Primary and Secondary Connectors.

Table 18: Straddle Mount Connector Options			
Name	Pins	Style and Baseboard Thickness	Offset (mm)
Primary Connector – 4C+	168 pins	Straddle Mount for 0.062"	Coplanar (0 mm)
Primary Connector – 4C+	168 pins	Straddle Mount for 0.076"	-0.3 mm
Primary Connector – 4C+	168 pins	Straddle Mount for 0.093"	Coplanar (0 mm)
Secondary Connector – 4C	140 pins	Straddle Mount for 0.062"	Coplanar (0 mm)
Secondary Connector – 4C	140 pins	Straddle Mount for 0.076"	-0.3 mm
Secondary Connector – 4C	140 pins	Straddle Mount for 0.093"	Coplanar (0 mm)

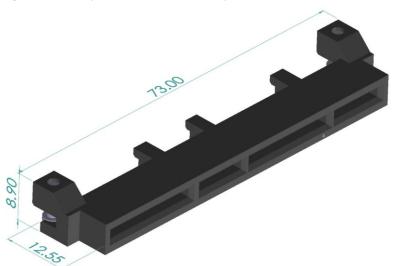
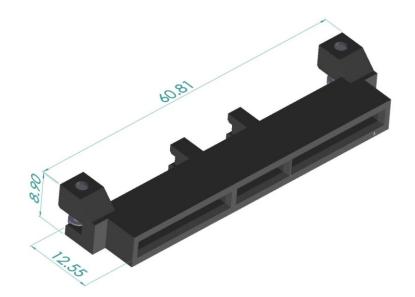


Figure 69: 168-pin Base Board Primary Connector – Straddle Mount

Figure 70: 140-pin Base Board Secondary Connector – Straddle Mount



3.2.4 Straddle Mount Offset and PCB Thickness Options

The OCP NIC 3.0 straddle mount connectors have three baseboard PCB thicknesses they can accept. The available options are shown in Figure 71. The thicknesses are 0.062'', 0.076'', and 0.093''. These PCBs must be controlled to a thickness of $\pm 10\%$. These are available for both the Primary and Secondary Connector locations. At the time of this writing, the most commonly used part is expected to be the 0.076'' baseboard thickness.

Connector

Mating PCB

Host PCB

Thickness

A

B

.062" (1.57mm)

.076" (1.93mm)

.093" (2.36mm)

Figure 71: OCP NIC 3.0 Card and Baseboard PCB Thickness Options for Straddle Mount Connectors

The connectors are capable of being used coplanar as shown in Figure 72. Additionally, the connectors are also capable of having a 0.3 mm offset from the centerline of the host board as shown in Figure 73.

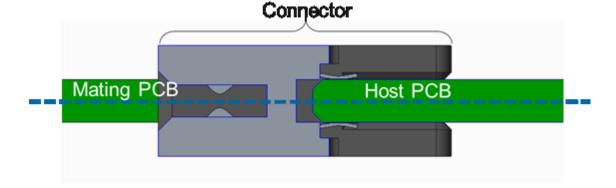
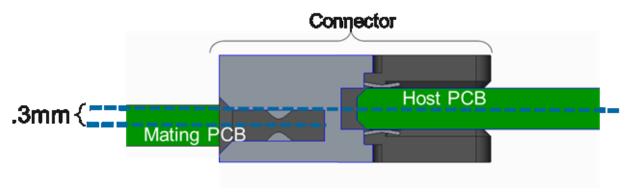


Figure 72: 0 mm Offset (Coplanar) for 0.062" Thick Baseboards

Figure 73: 0.3 mm Offset for 0.076" Thick Baseboards



3.2.5 LFF Connector Locations

In order to support the LFF, systems must locate the Primary and Secondary Connectors per the mechanical drawing shown in Figure 74 and Figure 75.

Figure 74: Primary and Secondary Connector Locations for LFF Support with Right Angle Connectors

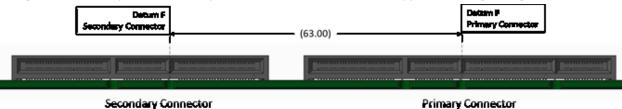
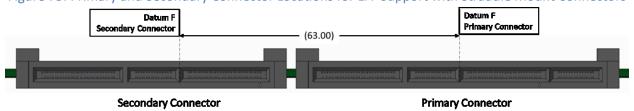


Figure 75: Primary and Secondary Connector Locations for LFF Support with Straddle Mount Connectors



3.3 Pin Definition

The pin definitions of an OCP NIC 3.0 card with up to a x32 PCIe interface are shown in Table 19 and Table 20. All signal directions are shown from the perspective of the baseboard.

A baseboard system may provide a combination of Primary Connectors only, or Primary and Secondary Connectors to support multiple sizes of OCP NIC 3.0 cards. Both connectors share common functionality with power, SMBus 2.0, x16 PCle and bifurcation control. The Primary Connector 4C+ definition has an additional OCP Bay (pins OCP_A[1:14], OCP_B[1:14]) with additional REFCLKs for supporting up to four PCle hosts, NC-SI over RBT connectivity and a Scan Chain for information exchange between the host and card. The NIC is required to implement the Scan Chain, while the baseboard may choose to optionally implement it. Depending on the baseboard form factor, multiple OCP NIC 3.0 compliant cards may be designed into the system.

The Primary and Secondary Connectors pins are shown in Section 3.4. The OCP Bay pins on the Primary Connector only are explicitly called out with the "OCP_" prefix in the pin location column.

Cards or systems that do not require the use of a PCIe x16 connection may optionally implement a subset of electrical connections as applicable to the design. For example, a x8 (or smaller) card using the first 8 PCIe lanes that is compliant with the Primary Connector pinout. Refer to Sections 3.1 and 3.2 for mechanical details. For these cases, the Primary Connector matches the 2C dimensions as defined in SFF-TA-1002.

In all cases, the physical baseboard connectors shall support x16 PCIe widths and must be implemented with the Primary (4C+) and Secondary (4C) connectors.

3.3.1 Primary Connector

Table 19: Primary Connector Pin Definition (x16) (4C+)

	Side B	Side A	401)		
OCP B1	NIC PWR GOOD	PERST2#	OCP A1	_	_
OCP B2	MAIN PWR EN	PERST3#	OCP A2	rin	rin
OCP B3	LD#	WAKE#	OCP A3	nar	nar
OCP_B4	DATA IN	RBT ARB IN	OCP A4	ν ς	y Co
OCP B5	DATA OUT	RBT_ARB_OUT	OCP A5	on n	onn
OCP B6	CLK	SLOT ID1	OCP A6	lect	lect
OCP_B7	SLOT_ID0	RBT_TX_EN	OCP_A7	or .	or .
OCP_B8	RBT_RXD1	RBT_TXD1	OCP_A8	(4 0	(2C
OCP_B9	RBT_RXD0	RBT_TXD0	OCP_A9	, ⁺ ×	,+ ×
OCP_B10	GND	GND	OCP_A10	16,	8, 1
OCP_B11	REFCLKn2	REFCLKn3	OCP_A11	16	112.
OCP_B12	REFCLKp2	REFCLKp3	OCP_A12	8-p	-pir
OCP_B13	GND	GND	OCP_A13	in	0 0
OCP_B14	RBT_CRS_DV	RBT_CLK_IN	OCP_A14	Primary Connector (4C+, x16, 168-pin OCP NIC 3.0 card with OCP Bay)	Primary Connector (2C+, x8, 112-pin OCP NIC 3.0 card with OCP bay)
	Mechar	nical Key		Ž	NIC
B1	+12V_EDGE	GND	A1	C 3	3.0
B2	+12V_EDGE	GND	A2	.0 .) ca
В3	+12V_EDGE	GND	A3	arc	<u>a</u>
B4	+12V_EDGE	GND	A4	₹.	Vit
B5	+12V_EDGE	GND	A5	럀	h C
B6	+12V_EDGE	GND	A6	8	ČP
B7	BIFO#	SMCLK	A7	РВ	ba
B8	BIF1#	SMDAT	A8	ay)	٤
B9	BIF2#	SMRST#	A9		
B10	PERSTO#	PRSNTA#	A10		
B11	+3.3V_EDGE	PERST1#	A11		
B12	AUX_PWR_EN	PRSNTB2#	A12		
B13	GND	GND	A13		
B14	REFCLKn0	REFCLKn1	A14		
B15	REFCLKp0	REFCLKp1	A15		
B16	GND	GND	A16		
B17	PETn0	PERn0	A17		
B18	PETp0	PERp0	A18		
B19	GND	GND	A19		
B20	PETn1	PERn1	A20		
B21	PETp1	PERp1	A21		
B22	GND	GND	A22		

		ı							
B23	PETn2	PERn2	A23						
B24	PETp2	PERp2	A24						
B25	GND	GND	A25						
B26	PETn3	PERn3	A26						
B27	PETp3	PERp3	A27						
B28	GND	GND	A28						
Mechanical Key									
B29	GND	GND	A29						
B30	PETn4	PERn4	A30						
B31	PETp4	PERp4	A31						
B32	GND	GND	A32						
B33	PETn5	PERn5	A33						
B34	PETp5	PERp5	A34						
B35	GND	GND	A35						
B36	PETn6	PERn6	A36						
B37	PETp6	PERp6	A37						
B38	GND	GND	A38						
B39	PETn7	PERn7	A39						
B40	PETp7	PERp7	A40						
B41	GND	GND	A41						
B42	PRSNTB0#	PRSNTB1#	A42						
	Mechan	nical Key							
B43	GND	GND	A43						
B44	PETn8	PERn8	A44						
B45	PETp8	PERp8	A45						
B46	GND	GND	A46						
B47	PETn9	PERn9	A47						
B48	PETp9	PERp9	A48						
B49	GND	GND	A49						
B50	PETn10	PERn10	A50						
B51	PETp10	PERp10	A51						
B52	GND	GND	A52						
B53	PETn11	PERn11	A53						
B54	PETp11	PERp11	A54						
B55	GND	GND	A55						
B56	PETn12	PERn12	A56						
B57	PETp12	PERp12	A57						
B58	GND	GND	A58						
B59	PETn13	PERn13	A59						
B60	PETp13	PERp13	A60						
B61	GND	GND	A61						
B62	PETn14	PERn14	A62						
B63	PETp14	PERp14	A63						
B64	GND	GND	A64						
B65	PETn15	PERn15	A65						
B66	PETp15	PERp15	A66						
B67	GND	GND	A67						
B68	RFU1, N/C	USB_DATn	A68						
B69	RFU2, N/C	USB DATp	A69						
B70	PRSNTB3#	PWRBRK0#	A70						
<u> </u>			1						

3.3.2 Secondary Connector

Table 20: Secondary Connector Pin Definition (x16) (4C)

		y Connector Pin Definition (x16)	(40)	
	Side B	Side A		
B1	+12V_EDGE	GND	A1	Se
B2	+12V_EDGE	GND	A2	8
B3	+12V_EDGE	GND	A3	nda
B4	+12V_EDGE	GND	A4	7
B5	+12V_EDGE	GND	A5	Secondary Connector (4C, x16, 140-pin OCP NIC 3.0 card)
B6	+12V_EDGE	GND	A6	ıne
B7	BIFO#	SMCLK	A7	cto
B8	BIF1#	SMDAT	A8	r (4
В9	BIF2#	SMRST#	A9	Ċ,
B10	PERST4#	PRSNTA#	A10	X16
B11	+3.3V_EDGE	PERST5#	A11	1, 1,
B12	AUX_PWR_EN	PRSNTB2#	A12	40
B13	GND	GND	A13	<u> </u>
B14	REFCLKn4	REFCLKn5	A14	8
B15	REFCLKp4	REFCLKp5	A15	Ÿ
B16	GND	GND	A16	JIC
B17	PETn16	PERn16	A17	3.0
B18	PETp16	PERp16	A18	са (
B19	GND	GND	A19	rd)
B20	PETn17	PERn17	A20	
B21	PETp17	PERp17	A21	
B22	GND	GND	A22	
B23	PETn18	PERn18	A23	
B24	PETp18	PERp18	A24	
B25	GND	GND	A25	
B26	PETn19	PERn19	A26	
B27	PETp19	PERp19	A27	
B28	GND	GND	A28	
	Mechan	nical Key		
B29	GND	GND	A29	
B30	PETn20	PERn20	A30	
B31	PETp20	PERp20	A31	
B32	GND	GND	A32	
B33	PETn21	PERn21	A33	
B34	PETp21	PERp21	A34	
B35	GND	GND	A35	
B36	PETn22	PERn22	A36	
B37	PETp22	PERp22	A37	
B38	GND	GND	A38	
B39	PETn23	PERn23	A39	
B40	PETp23	PERp23	A40	
B41	GND	GND	A41	
B42	PRSNTB0#	PRSNTB1#	A42	
		nical Key		
B43	GND	GND	A43	
B44	PETn24	PERn24	A44	
B45	PETp24	PERp24	A45	
B46	GND	GND	A46	
B47	PETn25	PERn25	A47	
B48	PETp25	PERp25	A48	
B49	GND	GND	A49	
J.J	5/10	5.40		

B50	PETn26	PERn26	A50	
B51	PETp26	PERp26	A51	
B52	GND	GND	A52	
B53	PETn27	PERn27	A53	
B54	PETp27	PERp27	A54	
B55	GND	GND	A55	
B56	PETn28	PERn28	A56	
B57	PETp28	PERp28	A57	
B58	GND	GND	A58	
B59	PETn29	PERn29	A59	
B60	PETp29	PERp29	A60	
B61	GND	GND	A61	
B62	PETn30	PERn30	A62	
B63	PETp30	PERp30	A63	
B64	GND	GND	A64	
B65	PETn31	PERn31	A65	
B66	PETp31	PERp31	A66	
B67	GND	GND	A67	
B68	RFU3, N/C	UART_RX	A68	
B69	RFU4, N/C	UART_TX	A69	
B70	PRSNTB3#	PWRBRK1#	A70	

3.4 Signal Descriptions

The pins shown in this section are common for both the Primary and Secondary Connectors unless otherwise noted. Pins that exist only for the Primary Connector OCP Bay are explicitly called out in the pin location column with the prefix "OCP_xxx". USB is only defined on the Primary Connector. UART is only defined on the secondary connector. All pin directions are from the perspective of the baseboard.

Note: The OCP NIC 3.0 card shall implement protection methods to prevent leakage or low impedance paths between the V_{AUX} and V_{MAIN} power domains in the event that a powered-down NIC is physically present in a powered-up baseboard. This specification provides example isolation implementations in the signal description text and appropriate figures. OCP NIC 3.0 implementers may choose to do a different implementation as long as the isolation requirements are met and the same result is achieved.

3.4.1 PCIe Interface Pins

This section provides the pin assignments for the PCIe interface signals. The PCIe signals have unique names on the Primary and Secondary connector. The Primary Connector uses the REFCLK[0:3], TX/RX[0:15], PERST[0:3] indices. The Secondary Connector uses the REFCLK[4:5], TX/RX[16:31] and PERST[4:5] indices. Where applicable, the Primary/Secondary connector naming convention is shown as a pair. The AC/DC specifications are defined in the PCIe CEM Specification, Rev 4.0. Example connection diagrams for are shown in Section 3.6.

Signal Name (Primary / Secondary)	Pin #	Baseboard Direction	Signal Description
REFCLKn0/REFCLKn4	B14	Output	
REFCLKp0/REFCLKp4	B15		

Table 21: Pin Descriptions – PCle

REFCLKn1/REFCLKn5	A14	Output	PCIe compliant differential reference clock #0, #1,
REFCLKp1/REFCLKp5 REFCLKn2	A15 OCP_B11	Output	#2 and #3. 100MHz reference clocks are used for the OCP NIC 3.0 card PCIe core logic.
REFCLKp2	OCP_B12	σατρατ	PEECLKO is always available to all OCP NIC 3.0 cards
REFCLKn3 REFCLKp3	OCP_A11 OCP_A12	Output REFCLKO is always available to all OCP NIC 3.0 card The card should not assume REFCLK1, REFCLK2 or REFCLK3 are available until the bifurcation negotiation process is complete.	The card should not assume REFCLK1, REFCLK2 or REFCLK3 are available until the bifurcation
			For baseboards, the REFCLKO, REFCLK1, REFCLK2 and REFCLK3 signals shall be available at the Primary Connector for supported designs. REFCLK2 and REFCLK3 are only available on the Primary connector in the OCP Bay. REFCLK4 and REFCLK5 are available on the Secondary connector.
			 REFCLKO is required for all designs. REFCLK1, REFCLK2 and REFCLK3 are required for designs that support 2 xn, and 4 xn bifurcation implementations.
			For baseboard implementations that use REFCLK[1:3], the baseboard should disable the appropriate REFCLKs not used by the OCP NIC 3.0 card.
			The baseboard shall not advertise the corresponding bifurcation modes if REFCLK[1:3] are not implemented.
			REFCLK4 and REFCLK5 are only available on the Secondary Connector and are not defined for use this specification release.
			For OCP NIC 3.0 cards, the required REFCLKs shall be connected per the endpoint datasheet. Unused REFCLKs on the OCP NIC 3.0 card shall be left as a no connect.
			Note: For cards that only support 1 x16, REFCLK0 is used. For cards that support 2 x8, REFCLK0 is used for the first eight PCIe lanes, and REFCLK1 is used for the second eight PCIe lanes. REFCLK2 and REFCLK3 are only used for cards that only support a four link PCIe bifurcation mode.

			Refer to Section 2.1 in the PCIe CEM Specification, Rev 4.0 for electrical details.
PETn0 / PETn16	B17	Output	Transmitter differential pairs [0:15] (Drimon)
PETPO / PETP16	B17 B18	Output	Transmitter differential pairs [0:15] (Primary Connector), and differential pairs [16:31]
PETn1 / PETn17	B20	Output	(Secondary Connector). These pins are connected
PETp1 / PETp17	B21	Output	from the baseboard transmitter differential pairs to
PETn2 / PETn18	B23	Output	the receiver differential pairs on the OCP NIC 3.0
PETp2 / PETp18	B24	Output	card.
PETn3 / PETn19	B26	Output	
PETp3 / PETp19	B27	Juiput	The PCIe transmit pins shall be AC coupled on the
PETn4 / PETn20	B30	Output	baseboard with capacitors. The AC coupling
PETp4 / PETp20	B31	Juiput	capacitor value shall use the C _{TX} parameter value
PETn5 / PETn21	B33	Output	specified in the PCIe Base Specification Rev 4.0
PETp5 / PETp21	B34		Section 8.3.9.
PETn6 / PETn22	B36	Output	
PETp6 / PETp22	B37		For baseboards, the PET[0:15] signals are required
PETn7 / PETn23	B39	Output	at the Primary Connector for a SFF slot. PET[0:15]
PETp7 / PETp23	B40	'	and PET[16:31] are required for a LFF slot.
PETn8 / PETn24	B44	Output	
PETp8 / PETp24	B45		For SFF OCP NIC 3.0 cards, the required PET[0:15]
PETn9 / PETn25	B47	Output	signals shall be connected to the endpoint silicon. For silicon that uses less than a x16 connection, the
PETp9 / PETp25	B48		
PETn10 / PETn26	B50	Output	appropriate PET[0:15] signals shall be connected
PETp10 / PETp26	B51		per the endpoint datasheet.
PETn11 / PETn27	B53	Output	For LEE in the control of DETIC AET and a control of the
PETp11 / PETp27	B54		For LFF implementations, PET[0:15] are assigned to
PETn12 / PETn28	B56	Output	the Primary Connector, and PET[16:31] are
PETp12 / PETp28	B57		assigned to the Secondary Connector.
PETn13 / PETn29	B59	Output	Refer to Section 6.1 in the PCIe CEM Specification,
PETp13 / PETp29	B60		Rev 4.0 for details.
PETn14 / PETn30	B62	Output	Nev 4.0 for details.
PETp14 / PETp30	B63		
PETn15 / PETn31	B65	Output	
PETp15 / PETp31	B66		
PERn0 / PERn16	A17	Input	Receiver differential pairs [0:15] (Primary
PERp0 / PERp16	A18		Connector), and differential pairs [16:31]
PERn1 / PERn17	A20	Input	(Secondary Connector). These pins are connected
PERp1 / PERp17	A21		from the OCP NIC 3.0 card transmitter differential
PERn2 / PERn18	A23	Input	pairs to the receiver differential pairs on the
PERp2 / PERp18	A24		baseboard.

126	1	
	Input	The DCIs massive wire shall be AC several day the
-		The PCIe receive pins shall be AC coupled on the
	Input	OCP NIC 3.0 card with capacitors. The AC coupling
-		capacitor value shall use the C _{TX} parameter value
	Input	specified in the PCIe Base Specification Rev 4.0
		Section 8.3.9.
	Input	Facility of the DEDIO 451 standards and the
		For baseboards, the PER[0:15] signals are required
	Input	at the Primary Connector for a SFF slot. PER[0:15]
•		and PER[16:31] are required for a LFF slot.
	Input	5 655 000 110 0 0 1 11 1 1 1 1 1 1 1 1 1 1
A45		For SFF OCP NIC 3.0 cards, the required PER[0:15]
A47	Input	signals shall be connected to the endpoint silicon.
A48		For silicon that uses less than a x16 connection, the
A50	Input	appropriate PER[0:15] signals shall be connected
A51		per the endpoint datasheet.
A53	Input	
A54		For LFF implementations, PER[0:15] are assigned to
A56	Input	the Primary Connector, and PER[16:31] are
A57		assigned to the Secondary Connector.
A59	Input	
A60		Refer to Section 6.1 in the PCIe CEM Specification,
A62	Input	Rev 4.0 for details.
A63		
A65	Input	
A66		
B10	Output	PCIe Reset #[0:5]. Active low.
A11		
OCP_A1		When PERSTn# is deasserted, the signal shall
OCP_A2		indicate the power state is already in Main Power
		Mode and is within tolerance and stable for the
		OCP NIC 3.0 card to bring up the PCIe link.
		- '
		PERST# shall be deasserted at least 1s after the
		NIC_PWR_GOOD assertion to Main Power Mode.
		This ensures the card power rails are within the
		operating limits. This value is longer than the
		minimum value specified in the PCIe CEM
		Specification. The PCIe REFCLKs shall also become
		stable within this period of time.
		·
		PERST[0:5]# shall be asserted low on the baseboard
		until the platform is ready to deassert reset.
		,
		For baseboards that support bifurcation, the
		PERST[0:3]# signals are required at the Primary
	A48 A50 A51 A53 A54 A56 A57 A59 A60 A62 A63 A65 A66 B10 A11 OCP_A1	A27 A30 Input A31 Input A34 Input A36 Input A37 Input A39 Input A40 Input A43 Input A45 Input A50 Input A51 Input A52 Input A60 Input A62 Input A63 Input A66 Input A11 OCP_A1

		Connector, PERST[4:5]# are required at the Secondary Connector.
		For OCP NIC 3.0 cards, the required PERST[0:5]# signals shall be connected to the endpoint silicon. Unused PERST[0:5]# signals shall be left as a no connect.
		Note: For cards that only support 1 x16, PERSTO# is used. For cards that support 2 x8, PERSTO# is used for the first eight PCIe lanes, and PERST1# is used for the second eight PCIe lanes. PERST2# and PERST3# are only used for cards that support a four link PCIe bifurcation mode.
		PERSTO# is always available to all OCP NIC 3.0 cards. The card should not assume PERST[1:5]#are available until the bifurcation negotiation process is complete.
		Refer to Section 2.2 in the PCIe CEM Specification, Rev 4.0 for details.
OCP_A3	Input, OD	WAKE#. Open drain. Active low.
		This signal shall be driven by the OCP NIC 3.0 card to notify the baseboard to restore PCIe link. For OCP NIC 3.0 cards that support multiple WAKE# signals, their respective WAKE# pins may be tied together as the signal is open-drain to form a wired-OR. For multi-homed host configurations, the WAKE# signal assertion shall wake all nodes.
		For baseboards, this signal shall be pulled up to +3.3V_EDGE on the baseboard with a 10 kOhm resistor. This signals shall be connected to the system WAKE# signal.
		For OCP NIC 3.0 cards, this signal shall be connected between the endpoint silicon WAKE# pin(s) and the card edge through an isolation buffer. The WAKE# signal shall not assert until the PCIe card is in the D3 state according to the PCIe CEM specification to prevent false WAKE# events. For OCP NIC 3.0, the WAKE# pin shall be buffered or otherwise isolated from the host until the aux voltage source is present. Examples of this are shown in Section 3.5.5 by gating via an on-board
	OCP_A3	OCP_A3 Input, OD

			AUX power rails are stable. The PCIe CEM specification also shows an example in the WAKE# signal section. This pin shall be left as a no connect if WAKE# is not
			supported by the silicon.
			Refer to Section 2.3 in the PCIe CEM Specification, Rev 4.0 for details.
PWRBRK0# / PWRBRK1#	A70	Output, OD	Power break. Active low, open drain.
			This signal shall be pulled up to +3.3V_EDGE on the OCP NIC 3.0 card with a minimum of 95 kOhm. The pull up on the baseboard shall be a stiffer resistance in-order to meet the timing specs as shown in the PCIe CEM Specification.
			When this signal is driven low by the baseboard, the Emergency Power Reduction State is requested. The OCP NIC 3.0 card shall move to a lower power consumption state.
			For baseboards, the PWRBRKO# pin shall be implemented and available on the Primary Connector for SFF slots. In addition, the PWRBRK1# pin shall be implemented on the Secondary connector for LFF slots.
			For OCP NIC 3.0 cards, the PWRBRK[0:1]# pin usage is optional. If used, the PWRBRK# should be connected to the network silicon to enable reduced power state. If not used, the PWRBRK[0:1]# signals shall be left as a no connect.
			Note: The PWRBRK[0:1]# pins are only available for OCP NIC 3.0 cards that implement a SFF 4C+ edge connector or a LFF. For SFF cards that implement at 2C+ edge connection, the PWRBRK[0:1]# functionality is not available.

3.4.2 PCle Present and Bifurcation Control Pins

This section provides the pin assignments for the PCIe present and bifurcation control signals. The AC/DC specifications are defined in Section 3.11. Example connection diagrams are shown in Figure 76 and Figure 77.

The PRSNTA#/PRSNTB[0:3]# state shall be used to determine if a card has been physically plugged in. The BIF[0:2]# pins shall be asserted by the baseboard along with the rising edge of AUX_PWR_EN. The BIF[0:2]# pins shall be latched by the OCP NIC 3.0 card when AUX_PWR_EN=1 and NIC_PWR_GOOD=1

to ensure the correct values are detected by the OCP NIC 3.0 card. Changing the pin states after this timing window is not allowed. Refer to the AC timing diagram in Section 3.11 for details.

PRSNTB[0:3]# pins are available to each connector and are independent of each other. For the SFF, the baseboard shall only read the Primary Connector PRSNTB[0:3]# to determine the card type. For the LFF, the baseboard shall read both the Primary and Secondary connector PRSNTB[0:3]# pins to determine the card type. The card type matrix is discussed in Section 3.5.

Table 22: Pin Descriptions – PCle Present and Bifurcation Control Pins

Signal Name	Pin #	Baseboard Direction	Signal Description
PRSNTA#	A10	Output	Present A is used for OCP NIC 3.0 card presence and PCIe capabilities detection.
			For baseboards, this pin shall be directly connected to GND.
			For OCP NIC 3.0 cards, this pin shall be directly connected to the PRSNTB[3:0]# pins.
PRSNTB0# PRSNTB1# PRSNTB2#	B42 A42 A12	Input	Present B [0:3]# are used for OCP NIC 3.0 card presence and PCIe capabilities detection.
PRSNTB3#	B70		For baseboards, these pins shall be connected to the I/O hub and pulled up to +3.3V_EDGE using 1 kOhm resistors.
			For OCP NIC 3.0 cards, these pins shall be strapped to PRSNTA# per the encoding definitions described in Section 3.5.
			Note: PRSNTB3# is located at the bottom of the 4C connector and is only applicable for OCP NIC 3.0 cards with a PCIe width of x16 (or greater). OCP NIC 3.0 cards that implement a 2C card edge do not use the PRSNTB3# pin for capabilities or present detection.
BIFO# BIF1# BIF2#	B7 B8 B9	Output	Bifurcation [0:2]# pins allow the baseboard to force configure the OCP NIC 3.0 card bifurcation.
			For baseboards, the BIF[0:2]# these pins shall be driven from the baseboard I/O hub on the rising edge of AUX_PWR_EN. This allows the baseboard to force the OCP NIC 3.0 card bifurcation. The baseboard may optionally pull the BIF[0:2]# signals to AUX_PWR_EN or to ground per the definitions described in Section 3.5 if no dynamic bifurcation configuration is

required. The BIF[0:2]# pins shall be low until AUX_PWR_EN is asserted.

For baseboards that allow dynamic bifurcation, the BIF[0:2] pins are driven low prior to AUX_PWR_EN. The state of the BIF[0:2] pins are driven with the rising edge of AUX_PWR_EN when bifurcation is requested. Refer to Figure 76 for an example configuration.

For baseboards with static bifurcation, the BIF pins that are intended to be a logical '1' shall be connected to a pull up to AUX_PWR_EN. BIF pins that are a logical '0' may be directly tied to ground. Refer to Figure 77 for an example configuration.

For OCP NIC 3.0 cards, these signals shall connect to the endpoint bifurcation pins if it is supported. The BIF[0:2]# signals shall be left as no connects if end point bifurcation is not supported. The value of the BIF[2:0]# pins are latched by the OCP NIC 3.0 card upon entering the AUX power mode state (when AUX PWR EN=1 and NIC PWR GOOD=1).

Note: the required combinatorial logic output for endpoint bifurcation is dependent on the specific silicon and is not defined in this specification.

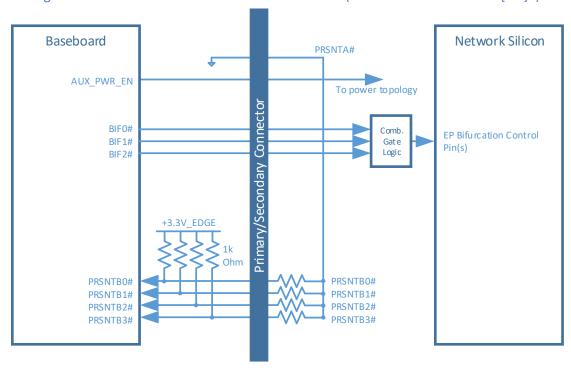
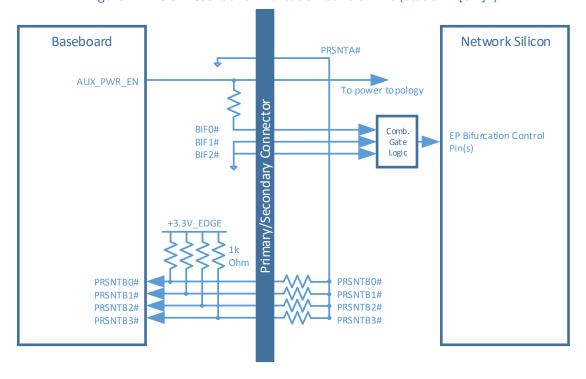


Figure 76: PCIe Present and Bifurcation Control Pins (Baseboard Controlled BIF[0:2]#)





3.4.3 SMBus Interface Pins

This section provides the pin assignments for the SMBus interface signals. The AC/DC specifications are defined in the SMBus 2.0 and I^2C bus specifications. An example connection diagram is shown in Figure 78.

Table 23: Pin Descriptions – SMBus

Signal Name	Pin #	Baseboard Direction	Signal Description
SMCLK	A7	Output, OD	SMBus clock. Open drain, pulled up to +3.3V_EDGE on the baseboard.
			For baseboards, the SMCLK from the platform SMBus master shall be connected to the connector.
			For OCP NIC 3.0 cards, the SMCLK from the endpoint silicon shall be connected to the card edge gold fingers.
SMDAT	A8	Input / Output, OD	SMBus Data. Open drain, pulled up to +3.3V_EDGE on the baseboard.
			For baseboards, the SMDAT from the platform SMBus master shall be connected to the connector.
			For OCP NIC 3.0 cards, the SMDAT from the endpoint silicon shall be connected to the card edge gold fingers.
SMRST#	A9	Output, OD	SMBus reset. Open drain.
			For baseboards, this pin shall be pulled up to +3.3V_EDGE. The SMRST pin may be used to reset optional downstream SMBus devices (such as temperature sensors). The SMRST# implementation shall be mandatory for baseboard implementations.
			For OCP NIC 3.0 cards, SMRST# is optional and is dependent on the OCP NIC 3.0 card implementation. If used, the SMRST# is on the +3.3V_EDGE power domain. Isolation logic may be required if the target
			device(s) exist on a different power domain to prevent a leakage path. The SMRST# signal shall be left as a no connect if it is not used on the OCP NIC 3.0 card.

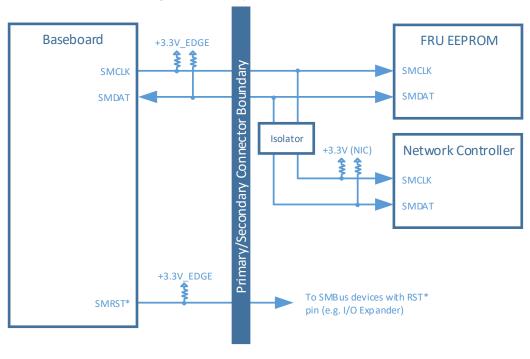


Figure 78: Example SMBus Connections

3.4.4 NC-SI over RBT Interface Pins

This section provides the pin assignments for the NC-SI over RBT interface signals on the Primary Connector OCP bay. The AC/DC specifications for NC-SI over RBT are defined in the DMTF DSP0222 NC-SI specification. Example connection diagrams are shown in Figure 79 and Figure 80.

Note: The RBT pins must provide the ability to be isolated on the baseboard side when AUX_PWR_EN=0 or when (AUX_PWR_EN=1 and NIC_PWR_GOOD=0). The RBT pins shall remain isolated until the power state machine has transitioned to AUX power mode or to Main Power Mode along with a valid indication of NIC_PWR_GOOD. This prevents a leakage path through unpowered silicon. The RBT REF_CLK must also be disabled until AUX_PWR_EN=1 and NIC_PWR_GOOD=1. Example buffering implementations are shown in Figure 79 and Figure 80. The isolator shall be controlled on the baseboard with a signal called RBT_ISOLATE#.

Signal Name	Pin#	Baseboard Direction	Signal Description
RBT_REF_CLK	OCP_A14	Output	Reference clock input. Synchronous clock reference for receive, transmit and control interface. The clock shall have a typical frequency of 50MHz. For baseboards, this pin shall be connected between the baseboard NC-SI over RBT PHY and the Primary Connector OCP bay. This signal requires a 100 kOhm pull down resistor on the baseboard. If the

Table 24: Pin Descriptions – NC-SI over RBT

			baseboard does not support NC-SI over RBT, then this signal shall be terminated to ground through a 100 kOhm pull down resistor. The RBT_REF_CLK shall not be driven until the card has transitioned into AUX Power Mode.
			For OCP NIC 3.0 cards, this pin shall be connected between the card gold finger and the endpoint silicon. This pin shall be left as a no connect if NC-SI over RBT is not supported.
RBT_CRS_DV	OCP_B14	Input	Carrier sense/receive data valid. This signal is used to indicate to the baseboard that the carrier sense/receive data is valid.
			For baseboards, this pin shall be connected between the baseboard NC-SI over RBT PHY and the connector. This signal requires a 100 kOhm pull down resistor on the baseboard. If the baseboard does not support NC-SI over RBT, then this signal shall be terminated to ground through a 100 kOhm pull down resistor.
			For OCP NIC 3.0 cards, this pin shall be connected between the card gold finger and the endpoint silicon. This pin shall be left as a no connect if NC-SI over RBT is not supported.
RBT_RXD0 RBT_RXD1	OCP_B9 OCP_B8	Input	Receive data. Data signals from the network controller to the BMC.
			For baseboards, this pin shall be connected between the baseboard NC-SI over RBT PHY and the connector. This signal requires a 100 kOhm pull down resistor to GND on the baseboard. If the baseboard does not support NC-SI over RBT, then this signal shall be terminated to GND through a 100 kOhm pull down.
			For OCP NIC 3.0 cards, this pin shall be connected between the card gold fingers and the RBT_RXD[0:1] pins on endpoint silicon. This pin shall be left as a no connect if NC-SI over RBT is not supported.
RBT_TX_EN	OCP_A7	Output	Transmit enable.
			For baseboards, this pin shall be connected between the baseboard NC-SI over RBT PHY and the connector. This signal requires a 100 kOhm pull down resistor to ground on the baseboard. If the baseboard does not support NC-SI over RBT, then

			this signal shall be terminated to ground through a 100 kOhm pull down.
			·
			For OCP NIC 3.0 cards, this pin shall be connected between the card gold finger and the endpoint silicon. This pin shall be left as a no connect if NC-SI over RBT is not supported.
RBT_TXD0 RBT_TXD1	OCP_A9 OCP_A8	Output	Transmit data. Data signals from the BMC to the network controller.
			For baseboards, this pin shall be connected between the baseboard NC-SI over RBT PHY and the connector. This signal requires a 100 kOhm pull down resistor to GND on the baseboard. If the baseboard does not support NC-SI over RBT, then this signal shall be terminated to GND through a 100 kOhm pull down.
			For OCP NIC 3.0 cards, this pin shall be connected between the card gold fingers and the RBT_TXD[0:1] pins on the endpoint silicon. This pin shall be left as a no connect if NC-SI over RBT is not supported.
RBT_ARB_OUT	OCP_A5	Output	NC-SI hardware arbitration output.
			If the baseboard does not support NC-SI over RBT or implements only one OCP NIC 3.0 interface, this signal shall be directly connected to the RBT_ARB_IN pin to complete the hardware arbitration ring on the OCP NIC 3.0 card. If the baseboard supports multiple OCP NIC 3.0 cards connected to the same RBT interface, it shall implement logic that connects the RBT_ARB_OUT pin of the first populated OCP NIC 3.0 card to its RBT_ARB_IN pin if it is the only card present or to the RBT_ARB_IN pin of the next populated card and so on sequentially for all cards on the specified RBT bus to ensure the arbitration ring is complete. A two OCP NIC 3.0 card example using an analog mux is shown in Figure 80.
			For OCP NIC 3.0 cards that support hardware arbitration, this pin shall be connected between the card gold finger and the RBT_ARB_IN pin on the endpoint silicon. If the card implements two controllers, both must be connected internally to complete the ring, see Figure 80. If hardware arbitration is not supported, then this pin shall be directly connected to the card edge RBT_ARB_IN pin.

			This allows the ha	ardware arbitratio	n signals to pass
				i-Primary Connect	•
RBT_ARB_IN	OCP_A4	Input	NC-SI hardware a	•	
			implements only signal shall be dir RBT_ARB_OUT pi arbitration ring o baseboard suppo connected to the implement logic to f the first popula RBT_ARB_OUT pi the RBT_ARB_OU and so on sequen RBT bus to ensure	•	nterface, this the hardware card. If the IIC 3.0 cards ce, it shall RBT_ARB_IN pin card to its ard present or to copulated card on the specified
			arbitration, this p card gold finger a endpoint silicon. controllers, both complete the ring arbitration is not directly connecte pin. This allows the	rards that support in shall be connected the RBT_ARB_0 of the card implements be connected, see Figure 80. If supported, then to the card edge he hardware arbitrimulti-Primary Cor	ted between the OUT pin on the nents two d internally to hardware his pin shall be RBT_ARB_OUT ration signals to
SLOT_ID0 SLOT_ID1	OCP_B7 OCP_A6	Output	Package ID. This p EEPROM address For baseboards, t physically tied to	pins shall be used bin is also used in s	setting the FRU sins shall be EDGE. The
			SLOT[1:0] values mapping:	are based on the f	ollowing
			Physical Slot	SLOT_ID1	SLOT_ID0
			(Decimal)	OCP_A6	OCP_B7
			0	0	0
			1	0	1
			2	1	0
		1	1	1	

	3	1	1
--	---	---	---

For OCP NIC 3.0 cards, SLOT_ID0 shall be connected to the endpoint device GPIO associated with Package ID[0]. SLOT_ID1 shall be associated with Package ID[1]. Refer to Section 4.8.1 and the device datasheet for details.

For OCP NIC 3.0 cards with multiple endpoint devices, Package ID[2] shall be used to identify a second physical RBT capable controller on the same physical card.

For Package ID addressing, the SLOT_ID[1:0] pins shall be buffered on NIC side with a FET switch (or a similar implementation) to prevent a leakage path when the OCP NIC 3.0 card is in ID mode. The SLOT_ID[1:0] buffers shall isolate the signals to the network silicon until an "Aux Power Good" is generated locally from the NIC. This indication shall be generated from an on-board voltage monitor or similar logic. OCP NIC 3.0 designers may omit isolation logic for the Package ID addressing if the target silicon properly isolates the signals when it is unpowered.

For FRU EEPROM addressing, the SLOT_IDO pin shall be directly connected to the EEPROM A1 address pin; SLOT_ID1 shall be connected to the EEPROM A2 address pin. No isolation shall be used for the FRU EEPROM connections.

For endpoint devices without NC-SI over RBT support, these pins shall only be connected to the FRU EEPROM as previously described.

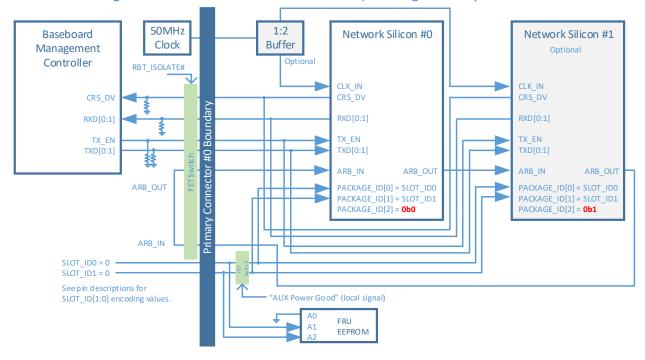


Figure 79: NC-SI over RBT Connection Example – Single Primary Connector

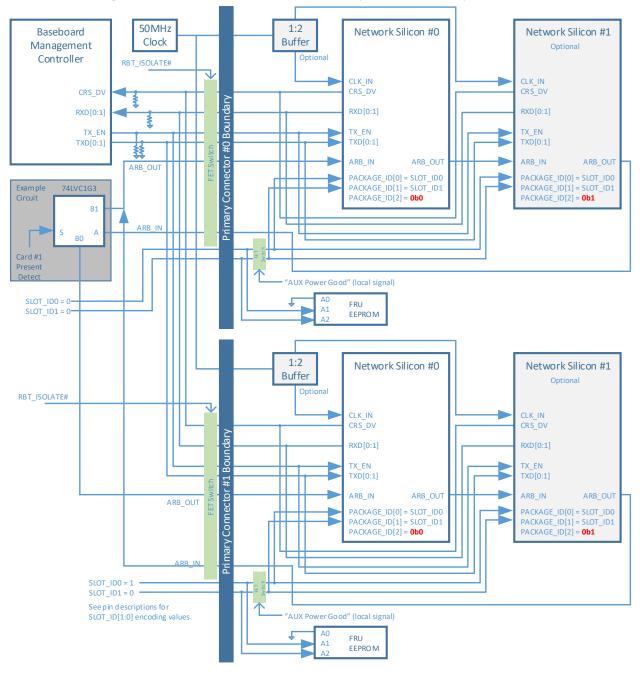


Figure 80: NC-SI over RBT Connection Example – Dual Primary Connectors

Note 1: For baseboard designs with a single Primary Connector, connect ARB_IN to ARB_OUT to complete the NC-SI hardware arbitration ring. For designs with multiple Primary Connectors, connect ARB_IN and ARB_OUT to an analog mux to complete the NC-SI arbitration ring based on the number of cards installed in the system. An example dual Primary Connector implementation is shown in Figure 80.

Note 2: For baseboard implementations having two or more RBT busses, the baseboard hardware arbitration rings shall remain within their respective bus and shall not cross RBT bus domains.

Note 3: The logical implementation of the hardware arbitration ring shall maintain the arbitration ring integrity when there exists one or more cards that are plugged in, but are powered off (e.g. in ID Mode).

Note 4: For OCP NIC 3.0 cards with two discrete endpoint silicon, the Package ID[2] bit shall be statically set based on the silicon instance. For example, the figure above shows Network Silicon #0 and Network Silicon #1. Network Silicon #0 has Package ID[2] = 0b0, Network Silicon #1 has Package ID[2] = 0b1.

Note 5: Designs that implement a clock fan out buffer will affect the RBT timing budget. Careful analysis of the timing budget is required. Refer to Section 5.1 for RBT signal integrity and timing budget considerations.

3.4.5 Scan Chain Pins

This section provides the pin assignments for the Scan Chain interface signals on the Primary Connector OCP Bay. The scan chain is a point-to-point bus on a per OCP slot basis. The scan chain consists of two unidirectional busses, a common clock and a common load signal. The DATA_OUT signal serially shifts control signals from the baseboard to the OCP NIC 3.0 card. The DATA_IN signal serially shifts bits from the OCP NIC 3.0 card to the baseboard. The DATA_OUT and DATA_IN chains are independent of each other. The scan chain CLK is driven from the baseboard. The LD pin, when asserted by the baseboard, allows loading of the data on to the shift registers. An example timing diagram is shown in Figure 81. An example connection diagram is shown in Figure 82.

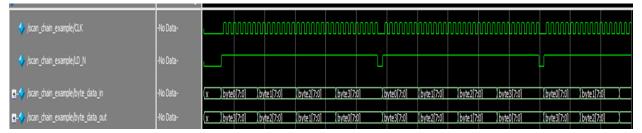
Note: The DATA_OUT chain is provisioned, but is not used on OCP NIC 3.0 cards for this revision of the specification.

Signal Name	Pin #	Baseboard	Signal Description
		Direction	
CLK	OCP_B6	Output	Scan clock. The CLK is an output pin from the
			baseboard to the OCP NIC 3.0 card. The CLK may run
			up to 12.5MHz.
			For baseboard implementations, the CLK pin shall be connected to the Primary Connector. The CLK pin shall be tied directly to GND if the scan chain is not used.
			For NIC implementations, the CLK pin shall be connected to Shift Registers 0 & 1, and optionally connected to Shift Registers 2 & 3 (if implemented) as defined in the text and Figure 82, below. The CLK pin shall be pulled up to +3.3V_EDGE through a 1 kOhm resistor.
DATA_OUT	OCP_B5	Output	Scan data output from the baseboard to the OCP NIC 3.0 card. This bit stream is used to shift configuration data out to the NIC.

Table 25: Pin Descriptions – Scan Chain

			For baseboard implementations, the DATA_OUT pin shall be connected to the Primary Connector. The DATA_OUT pin shall be pulled down to GND through a 1 kOhm resistor if the scan chain is not used. For NIC implementations, the DATA_OUT pin shall be pulled down to GND on the OCP NIC 3.0 card through a 10 kOhm resistor.
DATA_IN	OCP_B4	Input	Scan data input to the baseboard. This bit stream is used to shift out NIC status bits to the baseboard. For baseboard implementations, the DATA_IN pin shall be pulled up to +3.3V_EDGE through a 10 kOhm resistor to prevent the input signal from floating if a card is not installed. This pin may be left as a no connect if the scan chain is not used. For NIC implementations, the DATA_IN scan chain is required. The DATA_IN pin shall be connected to Shift Register 0, as defined in the text and Figure 82.
LD#	OCP_B3	Output	Scan shift register load. Used to latch configuration data on the OCP NIC 3.0 card. For baseboard implementations, the LD# pin shall be pulled up to +3.3V_EDGE through a 1 kOhm resistor if the scan chain is not used to prevent the OCP NIC 3.0 card from erroneous data latching. For NIC implementations, the LD# pin implementation is required. The LD# pin shall be connected to Shift Registers 0 & 1, and optionally connected to Shift Registers 2 & 3 (if implemented) as defined in the text and Figure 82. The LD# pin shall be pulled up to +3.3V_EDGE through a 10 kOhm resistor.

Figure 81: Example Scan Chain Timing Diagram



The scan chain provides sideband status indication between the OCP NIC 3.0 card and the baseboard. The scan chain bit definition is defined in the two tables below. The scan chain data stream is 32-bits in length for both the DATA_OUT and the DATA_IN streams. The scan chain implementation is optional on

the host, but its implementation is mandatory per Table 26 and Table 27 on all OCP NIC 3.0 cards. The scan chain components operates on the +3.3V_EDGE power domain.

The DATA_OUT bus is an output from the host. The DATA_OUT bus provides initial configuration options to the OCP NIC 3.0 card. At the time of this writing, the DATA_OUT bus is not used. All baseboard systems that implement the Scan Chain shall connect DATA_OUT between the platform and the Primary Connector for subsequent revisions of this specification. The DATA_OUT data stream shall shift out all 0's prior to AUX_PWR_EN assertion to prevent leakage paths into unpowered silicon.

Byte.bit	DATA_OUT Field	Default	Description
	Name	Value	
0.[07]	RSVD	0h00	Reserved. Byte 0 value is 0h00.
1.[07]	RSVD	0h00	Reserved. Byte 1 value is 0h00.
2.[07]	RSVD	0h00	Reserved. Byte 2 value is 0h00.
3.[07]	RSVD	0h00	Reserved. Byte 3 value is 0h00.

Table 26: Pin Descriptions – Scan Chain DATA OUT Bit Definition

The DATA_IN bus is an input to the host and provides NIC status indication. The default implementation is completed with two 8-bit 74LV165 parallel in to serial out shift registers in a cascaded implementation. Up to four shift registers may be implemented to provide additional NIC status indication to the host platform. Alternatively, an OCP NIC 3.0 card vendor may choose to implement this chain using an active device (such as a microcontroller or CPLD). For active device implementations, there is an associated device start-up time. Refer to Section 3.11 for details on the +3.3V_EDGE stable to the first data valid read in ID Mode.

DATA_IN shift register 0 shall be mandatory for scan chain implementations for the card present, WAKE_N and thermal threshold features. DATA_IN shift registers 1, 2 & 3 are optional depending on the line side I/O and LED fields being reported to the host. Dual port LED applications require shift register 1. Quad port LED applications require shift registers 1 & 2. Octal port applications require shift registers 1, 2 & 3.

The host should read the DATA_IN bus multiple times to qualify the incoming data stream. The number of data qualification reads is dependent on the baseboard implementation.

On the OCP NIC 3.0 card, a 1 kOhm pull up resistor shall be connected to the SER input of the last DATA_IN shift register. Doing so ensures the default bit value of 0b1 for implementations using less than four shift registers.

Byte.bit	DATA_IN Field Name	Default Value	Description
0.0	PRSNTB[0]#	0bX	PRSNTB[3:0]# bits shall reflect the same state as
0.1	PRSNTB[1]#	0bX	the signals on the Primary Connector. Connect
0.2	PRSNTB[2]#	0bX	these scan chain signals directly to the OCP NIC
0.3	PRSNTB[3]#	0bX	3.0 card edge PRSNTB[3:0]# pins. The OCP NIC 3.0 implementer may alternatively choose to locally

Table 27: Pin Descriptions – Scan Chain DATA_IN Bit Definition

			populate pull up and pull down resistors to these scan chain inputs as long as the PRSNTB[3:0]# values are the same on the scan chain and card edge.
0.4	WAKE_N	0bX	PCIe WAKE_N signal shall reflect the same state as the signal on the Primary Connector.
0.5	TEMP_WARN_N	0b1	Temperature monitoring pin from the on-card thermal solution. This pin shall be asserted low when the network silicon or transceiver module temperature sensors exceed the temperature warning threshold.
0.6	TEMP_CRIT_N	0b1	Temperature monitoring pin from the on-card thermal solution. This pin shall be asserted low when the network silicon or transceiver module temperature sensors exceed the temperature critical threshold.
0.7	FAN_ON_AUX	0b0	When high, FAN_ON_AUX shall request the system fan to be enabled for extra cooling in the S5 state.
			The FAN_ON_AUX bit shall be asserted when the network silicon or transceiver module cooling requested threshold has been exceeded. The temperature at which this assertion occurs is device dependent.
			The FAN_ON_AUX bit shall deassert when the network silicon or transceiver module temperature is at least 5°C below the assertion threshold.
			0b0 – The system fan is not requested/off in S5. 0b1 – The system fan is requested/on in S5.
1.0	LINK_SPDA_P0#	0b1	Port 0 link and speed A indication (max speed). Active low.
			0b0 – Link LED is illuminated on the host platform. 0b1 – Link LED is not illuminated on the host platform.
			Steady = link is detected on the port and is at the maximum speed.Off = the physical link is down, the link is not operating at the maximum speed or the port is disabled.

			Note: The link and speed A LED may also be
1.1	LINK_SPDB_P0#	0b1	blinked for use as port identification. Port 0 link and speed B indication (not max speed). Active low.
			0b0 – Link LED is illuminated on the host. 0b1 – Link LED is not illuminated on the host.
			 Steady = link is detected on the port and is not at the maximum speed. Off = the physical link is down, the link is operating at the maximum speed, or the port is disabled.
			Note: The link and speed B LED may also be blinked for use as port identification.
1.2	ACT_P0#	0b1	Port 0 activity indication. Active low.
			0b0 – ACT LED is illuminated on the host. 0b1 – ACT LED is not illuminated on the host.
			Steady = no activity is detected on the port. Blinking = activity is detected on the port. The
			blink rate should blink low for 50-500 ms during activity periods with a 50% duty cycle.
1.3	LINK SPDA P1#	0b1	Off = the physical link is down or disabled. Port 1 link and speed A indication (max speed).
1.5	LINK_3I DA_I I#	001	Active low.
1.4	LINK_SPDB_P1#	0b1	Port 1 link and speed B indication (not max speed). Active low.
1.5	ACT_P1#	0b1	Port 1 activity indication. Active low.
1.6	LINK_SPDA_P2#	0b1	Port 2 link and speed A indication (max speed). Active low.
1.7	LINK_SPDB_P2#	0b1	Port 2 link and speed B indication (not max speed). Active low.
2.0	ACT_P2#	0b1	Port 2 activity indication. Active low.
2.1	LINK_SPDA_P3#	0b1	Port 3 link and speed A indication (max speed). Active low.
2.2	LINK_SPDB_P3#	0b1	Port 3 link and speed B indication (not max speed). Active low.
2.3	ACT_P3#	0b1	Port 3 activity indication. Active low.
2.4	LINK_SPDA_P4#	0b1	Port 4 link and speed A indication (max speed). Active low.
2.5	LINK_SPDB_P4#	0b1	Port 4 link and speed B indication (not max speed). Active low.
2.6	ACT_P4#	0b1	Port 4 activity indication. Active low.

2.7	LINK_SPDA_P5#	0b1	Port 5 link and speed A indication (max speed). Active low.
3.0	LINK_SPDB_P5#	0b1	Port 5 link and speed B indication (not max speed). Active low.
3.1	ACT_P5#	0b1	Port 5 activity indication. Active low.
3.2	LINK_SPDA_P6#	0b1	Port 6 link and speed A indication (max speed). Active low.
3.3	LINK_SPDB_P6#	0b1	Port 6 link and speed B indication (not max speed). Active low.
3.4	ACT_P6#	0b1	Port 6 activity indication. Active low.
3.5	LINK_SPDA_P7#	0b1	Port 7 link and speed A indication (max speed). Active low.
3.6	LINK_SPDB_P7#	0b1	Port 7 link and speed B indication (not max speed). Active low.
3.7	ACT_P7#	0b1	Port 7 activity indication. Active low.

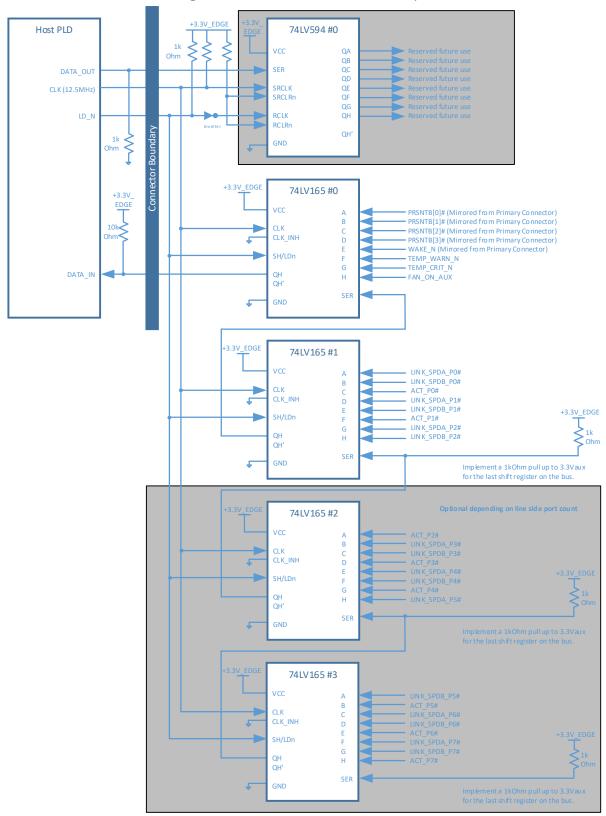


Figure 82: Scan Chain Connection Example

3.4.6 Power Supply Pins

This section provides the pin assignments for the power supply interface signals. The AC/DC specifications are defined in the PCIe CEM Specification, Rev 4.0 and amended in Section 3.9. An example connection diagram is shown in Figure 83.

Table 28: Pin Descriptions – Power

Signal Name	Pin #	Baseboard Direction	Signal Description
GND	Various	GND	Ground return; a total of 46 ground pins are on the main 140-pin connector area. Additionally, a total of 4 ground pins are in the OCP bay area. Refer to Section 3.3 for details.
+12V_EDGE	B1, B2, B3, B4, B5, B6	Power	+12 V main or +12 V aux power; total of 6 pins per connector. The +12V_EDGE pins shall be rated to 1.1 A per pin with a maximum derated power delivery of 80 W.
			The +12V_EDGE power pins shall be within the rail tolerances as defined in Section 3.9 when the PWR_EN pin is driven high by the baseboard.
			The OCP NIC 3.0 card may optionally implement a fuse on +12V_EDGE to protect against electrical faults.
+3.3V_EDGE	B11	Power	+3.3 V main or +3.3 V aux power; total of 1 pin per connector. The +3.3V_EDGE pin shall be rated to 1.1 A for a maximum derated power delivery of 3.63 W.
			The +3.3V_EDGE power pin shall be within the rail tolerances as defined in Section 3.9 when the PWR_EN pin is driven high by the baseboard.
			The OCP NIC 3.0 card may optionally implement a fuse on +3.3V_EDGE to protect against electrical faults.
AUX_PWR_EN	B12	Output	Aux Power enable. Active high.
			This pin indicates that the +12V_EDGE and +3.3V_EDGE power is from the baseboard aux power rails.
			This signal shall be pulled down to GND through a 10 kOhm resistor on the baseboard. This ensures the OCP NIC 3.0 card power is disabled until instructed to turn on by the baseboard.
			When low, the OCP NIC 3.0 card supplies running on aux power shall be disabled.

		When high, the OCP NIC 3.0 card supplies running on aux power shall be enabled.
		For OCP NIC 3.0 cards that do not use a separate "main power" domain circuitry (or can operate in a single power domain), the AUX_PWR_EN signal serves as the primary method to enable all the card power supplies.
		It is expected that a baseboard will not drive signals other than SMBus and the Scan Chain to the OCP NIC 3.0 card when this signal is low.
OCP_B2	Output	Main Power Enable. Active high.
		This pin indicates that the +12_EDGE and +3.3V_EDGE power is from the baseboard main power rails. Additionally, this signal notifies the OCP NIC 3.0 card to enable any power supplies that run only in the Main Power Mode.
		The MAIN_PWR_EN pin is driven by the baseboard. This pin must be implemented on baseboard systems, but may optionally be used by the OCP NIC 3.0 card depending on the end point silicon implementation. Depending on the silicon vendor, end point devices may be able to operate in a single power domain, or may require separate power domains to function.
		For baseboard implementations, this signal shall be pulled down to GND through a 10 kOhm resistor on the baseboard. This ensures the OCP NIC 3.0 card power is disabled until instructed to turn on by the baseboard.
		When low, the OCP NIC 3.0 card supplies running on main power shall be disabled.
		When high, the OCP NIC 3.0 card supplies running on main power shall be enabled.
		This pin may be left as a no connect for OCP NIC 3.0 cards that do not use a separate "main power" domain SVR circuitry.
OCP_B1	Input	NIC Power Good. Active high. This signal is driven by the OCP NIC 3.0 card.
		The NIC_PWR_GOOD signal is used to indicate when the aux power domain, and main power domain rails are within operational tolerances.

The truth table shows the expected NIC_PWR_GOOD state for power up sequencing depending on the values of AUX_PWR_EN and MAIN_PWR_EN.

AUX_PWR _EN	MAIN_PWR _EN	NIC_PWR_GOOD Nominal Steady State Value
0	0	0
1	0	1
0	1	Invalid
1	1	1

Refer to the power up and power down sequencing diagrams (Figure 100 and Figure 101) for timing details.

Where appropriate, designs that have a separate Main Power domain should also connect to the main power good indication to the NIC_PWR_GOOD signal via a FET to isolate the domains. Refer to Figure 83 for an example implementation.

When low, this signal shall indicate that the OCP NIC 3.0 card power supplies are not yet within nominal tolerances or are in a fault condition after the power ramp times (T_{APL} and T_{MPL}) have expired.

For baseboards, this pin may be connected to the platform I/O hub as a NIC power health status indication. This signal shall be pulled down to ground with a 100 kOhm resistor on the baseboard to prevent a false power good indication if no OCP NIC 3.0 card is present.

For OCP NIC 3.0 cards this signal shall indicate the OCP NIC 3.0 card power is "good" for the given power mode. This signal may be implemented by combinatorial logic, a cascaded power good tree or a discrete power good monitor output.

When high, this signal should be treated as V_{REF} is available for NC-SI communications. Refer to timing parameter T4 in the DMTF DSP0222 specification for details.

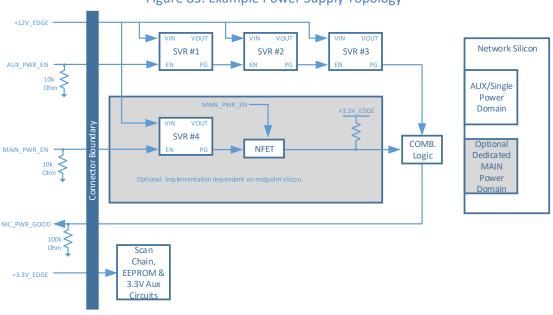


Figure 83: Example Power Supply Topology

3.4.7 USB 2.0 (A68/A69) – Primary Connector Only

This section provides the pin assignments for the USB 2.0 interface signals. USB 2.0 is only defined for operation on the Primary Connector. USB 2.0 may be used for applications with end point silicon that requires a USB connection to the baseboard. Implementations may also allow for a USB-Serial or USB-JTAG translator for serial or JTAG applications. If multiple USB devices are required, an optional USB hub may be implemented on the OCP NIC 3.0 card. Downstream device discovery is completed as part of the bus enumeration per the USB 2.0 specification. A basic example connection diagram is shown in Figure 84. An example depicting USB-Serial and USB-JTAG connectivity with an USB hub is shown in Figure 85.

Signal Name	Pin #	Baseboard	Signal Description
		Direction	
USB_DATn	A68	Bi-	USB 2.0 Differential Pair – Primary Connector Only.
USB_DATp	A69	directional	
			A baseboard implementation shall provide a USB
			connection to the OCP NIC 3.0 primary connector.
			NIC implementations that require USB shall connect the bus to the end point silicon. This pin shall be left as a no connect if it is not used on the OCP NIC 3.0 card.
			The USB pins shall be directly connected between the end point silicon or USB device and the card gold fingers.

Table 29: Pin Descriptions – USB 2.0 – Primary Connector only

The USB interface shall be based on a V_{BUS} = 3.3 V. Both the baseboard and NIC device shall be capable of driving signals using 3.3 V logic. The OCP NIC 3.0 card may implement protection diodes and is up to the adapter vendor for placement.

To prevent leakage paths, a baseboard shall not use USB pull up resistors on the USB_DATp/n lines to indicate the bus data transmission rate. If used, pull up resistors shall only exist on the NIC side.

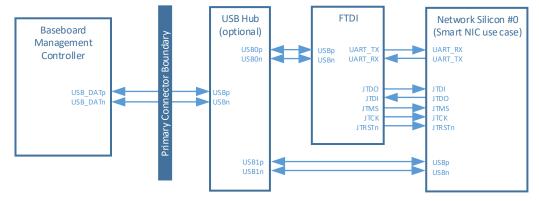
The AUX_PWR_EN signal may be used for downstream USB devices that require a V_{BUS} connection for host detection. Examples of this may include USB-serial converting devices.

Baseboard
Management
Controller

USB_DATP
USB_DATP
USB_DATD

Figure 84: USB 2.0 Connection Example – Basic Connectivity





3.4.8 UART (A68/A69) – Secondary Connector Only

This section provides the pin assignments for the UART interface signals. UART is only defined for operation on the Secondary Connector. The UART pins may be used with end point silicon that require console redirection over the baseboard – such as LFF SmartNICs. An example connection diagram is shown in Figure 86.

Table 30: Pin Descriptions – UART – Secondary Connector Only

Signal Name	Pin #	Baseboard Direction	Signal Description
UART_RX	A68	Input	UART Receive. +3.3 V signaling levels. Secondary Connector Only.
			A baseboard implementations shall provide a UART receive connection from the OCP NIC 3.0 connector. The UART_RX pin shall be pulled up to +3.3 V _{AUX} on the baseboard to prevent erroneous data reception when the OCP NIC 3.0 card is powered off or not present.
			NIC implementations that require a UART shall connect the network silicon UART_RX pin to the UART_TX pin on the OCP NIC 3.0 connector. This pin shall be left as a no connect if it is not used on the OCP NIC 3.0 card.
			The UART_RX pin shall be buffered on the NIC to prevent a leakage path into unpowered silicon when the card is in ID Mode. The buffer may be controlled via a local "Power Good" indicator.
UART_TX	A69	Output	UART Transmit. +3.3 V signaling levels. Secondary Connector Only.
			A baseboard implementation shall provide a UART transmit connection to the OCP NIC 3.0 connector.
			NIC implementations that require a UART shall connect the UART_TX pin from the OCP NIC 3.0 connector to the target silicon UART_RX pin. This pin shall be left as a no connect if it is not used on the OCP NIC 3.0 card.
			The UART_TX pin shall be buffered on the NIC to prevent a leakage path into unpowered silicon when the card is in ID Mode. The buffer may be controlled via a local "Power Good" indicator.

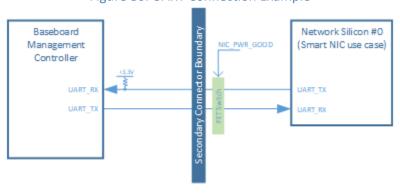


Figure 86: UART Connection Example

3.4.9 RFU[1:4] Pins

This section provides the pin assignments for the RFU[1:4] interface signals.

Table 31: Pin Descriptions – RFU[1:4]

Signal Name (Primary /	Pin#	Baseboard Direction	Signal Description
Secondary)			
RFU1 / RFU3, N/C	B68	Input /	Reserved future use pins. These pins shall be left as
RFU2 / RFU4, N/C	B69	Output	no connect. These pins may also be used as a differential pair for future implementations.
			In this release of the OCP NIC 3.0 specification, the RFU[1:2] pins are defined on the Primary Connector. RFU[3:4] are defined on the Secondary Connector. A total of two reserved pins are available for the SFF; a
			total of four reserved pins are available the LFF.

3.5 PCIe Bifurcation Mechanism

OCP NIC 3.0 baseboards and OCP NIC 3.0 cards support multiple bifurcation combinations. Single socket baseboards with a single or multiple root ports, as well as a multi-socket baseboards with a single or multiple root ports are supported. The bifurcation mechanism also supports OCP NIC 3.0 cards with a single or multiple end points. These features are accomplished via I/O pins on the Primary and Secondary Connector:

- PRSNTA#, PRSNTB[3:0]#. The PRSNTA# pin shall connect to the PRSNTB# pins as a hard coded value on the OCP NIC 3.0 card. The encoding of the PRSNTB[3:0]# pins allows the baseboard to determine the PCIe Links available on the OCP NIC 3.0 card. PRSNTA# and PRSNTB[3:0]# pins exist for each connector. For the SFF, a baseboard shall read the pins associated with the Primary Connector to determine the card type. For the LFF, a baseboard shall read the pins associated with both the Primary and Secondary Connector to determine the card type.
- BIF[3:0]#. The BIF# pin states shall be controlled by the baseboard to allow the baseboard to override the default end point bifurcation for silicon that support bifurcation. Additional combinatorial logic is required and is specific to the card silicon. The combinatorial logic is not covered in this specification. The BIF[3:0]# pins may optionally be hardcoded for baseboards that do not require a dynamic bifurcation override. BIF[2:0]# pins exist on each connector.

A high level bifurcation connection diagram is shown in Figure 76.

3.5.1 PCIe OCP NIC 3.0 Card to Baseboard Bifurcation Configuration (PRSNTA#, PRSNTB[3:0]#)

The OCP NIC 3.0 card to baseboard configuration mechanism consists of four dual use pins (PRSNTB[3:0]#) on the OCP NIC 3.0 card and a grounded PRSNTA# pin on the baseboard per connector. For the SFF, a baseboard shall read the pins associated with the Primary Connector to determine the card type. For the LFF, a baseboard shall read the pins associated with both the Primary and Secondary Connector to determine the card type. These pins provide card presence detection as well as mechanism to notify the baseboard of the pre-defined PCIe lane width capabilities. The PRSNTB[3:0]# pins are pulled up to +3.3V_EDGE on the baseboard and are active low signals. A state of 0b1111 indicates that no card is present in the connector(s). Depending on the capabilities of the OCP NIC 3.0 card, a selection of PRSNTB[3:0]# signals may be strapped to the PRSNTA# signal and is pulled low by the baseboard. The encoding of the PRSTNB[3:0]# bits is shown in Table 32 for x32, x16 and x8 PCIe cards. While SFF and LFF cards are allowed in an LFF compliant slot, the condition where the Primary Connector PRSNTB[3:0]# equals 0b1111 and the Secondary Connector PRSNTB[3:0]# pins is not equal to 0b1111 is invalid.

3.5.2 PCIe Baseboard to OCP NIC 3.0 Card Bifurcation Configuration (BIF[2:0]#)

Three signals (BIF[2:0]#) are driven by the baseboard to notify requested bifurcation on the OCP NIC 3.0 card silicon. This allows the baseboard to set the lane configuration on the OCP NIC 3.0 card that supports multiple bifurcation options. BIF[2:0]# pins exist on each connector. For the SFF, the BIF[2:0]# pins associated with the Primary Connector are used. For the LFF, the BIF[2:0]# pins associated with both the Primary and Secondary Connector are used to determine the requested bifurcation.

For example, a baseboard that has four separate hosts that support a 4 x4 connection, should appropriately drive the BIF[2:0]# pins per Table 32 and indicate to the SFF OCP NIC 3.0 card silicon to setup a 4 x4 configuration.

As previously noted, the BIF[2:0]# signals require additional combinatorial logic to decode the BIF[2:0]# value and appropriately apply it to the end-point silicon. The combinatorial logic is not covered in the specification as its implementation is specific to the vendor silicon used.

3.5.3 PCle Bifurcation Decoder

The combination of the PRSNTB[3:0]# and BIF[2:0]# pins deterministically sets the PCIe lane width for a given combination of baseboard and OCP NIC 3.0 cards. Table 32 shows the resulting number of PCIe links and its width for known combinations of baseboards and OCP NIC 3.0 cards. A copy of this bifurcation decoder is also available on the OCP NIC 3.0 Wiki site. Please refer to: https://www.opencompute.org/wiki/Server/Mezz.

Note 1: The baseboard must disable PCIe lanes during the initialization phase if the number of detected PCIe links are greater than what is supported on the baseboard to prevent a nondeterministic solution. For example, if the baseboard only supports a 1 x16 connection, and the OCP NIC 3.0 card only supports a 2 x8 connection, the baseboard must disable PCIe lanes 8-15 to prevent any potential LTSSM issues during the discovery phase.

Note 2: Due to separate PCIe REFCLKs and power state timing differences in multi-host configurations, Table 32 shows the expected resulting links for a given baseboard and OCP NIC 3.0 card combination.

Table 32: PCIe Bifurcation Decoder for x32, x16, x8, x4, x2 and x1 Card Widths

Cockets Cock							Single Host			Dual Host	Dual Host	Quad Host	Quad Host
			Host>		1Host	1Host	1Host	1Host	1Host	2 Host	2 Hosts	4 Hosts	4 Hosts
			SFF: Host CPU Sookets>		1Upstream Sooket	2 Upstream Sockets	4 Upstream Sookets	4 Sockets First 8 PCle lanes	This configuration is not applicable for SFF, 32 lanes		2 Upstream Sockets (1 Socket per Host)	4 Upstream Sookets (1 Socket per Host)	(1Sooket per Host)
			SFF: Total PCle Links (1 conne	ector]>	12, or 4 Links	2 Links	4 Links	4 x2 links	is only available in the LFF implementation.		2 Links	4 Links	4.2 links
			0100000			0	0	0		0.11.0	711	100	0
	Network Carr Supported P	d - Cle Configurations	LTT: TOSK UPU SOOKets		Z Upstream Sockets	4 Upstream Dockets (2 sockets per host)	o upstream bookets (NOTE 1)	o Upstream Dockets First 8 PCIe lanes per connector (NOTE 1)	I upstream Sooket	(1 Socket perhost)	4 Upstream Sockets (2 Socket per Host)	(2 Socket per Host)	(2 Socket per Host) First 8 PCle lanes per connector (NOTE 1)
			LFF: Total PCle Links (Across	2 connectors)>	1,2,4 or 8 Links		8 Links	8 x2 links	1Link (No Bifuroation)	1, 2, or 4 Links		8 Links	8 x2 links
			System Link Width Support pe	er Connector>	1x16,1x8,1x4,1x2,1x1 2x8,2x4,2x2,2x1 4x4,4x2,4x1		4×4, 4×2, 4×1	4 x2, 4 x1	1x32 (w/both connectors) 1x16, 1x8, 1x4, 1x2, 1x1	1x16, 1x8, 1x4, 1x2, 1x1 2x8, 2x4, 2x2, 2x1 4x4, 4x2, 4x1	2 x8, 2 x4, 2 x2	4×4,4×2,4×1	4 x2, 4 x1
			Primary Connector BIF[2:0]# ((SFF & LFF)>	00090		00010	06011	0P100	00100		00410	06111
	- 1		_		00000	00001	06010	06011	00000	06100		06110	06111
Mathemes Statistics Statis		ion Modes	PRSNTB(3:0)# (SFF, LFF)	Secondary Connector PRSNTB(3:0)# (LFF only)	_								
11/10 11/1	Not Present	Card Not Present	Ob1111(not used)	Obtfff(not used)	0	0,	*		0	•	•	,	
1.1. 1.1.		a l	9	up!!!!(hotused)	o E	(Socket () only)	(Socket 0 only)	(Socket 0 only)	0 X	081	(Host 0 only)	(Host 0 only)	(Host 0 only)
1. 1. 1. 1. 1. 1. 1. 1.		1x4, 1x2, 1x1	061110	Ob1111 (not used)	1×4	1x4 (Socket 0 only)	1x4 (Socket 0 only)	1x2 (Sooket Donly)	4×L	1,4	1x4 (Host 0 only)	1x4 (Host 0 only)	1x2 (Host 0 only)
1.1. 1.1.		1x2,1x1	061110	Obfiff (not used)	1×2	1 _N 2 (Socket 0 only)	1x2 (Socket 0 only)	1x2 (Socket 0 only)	1×2	1×2	1x2 (Host 0 only)	1 _N 2 (Host 0 only)	1x2 (Host 0 only)
1, 1, 1, 1, 1, 1, 1, 1, 1, 1, 1, 1, 1,		181	061110	0bffff(not used)	181	1×1 (Sooket Donly)	1x1 (Socket 0 only)	1x1 (Socket 0 only)	181	1x1	1x1 (Host 0 only)	1x1 (Host 0 only)	1s1 (Host Donly)
		1x8,1x4,1x2,1x1 B 2x4,2x2,2x1	061101	Ob1111 (not used)	9×L	1x8 (Socket 0 only)	2 x4 (Socket 0 & 1)	2 x2 (Socket 0 & 2 only)	1x8	1×8	1x8 (Host 0 only)	2x4 (Host 0 & 1)	2 x2 (Host 0 & 2 only)
1-80 1-80		2x8,2x4,2x2,2x1 B 4x4,4x2,4x1	061101	Obtiff (not used)	2×8	2.48	4 %4	2 x2 (Socket 0 & 2 only)	1×8°	2×8	2x8 (Host 0 & 1)	4.4	2x2 (Host 0 & 2 only)
100 100			061100	0bffff(not used)	8×	1x8 (Sooket Donly)	2 x4 (Sooket 0 & 1)	4 ×2	8%.	1×8	1x8 (Host 0 only)	2x4 (Host 0 & 1)	4×2
		1x16,1x8,1x4 2x8,2x4,		Ob1111(not used)	1,16	2×8	4×4	4 ×2	1×16	1×16	2 x8 (Host 0 & 1)	4.84	4×2
		10 4x4, 4x2 (First 8 lanes), 4x1		Oktitifootuseed									
44.02 22.02.01.01.01.01.01.01.01.01.01.01.01.01.01.	l	2×4,2×2,2×1 1×4,1×2,1×1		0bTfff(not used)	2×4	1x4 (Socket 0 only)	2×4 (Socket 0 & 1)	2 x2 (Socket 0 & 2 only)	184	1×4	1×4 (Host Donly)	2×4 (Host 0 & 1)	2 x2 (Host 0 & 2 only)
PSP		4 x2 (First 8 lanes), 4 x1 2 x2, 2 x1 1 x2, 1 x1	061001	Obfiff(not used)	2,42	1x2 (Socket 0 only)	2 x2 (Socket 0 & 1)	4×2	1%2	2%1	1x.2 (Host 0 only)	2x2 (Host 0 & 1)	4×2
Table Depart Tabl	HSV	RSVD for future x8 encoding	0b1000 (not used)	Ob1111(not used)									
Page			060111	0bTfff(not used)	1×16	1x8 (Socket 0 only)	1x4 (Socket 0 only)	1x2 (Socket 0 only)	1×16	1x16	1x8 (Host 0 only)	1x4 (Host 0 only)	1x2 (Host 0 only)
Fire Dipside 1			060110	Ob1111 (not used)	2*8	2×8	2x4 (Socket 0 & 2 only)	1x2 (Socket 0 only)	.8×.	2×8	2x8 (Host 0&1)	2 x4 (Host 0 & 2 only)	1x2 (Host 0 & Tonly)
1.16 1.06 1.16		1x16,1x8,1x4,1x2,1x1 xB 2x8,2x4,2x2,2x1	060101	0b1fff(not used)	1×16	2×8	2 x4 (Sooket 0 & 2 only)	1x2 (Socket 0 only)	1×16	1×16	2×8 (Host 0 & 1)	2 x4 (Host 0 & 2 only)	1x2 (Host 0 & Tonly)
444 44.2.4.4.4 DeCOTT		1x16,1x6,1x4 2x8,2x4,2x2,2x1 C 4x4,4x2,4x1	060100	0b1fff(not used)	1x16	2 x8	4×4	2 x2 (Socket 0 & 2 only)	1x16	1x16	2x8 (Host 0& 1)	4 %4	1 _N 2 (Host 0 only)
2xi6 Dipmon 2xi6 Dipmon 2xi6 Dipmon 2xi6 Dipmon 2xi6 Dipmon 1xi6 Sale Sale Sale Sale Sale Sale Sale Sale		4 x4, 4 x2, 4 x1	060011	0b1fff(not used)	4×4	2×4 (EP 0 and 2 only)	4 84	1x2 (Socket 0 only)	184*	2×4	2×4 (EP 0 and 2 only)	4.44	1x2 (Host 0 only)
418 Expense 418 Expens			060111	060111	2×16	2 x8 (Socket 0 & 2 only)	2 x4 (Socket 0 & 4 only)	2 x2 (Sookets 0 & 4)	1x16	2×16	2 x8 (Host 0 & 2)	2x4 (Host 0 & 4)	2x2 (Host 0&4)
2.NE Depice 26 Aug	4 x8 Option		060110	060110	4×8	4×8	4x4 (Sockets 0, 2, 4 & 6)	2x2 (Sookets 0 & 4)	1x8	4×8	4 ×8	4×4 (Host 0, 2, 4 & 6)	2x2 (Host 0&4)
2.NB Device Control Resident And Base And Sacretary Institute Control Resident And Base And Sacretary Institute Control Resident And	2 x16 Option	2x16,2x8,2x4,2x2,2x1 xB 4x8,4x4,4x2,4x1	060101	060101	2×16	4×8	4 x4 (Sockets 0, 2, 4 & 6)	2 x2 (Sookets 0 & 4)	1×16	2×16	4×8	4×4 (Host 0, 2, 4 & 6)	2x2 (Host 0&4)
SSVO SSVO SSVO CONTINUALISM SSOUR		2 x16, 2 x8, 2 x4, 2 x2, 2 x1 4 x8, 4 x4, 4 x2, 4 x1 8 x4, 8 x2, 8 x1	060100	000100	2×16	4 ×8	8 x4 (NOTE 1)	4 x2 (Sockets 0, 2, 4 & 6)	1x16	2×16	4×8	8×4 (NOTE 1)	2x2 (Host 0 & 4)
Part	Ш	RSVD	0b0010 (not used)										
1/32 1/45 1/45 1/45 1/45 1/45 1/45 1/45 1/45		1832 1816,188,184,182,181 2816,288,284,282,281 488,484,482,481	000090	000040	2×16	4 ×8	8.x4 (NOTE 1)	4 k2 (Sockets 0, 2, 4 & 6)	1432	2×16	4.88	8x4 (NOTE 1)	2 x2 (Host 0 & 4)
	1x32 Option		000000	060001	1×16	1x8 (Socket 0 only)	1x4 (Socket 0 only)	1x2 (Socket 0 only)	1×32	1x16 (Socket 0 only)	1x8 (Host 0 only)	1x4 (Host 0 only)	1x2 (Host 0 only)

3.5.4 Bifurcation Detection Flow

The following detection flow shall be used to determine the resulting link count and lane width based on the baseboard and OCP NIC 3.0 card configurations.

- 1. The baseboard shall read the state of the PRSNTB[3:0]# pins for the Primary Connector and Secondary Connector (if applicable). An OCP NIC 3.0 card is present in the system if the resulting value is not 0b1111 on the Primary Connector.
- 2. Firmware determines the OCP NIC 3.0 card PCIe lane width capabilities per Table 32 by reading the PRSNTB[3:0]# pins.
- 3. The baseboard reconfigures the PCIe bifurcation on its ports to match the highest common lane width and lowest common link count on the card.
- 4. For cases where the baseboard request a link count override (such as requesting a 4-host baseboard requesting 4 x4 operation on a supported card that would otherwise default to a 2 x8 case), the BIF[0:2]# pins shall be asserted as appropriate. Asserting the BIF[0:2]# pins assumes the OCP NIC 3.0 card supports the requested link override.
 - Note: For cards that are already powered up, BIF[0:2]# reconfiguration requires a transition back to ID Mode. During this transition, the card power rails are inactive and manageability links may be briefly lost due to the RBT isolation state.
- 5. The BIF[0:2]# pins must be in their valid states upon the assertion of AUX_PWR_EN.
- 6. AUX_PWR_EN is asserted. An OCP NIC 3.0 card is allowed a max ramp time T_{APL} between AUX_PWR_EN assertion and NIC_PWR_GOOD assertion.
- 7. MAIN_PWR_EN is asserted. An OP NIC 3.0 card is allowed a max ramp time T_{MPL} between MAIN_PWR_EN assertion and NIC_PWR_GOOD reassertion. For cards that do not have a separate AUX and MAIN power domain, this state is an unconditional transition to NIC_PWR_GOOD.
- 8. The PCIe REFCLK shall become valid a minimum of 100 µs before the deassertion of PERST#.
- 9. PERST# shall be deasserted >1 s after NIC_PWR_GOOD assertion as defined in Figure 100. Refer to Section 3.11 for timing details.

3.5.5 PCIe Bifurcation Examples

For illustrative purposes, the following figures show several common bifurcation permutations using a SFF.

3.5.5.1 Single Host (1 x16) Baseboard with a 1 x16 OCP NIC 3.0 Card (Single Controller)

Figure 87 illustrates a single host baseboard that supports x16 with a single controller OCP NIC 3.0 card that also supports x16. The PRSTNB[3:0]# state is 0b0111. The BIF[2:0]# state is 0b000 to set the card as a 1x16 for bifurcation capable controllers. For controllers without bifurcation support, the BIF[2:0] pin connections are not required on the card. The PRSNTB encoding notifies the baseboard that this card is only capable of 1 x16. The single host baseboard determines that it is also capable of supporting 1 x16. The resulting link width is 1 x16.

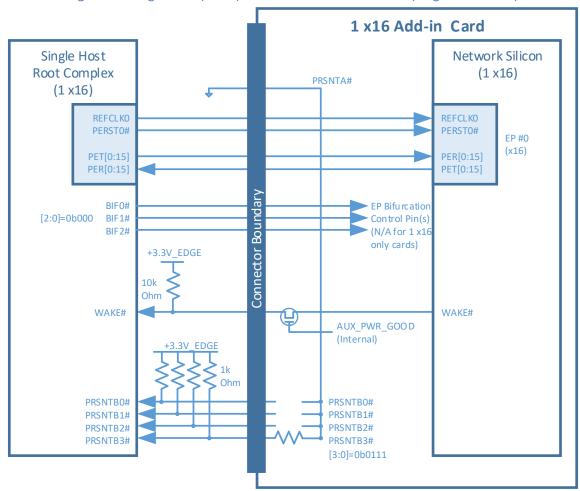


Figure 87: Single Host (1 x16) and 1 x16 OCP NIC 3.0 Card (Single Controller)

3.5.5.2 Single Host (2 x8) Baseboard with a 2 x8 OCP NIC 3.0 Card (Dual Controllers)

Figure 88 illustrates a single host baseboard that supports 2 x8 with a single controller OCP NIC 3.0 card that also supports 2 x8 with dual controllers. The PRSTNB[3:0]# state is 0b0110. The BIF[2:0]# state is 0b000 in this example because the network card only supports a 2x8. The PRSNTB encoding notifies the baseboard that this card is only capable of 2 x8. The single host baseboard determines that it is also capable of supporting 2 x8. The resulting link width is 2 x8.

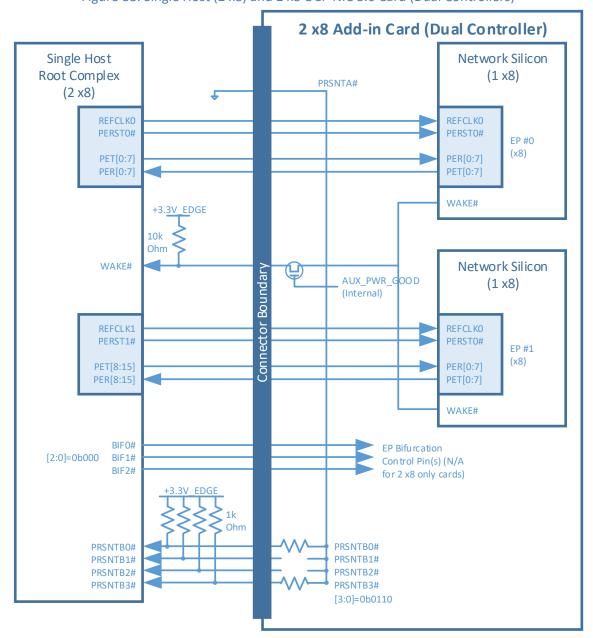


Figure 88: Single Host (2 x8) and 2 x8 OCP NIC 3.0 Card (Dual Controllers)

3.5.5.3 Quad Host (4 x4) Baseboard with a 4 x4 OCP NIC 3.0 Card (Single Controller)

Figure 89 illustrates a quad host baseboard that supports 4 x4 with a single controller OCP NIC 3.0 card that supports 1 x16, 2 x8 and 4 x4. The PRSTNB[3:0]# state is 0b0100. The BIF[2:0]# state in this example is 0b110 as the end point network controller is forced to bifurcate to 4 x4. The PRSNTB encoding notifies the baseboard that this card is only capable of 1 x16, 2 x8 and 4 x4. The quad host baseboard determines that it is also capable of supporting 4 x4. The resulting link width is 4 x4.

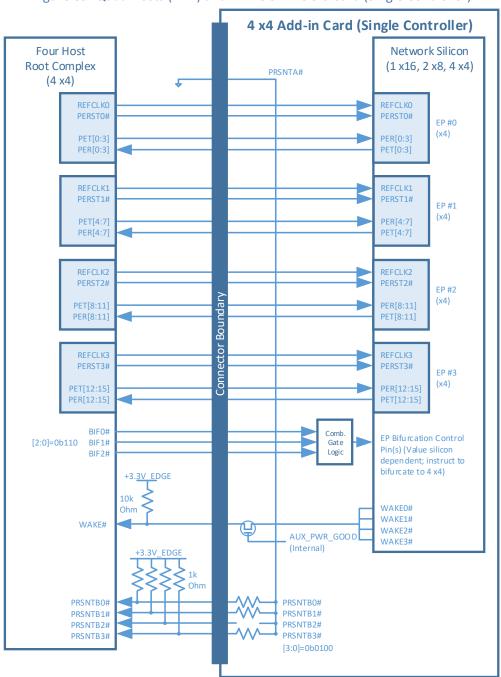


Figure 89: Quad Hosts (4 x4) and 4 x4 OCP NIC 3.0 Card (Single Controller)

3.5.5.4 Quad Host (4 x4) Baseboard with a 4 x4 OCP NIC 3.0 Card (Quad Controllers)

Figure 90 illustrates a quad host baseboard that supports 4 x4 with a quad controller OCP NIC 3.0 card that supports 4 x4. The PRSTNB[3:0]# state is 0b0011. The BIF[2:0]# state is a don't care value as there is no need to instruct the end-point network controllers to a specific bifurcation (each controller only supports 1x4 in this example). The PRSNTB encoding notifies the baseboard that this card is only capable of 4 x4. The quad host baseboard determines that it is also capable of supporting 4 x4. The resulting link width is 4 x4.

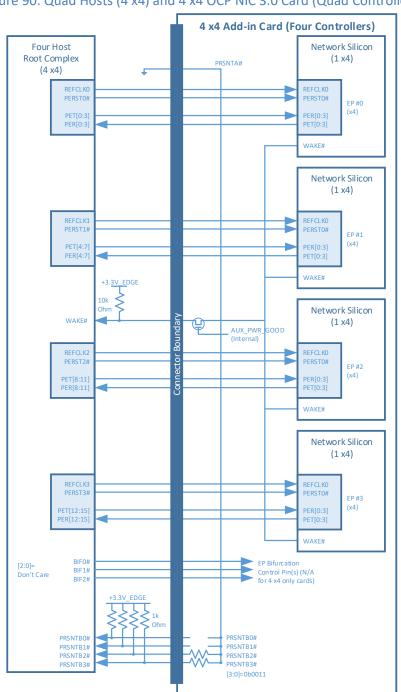


Figure 90: Quad Hosts (4 x4) and 4 x4 OCP NIC 3.0 Card (Quad Controllers)

3.5.5.5 Single Host (1 x16, no Bifurcation) Baseboard with a 2 x8 OCP NIC 3.0 Card (Dual Controller)

Figure 91 illustrates a single host baseboard that supports 1 x16 with a dual controller OCP NIC 3.0 card that supports 2 x8. The PRSTNB[3:0]# state is 0b0110. The BIF[2:0]# state is 0b000 as each silicon instance only supports 1x8. The PRSNTB encoding notifies the baseboard that this card is only capable of 2 x8. The quad host baseboard determines that it is capable of 1x 16, but down shifts to 1 x8. The resulting link width is 1 x8 and only on endpoint 0.

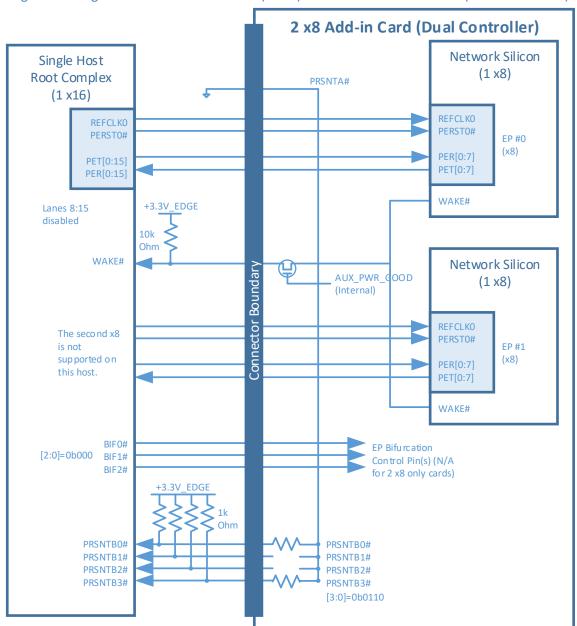


Figure 91: Single Host with no Bifurcation (1 x16) and 2 x8 OCP NIC 3.0 Card (Dual Controllers)

3.6 PCIe REFCLK and PERST# Mapping

The OCP NIC 3.0 specification allows for up to four PCIe REFCLKs and PERST# signals on the Primary Connector and up to two PCIe REFCLKs and PERST# signals on the Secondary Connector. The association of each REFCLK and PERST# is based on the card PCIe Link number and is shown in Table 33. Cards that implement both the Primary and Secondary Connectors have a total of up to 6 available REFCLKs and 6 PERST# signals.

REFCLK[0:3] and PERST[0:3]# are defined for use in this release of the specification. REFCLK[4:5] and PERST[4:5]# are not currently defined for use. The following tables enumerate the REFCLK and PERST# mapping for SFF cards for 1, 2 and 4 links; LFF cards for 1, 2, 4 and 8 links. For a LFF 8 link scenario, the lower x4 "link-a" and upper x4 "link-b" of each x8 lanes are expected to use the same REFCLK and PERST (see Table 35). A 1:2 clock driver circuit is expected on the OCP NIC 3.0 card in this case.

For multi-host use cases, the baseboard may require a multiplexer circuit to direct the Host 1, Host 2 PCIe reference clock to the connector REFCLK1 signal to maintain proper REFCLK associations for a card with two links. Refer to the diagrams in Sections 3.6.1 and 3.6.2.

REFCLK #	PERST #	Description	Availability (Connector)
REFCLK0	PERSTO#	Associated with Link 0.	Primary Connector only.
REFCLK1	PERST1#	Associated with Link 1.	Primary Connector only.
REFCLK2	PERST2#	Associated with Link 2.	Primary Connector only.
REFCLK3	PERST3#	Associated with Link 3.	Primary Connector only.
REFCLK4	PERST4#	Not used.	Secondary Connector only.
REFCLK5	PERST5#	Not used.	Secondary Connector only.

Table 33: PCIe REFCLK and PERST Associations

	Primary (Connector					
Lanes [0:3]	Lanes [4:7]	Lanes [8:11]	Lanes [12:15]				
Link 0 – x16, REFCLKO, PERSTO#							
Link 0 - x8, REFCLKO, PERSTO#		Link 1 – x8, REFCLK1, PERST1#					
Link 0 – x4, REFCLKO,	Link 1 – x4, REFCLK1,	Link 2 – x4, REFCLK2,	Link 3 – x4, REFCLK3,				
PERSTO#	PERST1#	PERST2#	PERST3#				

Table 35: LFF PCIe Link / REFCLKn / PERSTn mapping for 1, 2, 4 and 8 Links

	Primary C	Connector			Secondary	Connector		
Lanes [0:3]	Lanes [4:7]	Lanes [8:11]	Lanes [12:15]	Lanes [16:19]	Lanes [20:23]	Lanes [24:27]	Lanes [28:31]	
Link 0 – x32, R	EFCLKO, PERSTO	#						
Link 0 – x16, R	EFCLKO, PERSTO	#		Link 1 – x16, R	EFCLK1, PERST1	#		
, ,		Link 1 – x8, RE PERST1#	FCLK1,	Link 2 – x8, RE PERST2#	FCLK2,	Link 3 – x8 REFCLK3, PERST3#		
Link 0a – x4, REFCLKO, PERSTO#	Link 0b – x4, REFCLKO, PERSTO#	Link 1a – x4, REFCLK1, PERST1#	Link 1b – x4, REFCLK1, PERST1#	Link 2a – x4, REFCLK2, PERST2#	Link 2b – x4, REFCLK2, PERST2#	Link 3a – x4, REFCLK3, PERST3#	Link 3b – x4, REFCLK3, PERST3#	

3.6.1 SFF PCIe REFCLK and PERST# Mapping

The following figures show the Link n, REFCLKn, PERSTn mapping for the SFF with 1, 2 and 4 links as single, dual and quad host configurations. For clarity, the PCle sideband signals are not illustrated this section. Please refer to the signal descriptions and associated diagrams for connectivity requirements.

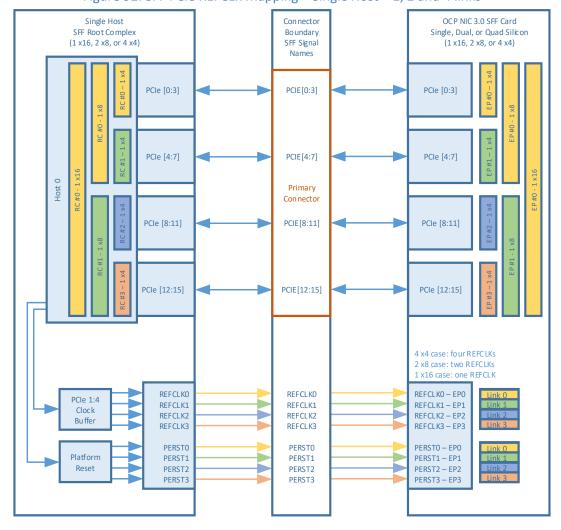


Figure 92: SFF PCIe REFCLK Mapping – Single Host – 1, 2 and 4 links

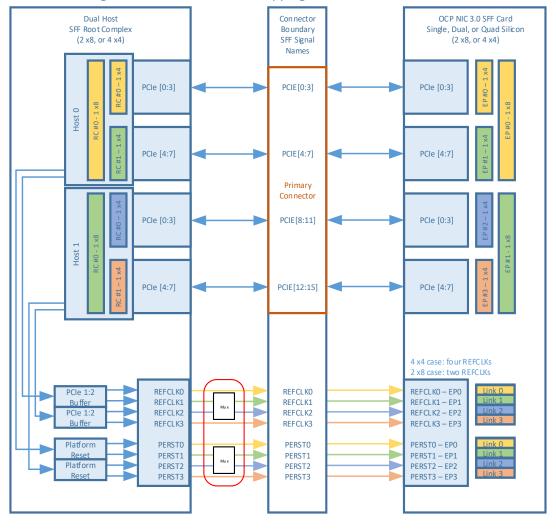


Figure 93: SFF PCle REFCLK Mapping – Dual Host – 2 and 4 links

Note: For dual host applications that connect to a two link endpoint, the baseboard Host 1 REFCLKO and PERSTO signal needs to be multiplexed to the REFCLK1 and PERST1 pins of the OCP NIC 3.0 card edge. This ensures the mandated Link n, REFCLKn and PERSTn mappings are maintained.

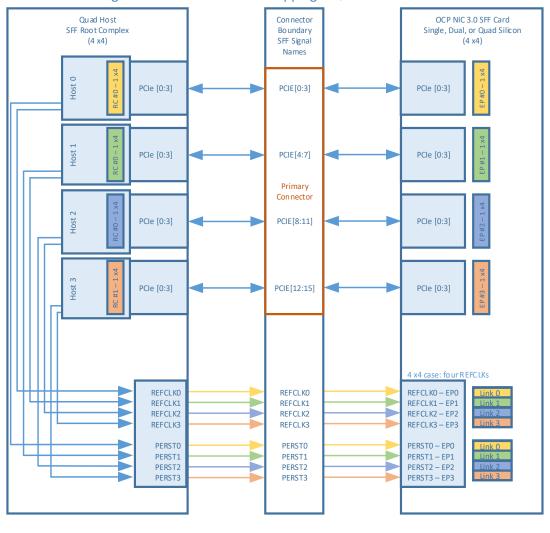


Figure 94: SFF PCIe REFCLK Mapping – Quad Host – 4 Links

Note: For quad host applications that connect to a two link endpoint, the baseboard Host 2 REFCLK and PERST signal needs to be multiplexed to the REFCLK1 and PERST1 pins of the OCP NIC 3.0 card edge. This ensures the mandated Link n, REFCLKn and PERSTn mappings are maintained.

3.6.2 LFF PCIe REFCLK and PERST# Mapping

The following figures show the Link n, REFCLKn, PERSTn mapping for the LFF with 1, 2 and 4 links as single, dual and quad host configurations. For clarity, the PCle sideband signals are not illustrated this section. Please refer to the signal descriptions and associated diagrams for connectivity requirements.

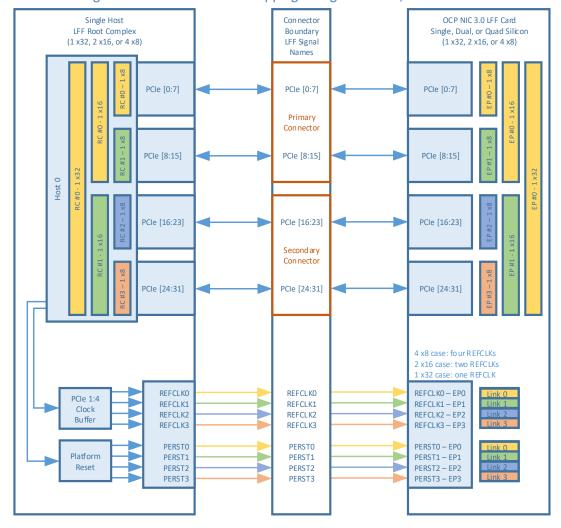


Figure 95: LFF PCIe REFCLK Mapping – Single Host – 1, 2 and 4 links

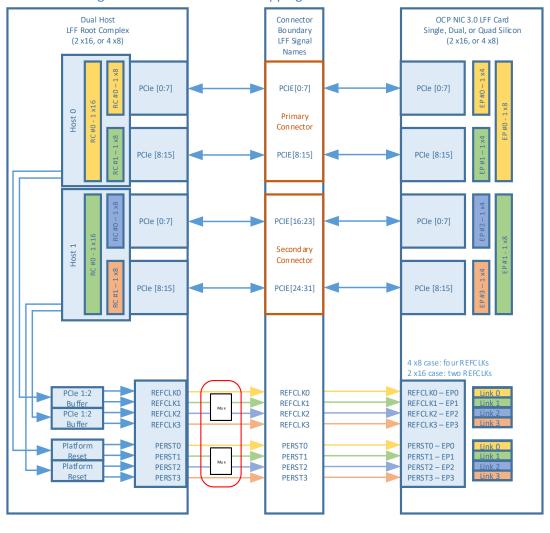


Figure 96: LFF PCIe REFCLK Mapping – Dual Host – 2 and 4 links

Note: For dual host applications that connect to a two link endpoint, the baseboard Host 1 REFCLKO and PERSTO signal needs to be multiplexed to the REFCLK1 and PERST1 pins of the OCP NIC 3.0 card edge. This ensures the mandated Link n, REFCLKn and PERSTn mappings are maintained.

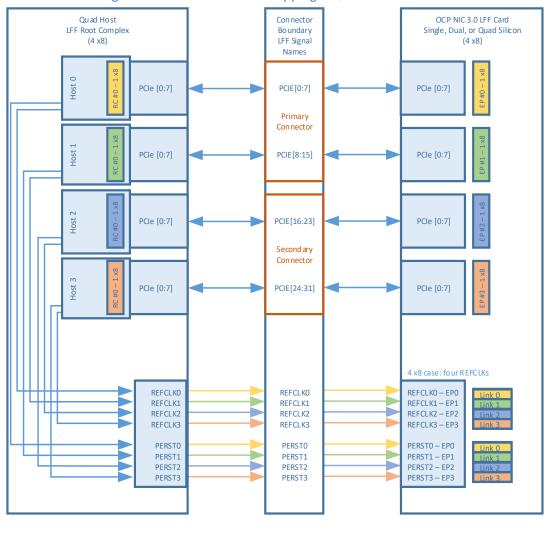


Figure 97: LFF PCIe REFCLK Mapping – Quad Host – 4 Links

Note: For quad host applications that connect to a two link endpoint, the baseboard Host 2 REFCLK and PERST signal needs to be multiplexed to the REFCLK1 and PERST1 pins of the OCP NIC 3.0 card edge. This ensures the mandated Link n, REFCLKn and PERSTn mappings are maintained.

3.6.3 REFCLK and PERST# Mapping Expansion

For cases where bifurcation are permissible on the baseboard and OCP NIC 3.0 card, an expanded PCIe Bifurcation spreadsheet is available on the OCP Wiki site: https://www.opencompute.org/wiki/Server/Mezz.

Implementers shall use the spreadsheet version that is aligned with the spec. At the time of this writing, the latest spreadsheet is version 0.84.

The spreadsheet enumerates all of the supported PCIe link, lane and REFCLK mappings for each supported configuration. The bifurcation decoder is shown in Section 3.5.3.

3.7 Port Numbering and LED Implementations

The OCP NIC 3.0 I/O bracket shall provide port labeling for user identification.

LEDs shall be implemented on the OCP NIC 3.0 I/O bracket when there is sufficient space for local indication. LEDs are typically placed on the primary side. LEDs may be optionally implemented on the secondary side of the card for space constrained implementations. LEDs may be remotely implemented on the card Scan Chain (as defined in Section 3.4.5) for link/activity indication on the baseboard. LED configurations for the local and remote cases are described in the sections below. In all cases, the actual link rate may be directly queried through the management interface.

3.7.1 OCP NIC 3.0 Port Naming and Port Numbering

The numbering of all OCP NIC 3.0 external ports shall start from Port 1. When oriented with the primary side components facing up and viewing directly into the port, Port 1 shall be located on the left hand side. The port numbers shall sequentially increase to the right. Refer to Figure 98 as an example implementation.

3.7.2 OCP NIC 3.0 Card LED Configuration

For low I/O count SFF cards without built in light pipes (such as 1x QSFP, 2x QSFP, 2x SFP, or 2x RJ45), or LFF cards, where additional I/O bracket area is available, the card shall locally implement on-board link/activity indications. The card may additionally implement LEDs on the optional Scan Chain data stream.

For 4x SFP, a permissible LED implementation may include right angle SMT mount LEDs placed on the secondary side of the OCP NIC 3.0 card. The LEDs shall be located below the line side I/O cages.

Note: Depending on the end faceplate implementation (e.g. with an ejector latch), the secondary side LED implementation may be obstructed and biased to the left to prevent interference with the ejector cam mechanism.

The recommended local (on-card) LED implementation uses two physical LEDs (a bicolored Speed A/Speed B Link LED and a discrete Activity LED). Table 36 describes the OCP NIC 3.0 card LED implementations.

The LEDs shall be uniformly illuminated across the indicator surface. LED surfaces with a diffusion treatment are preferred. For ease of indication within the operating environment, all OCP NIC 3.0 cards shall implement measures to prevent bleed-through between LED indicators and their surrounding chassis components.

Table 36: OCP NIC 3.0 Card LED Configuration with Two Physical LEDs per Port

LED Pin	LED Color	Description
Link	Green	Active low. Bicolor multifunction LED.
	Amber	
	Off	This LED shall be used to indicate link.
		When the link is up, then this LED shall be lit and solid. This indicates that the link is established, there are no local or remote faults, and the link is ready for data packet transmission/reception.
		The LED is Green when the port is linked at its maximum speed. The LED is Amber when the port is linked but not operating at the highest speed. The LED is off when no link is present.
		For silicon with limited I/O, the Amber LED may be omitted. In this case, the Green LED shall simply indicate link is up at any configured speed.
		The illuminated Link LED indicator may be blinked and used for port identification through vendor specific link diagnostic software.
		The Link LED shall be located on the left hand side or located on the top for each port when the OCP NIC 3.0 card is viewed in the horizontal plane.
		For serviceability, green LEDs shall emit light at a wavelength between 513 nm and 537 nm while amber LEDs shall emit light at a wavelength between 580 nm and 589 nm.
		For uniformity across OCP NIC 3.0 products, all link LEDs shall have their luminance across the total surface area measured in
		millicandelas (mcd) with an average value between 12 mcd to 18 mcd.
Activity	Green	Active low.
	Off	
		When the link is up and there is no activity, this LED shall be lit and solid.
		When the link is up and there is link activity, then this LED should blink at the rate of ½ Hz to 5 Hz during link activity.
		The activity LED shall be located on the right hand side or located on the bottom for each port when the OCP NIC 3.0 card is viewed in the horizontal plane.

For serviceability, green LEDs shall emit light at a wavelength between 513 nm and 537 nm.
For uniformity across OCP NIC 3.0 products, all activity LEDs shall have their luminance across the total surface area measured in millicandelas (mcd) with an average value between 12 mcd and 18 mcd.

3.7.3 OCP NIC 3.0 Card LED Ordering

For all OCP NIC 3.0 card use cases, each port shall implement the green/amber Link LED and a green activity LED. For I/O limited silicon, the amber LED may be omitted.

When the OCP NIC 3.0 card is viewed from the horizontal position, and with the primary component side facing up, the Link LED shall be located on the left side and the activity LED shall be located on the right. The LED placement may also make use of a stacked LED assembly, or light pipe in the vertical axis. In this case, the Link Activity LED shall be on the top of the stack, and the Activity LED shall be on the bottom of the stack when viewed from the horizontal position. In all cases, the port ordering shall increase from left to right when viewed from the same horizontal position.

The actual placement of the Link and Activity LEDs on the faceplate may be left up to the discretion of the OCP NIC 3.0 card designer. The LED port association should be clearly labeled on the OCP NIC 3.0 card if the space allows. Similarly, the LED for link and the LED for Activity indication should also be marked on the faceplate.

For 4xSFP configurations, the LEDs may be placed on the secondary side of the card using right-angle SMT components. OCP NIC 3.0 designers may opt to use the scan chain LEDs instead or in addition to the on-card indicators.

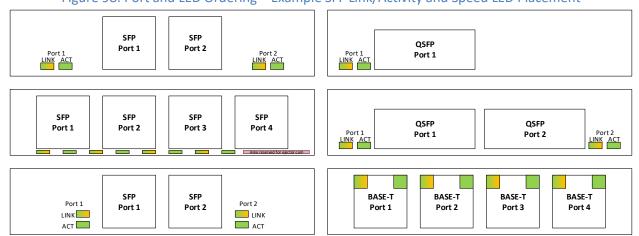


Figure 98: Port and LED Ordering – Example SFF Link/Activity and Speed LED Placement

Note 1: The example port and LED ordering diagrams shown in Figure 98 are viewed with the card in the horizontal position and the primary side is facing up.

Note 2: The 4xSFP LED implementation is biased to the left to allow clearance for the ejector latch cam.

3.7.4 Baseboard LEDs Configuration over the Scan Chain

A SFF OCP NIC 3.0 card with a fully populated I/O bracket (2x QSFP, 4x SFP or 4x RJ45) does not have sufficient space for primary-side discrete on-board (faceplate) LED indicators. Section 3.7.2 presents an implementation for placing LEDs on the secondary side.

In this scenario, the line side link and activity LED indicators are implemented on the baseboard system via the Scan Chain for remote indication. The Scan Chain bit stream is defined in Section 3.4.5.

The baseboard LED implementation uses two discrete LEDs – a green/amber Link LED and a discrete green Activity. The physical baseboard LED implementation is left up to the baseboard vendor and is not defined in this specification. The LED implementation is optional for baseboards.

For serviceability, green LEDs shall emit light at a wavelength between 513 nm and 537 nm while amber LEDs shall emit light at a wavelength between 580 nm and 589 nm.

At the time of this writing, the Scan Chain definition allows for up to two link and one activity LED per port. A total of up to 8 ports are supported in the Scan Chain. The bit stream defines the LEDs to be active low (on). The Scan Chain LED implementation allows the NIC LED indicators to be remotely located on the OCP NIC 3.0 compliant chassis (e.g. front LED indicators with rear I/O cards).

3.8 Power Capacity and Power Delivery

There are four permissible power states: NIC Power Off, ID Mode, Aux Power Mode (S5), and Main Power Mode (S0). The transition of these states is shown in Figure 99. The max available power envelopes for each of these states are defined in Table 37.

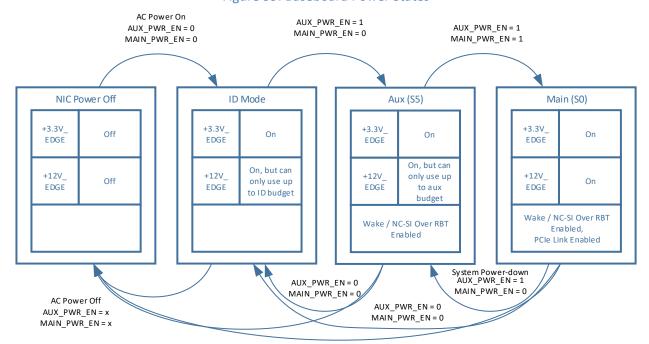


Figure 99: Baseboard Power States

Power State	AUX_PWR	MAIN_PW	PERSTn	FRU	Scan	WAKEn	RBT	PCle	+3.3V	+12V
	_EN	R_EN			Chain		Link	Link	_EDGE	_EDGE
NIC Power Off	Low	Low	Low							
ID Mode	Low	Low	Low	Х	X ¹				Χ	Χ
Aux Power	High	Low	Low	Х	Х	Х	Х		Х	Х
Mode (S5)										
Main Power	High	High	High	Х	Х	Х	Х	Х	Χ	Χ
Mode (S0)										

Table 37: Power States

Note 1: Only the PRSNTB[0:3]# scan chain signals are valid in ID mode as the OCP NIC 3.0 card power rails have not yet been enabled via the AUX_PWR_EN/MAIN_PWR_EN signals.

3.8.1 NIC Power Off

In NIC power off mode, all power delivery has been turned off or disconnected from the baseboard. Transition to this state can be from any other state.

3.8.2 ID Mode

In the ID Mode, only +3.3V_EDGE is available for powering up management only functions. Only FRU and scan chain accesses are allowed in this mode. Only the card PRSNTB[0:3]# bits are valid on the chain in this mode as the OCP NIC 3.0 card power rails have not yet been enabled via the AUX_PWR_EN and MAIN_PWR_EN signals. The WAKE#, TEMP_WARN#, TEMP_CRIT#, Link and Activity bits are invalid and should be masked by the baseboard in ID Mode.

The +12V_EDGE rail is not intended to be used in ID Mode, however leakage current may be present. The max leakage is defined in Section 3.9. An OCP NIC 3.0 card shall transition to this mode when AUX_PWR_EN=0 and MAIN_PWR_EN=0.

3.8.3 Aux Power Mode (S5)

In Aux Power Mode provides both $+3.3V_EDGE$ as well as $+12V_EDGE$ is available. $+12V_EDGE$ in Aux mode may be used to deliver power to the OCP NIC 3.0 card, but only up to the Aux mode budget as defined in Table 38. An OCP NIC 3.0 card shall transition to this mode when AUX_PWR_EN=1, MAIN_PWR_EN=0, NIC_PWR_GOOD=1 and the duration (T_{APL}) has passed for the ID-Aux Power Mode ramp. This guarantees the ID mode to Aux Power Mode transition (as shown in Figure 100) has completed and all Aux Power Mode rails are within operating tolerances. The WAKE#, TEMP_WARN#, and TEMP_CRIT# bits shall not sampled until these conditions are met.

3.8.4 Main Power Mode (S0)

In Main Power Mode provides both +3.3V_EDGE and +12V_EDGE across the OCP connector. The OCP NIC 3.0 card operates in full capacity. Up to 80 W may be delivered on +12V_EDGE for a SFF Card and up to 150 W for a LFF Card. Additionally, up to 3.63 W is delivered on each +3.3V_EDGE pin. An OCP NIC 3.0 card shall transition to this mode when AUX_PWR_EN=1, MAIN_PWR_EN=1, NIC_PWR_GOOD=1 and the duration (T_{MPL}) has passed for the Aux-Main Power Mode ramp. This guarantees the Aux Power Mode to Main Power Mode transition (as shown in Figure 100) has completed and all Main Power Mode rails are within operating tolerances. The WAKE#, TEMP_WARN#, and TEMP_CRIT# bits shall not sampled until these conditions are met.

3.9 Power Supply Rail Requirements and Slot Power Envelopes

The baseboard provides +3.3V_EDGE and +12V_EDGE to both the Primary and Secondary Connectors. The rail requirements are leveraged from the PCIe CEM 4.0 specification. For OCP NIC 3.0 cards, the requirements are as follows:

Power Rail	15 W Slot	25 W Slot	35 W Slot	80 W Slot	150 W
	SFF	SFF	SFF	SFF	LFF
	Hot Aisle	Hot Aisle	Hot Aisle	Cold Aisle	Cold Aisle
+3.3V_EDGE					
Voltage Tolerance	±9% (max)	±9% (max)	±9% (max)	±9% (max)	±9% (max)
Supply Current					
ID Mode	100 mA (max)	100 mA (max)	100 mA (max)	100 mA (max)	100 mA (max)
Aux Mode	1.1 A (max)	1.1 A (max)	1.1 A (max)	1.1 A (max)	2.2 A (max)
Main Mode	1.1 A (max)	1.1 A (max)	1.1 A (max)	1.1 A (max)	2.2 A (max)
Capacitive Load	150 μF (max)	150 μF (max)	150 μF (max)	150 μF (max)	300 μF (max)
+12V_EDGE					
Voltage Tolerance	+8%/-12% (max)	+8/-12% (max)	+8/-12% (max)	+8/-12% (max)	+8/-12% (max)
Supply Current					
ID Mode	50 mA (max)	50 mA (max)	50 mA (max)	50 mA (max)	50 mA (max)
Aux Mode	0.7 A (max)	1.1 A (max)	1.5 A (max)	3.3 A (max)	6.3 A (max)
Main Mode	1.25 A (max)	2.1 A (max)	2.9 A (max)	6.6 A (max)	12.5 A (max)
Capacitive Load	500 μF (max)	500 μF (max)	500 μF (max)	500 μF (max)	1000 μF (max)

Table 38: Baseboard Power Supply Rail Requirements – Slot Power Envelopes

Note 1: While cards may draw up to the published power ratings, the baseboard vendor shall evaluate its cooling capacity for each slot power envelope to determine if a transition to Aux Power Mode is allowed.

Note 2: The maximum slew rate for each OCP NIC 3.0 card shall be no more than 0.1 A/ μ s per the PCIe CEM specification.

Note 3: Each OCP NIC 3.0 card shall limit the bulk capacitance to the max values published (500 μ F for a SFF card, 1000 μ F for a LFF card).

Note 4: For systems that implement hot plug, the baseboard shall limit the voltage slew rate such that the instantaneous inrush current shall not exceed the specified max current. The equation is defined in the PCIe CEM specification and is dV/dt = I/C; where:

I = max allowed current (A) C = max allowed bulk capacitance (F)

dV/dt = maximum allowed voltage slew rate (V/s)

The OCP NIC 3.0 FRU definition provides a record for the max power consumption of the card. This value shall be used to aid in determining if the card may be enabled in a given OCP slot. Refer to Section 4.10.2 for the available FRU records.

Additionally, the baseboard shall advertise its slot power limits to aid in the overall board power budget allocation to prevent a high power card from being enabled in a lower power class slot. This is

implemented via the Slot Power Limit Control mechanism as defined in the PCIe Base Specification. The end point silicon will power up in a low power state until power is negotiated.

3.10 Hot Swap Considerations for +12V_EDGE and +3.3V_EDGE Rails

Hot plug and hot swap support is optional for baseboard implementers. However, the OCP NIC 3.0 form factor lends itself to potential hot plug and removal events while the baseboard is powered on. These events need to be carefully orchestrated with the operating system and system management entity to prevent a system hang. A surprise extraction may occur in some instances when resources have not been quiesced and the card is removed. Many aspects of the system are involved in processing such an event in both cases. The current scope of this specification does not define an overall hardware or software system architecture to support hot plug. Instead, this specification only highlights the hardware elements that can be utilized to support hot plug for implementations.

The system implementer shall consider the use of hot swap controllers on both the +12V_EDGE and +3.3V_EDGE pins to prevent damage to the baseboard or the OCP NIC 3.0 card. Hot swap controllers limit the in-rush current while also providing overcurrent, undervoltage and overvoltage protection capabilities.

The hot swap controller may gate the +12V_EDGE and +3.3V_EDGE based on the PRSNTB[3:0]# value. Per Section 3.5.3, a card is present in the system when the encoded value is not 0b1111. The PRSNTB[3:0]# may be AND'ed together and connected to the hot swap controller to accomplish this result. Per the OCP NIC 3.0 mechanical definition (Section 3.1.1), the present pins are short pins and engage only when the card is positively seated.

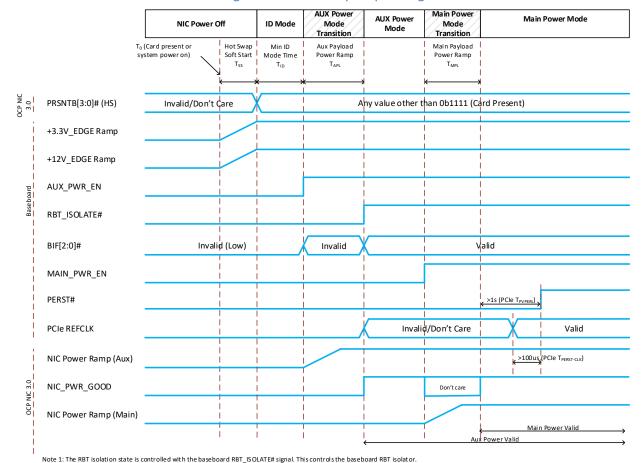
The PRSNTB[3:0]# pins are used to detect an OCP 3.0 NIC card insertion and removal event. The card type detection is described in Section 3.5. Through the use of in-band signaling, the PCIe link may be enabled to periodically train when a card is plugged in. Similarly, the signals may be used to detect a card removal. The card type is determined by querying the FRU data over the SMBus.

At the time of this writing, the DSP0222 Network Controller Sideband Interface (NC-SI) Specification does not define a mechanism to discover hot-plug support. Future work is needed for supporting this feature on NCSI over RBT interfaces.

Baseboards that do not support hot insertion, or hot extractions may opt to not implement these features.

3.11 Power Sequence Timing Requirements

The following figure shows the power sequence of PRSNTB[3:0]#, +3.3V_EDGE, +12V_EDGE relative to AUX_PWR_EN, RBT_ISOLATE#, BIF[2:0]#, MAIN_PWR_EN, PERSTn*, and PCIe REFCLK stable on the baseboard. Additionally the OCP NIC 3.0 card power ramp, and NIC_PWR_GOOD are shown. Please refer to Section 3.4.6 for the NIC_PWR_GOOD definition. Refer to DMTF DSP0222 for details on the NC-SI controller and clock startup requirements.



Note 2: For NC-SI over RBT, the rising edge of NIC_PWR_GOOD shall be treated as V_{REF} is available for NC-SI communication. Refer to timing parameter T4 in the DMTF DSP0222 specification for details.

Figure 100: Power-Up Sequencing

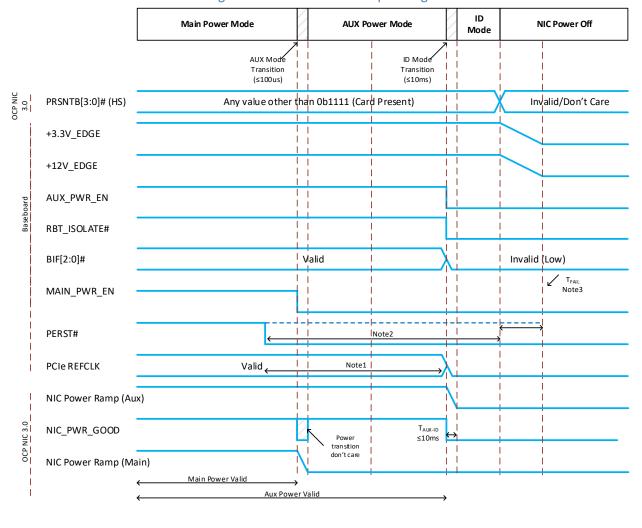


Figure 101: Power-Down Sequencing

Note1: REFCLK go inactive after PERST# goes active. (PCIe CEM Section 2.2.3)

Note2: PERST# goes active before the power on the connector is removed. (PCIe CEM Section 2.2.3)

Note 3: In the case of a surprise power down, PERST# goes active T_{FALL} after power is no longer stable.

Table 39: Power Sequencing Parameters

Parameter	Value	Units	Description
T _{ss}	20	ms	Maximum time between system +3.3V_EDGE and +12V_EDGE ramp to power stable.
			This parameter is only applicable to hot swap controller-based implementations. For non-hot swap applications, the +3.3V_EDGE and +12V_EDGE ramp is system dependent.
T _{SCAN_RDY}	1	ms	Minimum time required between +3.3V_EDGE stable to the first scan chain data valid read.
T _{ID}	20	ms	Minimum guaranteed time per spec to spend in ID mode.
T _{APL}	25	ms	Maximum time between AUX_PWR_EN assertion and NIC_PWR_GOOD assertion.

T _{MPL}	25	ms	Maximum time between MAIN_PWR_EN assertion and
			NIC_PWR_GOOD assertion.
T _{PVPERL}	1	S	Minimum time between NIC_PWR_GOOD assertion in Main Power
			Mode and PERST# deassertion. For OCP NIC 3.0 applications, this
			value is >1 second. This is longer than the minimum value specified
			in the PCIe CEM Specification, Rev 4.0.
T4	2	S	Maximum time interval from when the network controller NC-SI
			over RBT interface is able to respond to commands.
			The parameter T4 is defined in the DSP0222 specification and is
			measured from when V _{REF} becomes available. For OCP NIC 3.0, the
			value T4 is measured from the deassertion of RBT_ISOLATE#.
T _{PERST-CLK}	100	μs	Minimum Time PCIe REFCLK is stable before PERST# inactive.
T _{FAIL}	500	ns	In the case of a surprise power down, PERST# goes active at
			minimum T _{FAIL} after power is no longer stable.
T _{AUX-ID}	10	ms	Maximum time from AUX_PWR_EN deassertion to NIC_PWR_GOOD
			deassertion.

3.12 Digital I/O Specifications

All digital I/O pins on the connector boundary are +3.3 V signaling levels. Table 40 following tables provide the absolute max levels. Refer to the appropriate specifications for the RBT, PCIe and SMBus DC/AC specifications.

Table 40: Digital I/O DC specifications

Symbol	Parameter	Min	Max	Units	Note
V _{OH}	Output voltage		3.6	V	
V _{OL}	Output low voltage		0.8	V	
I _{OH}	Output high current			mA	
I _{OH}	Output low current			mA	
V _{IH}	Input voltage		3.6	V	
V _{IL}	Input low voltage		0.8	V	
I _{OH}	Input current			mA	

Table 41: Digital I/O AC specifications

Symbol	Parameter	Min	Max	Units	Note
T _{OR}	Output rise time			ns	
T _{OF}	Output fall time			ns	

4 Management and Pre-OS Requirements

OCP NIC 3.0 card management is an important aspect to overall system management. This section specifies a common set of management requirements for OCP NIC 3.0 implementations. There are three types of implementations (RBT+MCTP Type, RBT Type, and MCTP Type) depending on the physical sideband management interfaces, transports, and traffic supported over different transports. An OCP NIC 3.0 implementation shall support at least one type of implementation for card management. For a given type of implementation, an OCP NIC 3.0 card shall support type specific requirements described in Sections 4.1 through 4.7.

Management Type	Definition
RBT Type	The RBT Type management interface is exclusive to the Reduced Media
	Independent Interface (RMII) Based Transport (RBT). The NIC card is required
	to support the DSP0222 Network Controller Sideband Interface (NC-SI)
	Specification for this management
RBT+MCTP Type	The RBT+MCTP management interface supports both the RBT and MCTP
	standards, specifically the DSP0222 Network Controller Sideband Interface
	(NC-SI) Specification, DSP0236 Management Component Transport Protocol
	(MCTP) Base Specification, and the associated binding specifications. This is
	the preferred management implementation for baseboard NIC cards. See
	MCTP Type below for more details
MCTP Type	The MCTP management interface supports MCTP standards specifically the
	DSP0236 Management Component Transport Protocol (MCTP) Base
	Specification and the associated binding specifications.

Table 42: OCP NIC 3.0 Management Implementation Definitions

4.1 Sideband Management Interface and Transport

OCP NIC 3.0 sideband management interfaces are used by a Management Controller (MC) or Baseboard Management Controller (BMC) to communicate with the NIC. Table 43 summarizes the sideband management interface and transport requirements.

Requirement	RBT+MCTP	RBT Type	МСТР
	Type		Type
NC-SI compliant RMII Based Transport (RBT) including	Required	Required	N/A
physical interface defined in Section 10 of DMTF DSP0222			
I ² C compliant physical interface for FRU EEPROM	Required	Required	Required
SMBus 2.0 compliant physical interface	Required	N/A	Required
Management Component Transport Protocol (MCTP) Base	Required	N/A	Required
(DSP0236 compliant) over MCTP/SMBus Binding (DSP0237			
compliant)			
PCIe VDM compliant physical interface	Optional	Optional	Optional
Management Component Transport Protocol (MCTP) Base	Optional	Optional	Optional
(DSP0236 compliant) over MCTP/PCIe VDM Binding			
(DSP0238 compliant)			

Table 43: Sideband Management Interface and Transport Requirements

4.2 NC-SI Traffic

DMTF DSP0222 defines two types of NC-SI traffic: Pass-Through and Control. Table 44 summarizes the NC-SI traffic requirements.

Requirement **RBT+MCTP RBT Type MCTP** Type Type NC-SI Control over RBT (DMTF DSP0222 compliant) Required N/A Required NC-SI Control over MCTP (DMTF DSP0261 compliant) Required N/A Required NC-SI Pass-Through over RBT (DMTF DSP0222 compliant) Required Required N/A NC-SI Pass-Through over MCTP (DMTF DSP0261 compliant) Optional N/A Optional

Table 44: NC-SI Traffic Requirements

Note: A Management Controller (MC) is allowed to use NC-SI Control traffic only without enabling NC-SI pass-through.

4.3 Management Controller (MC) MAC Address Provisioning

An OCP NIC 3.0 compliant card that supports NC-SI pass-through shall provision one or more MAC addresses per Package (refer to the Package definition as detailed in the DMTF DSP0222 specification) for Out-Of-Band (OOB) management traffic. The number of MC MAC addresses provisioned is implementation dependent. These MAC addresses are not exposed to the host(s) as available MAC addresses. The MC is not required to use these provisioned MAC addresses. Table 45 summarizes the MC MAC address provisioning requirements.

Table 45: MC MAC Address Provisioning Requirements

Requirement	RBT+MCTP	RBT Type	MCTP
	Type		Type
One or more MAC Addresses per package shall be provisioned for the MC.	Required	Required	Optional
The OCP NIC 3.0 platform may choose to use the NIC vendor allocated MAC addresses for the BMC.			
The usage of provisioned MAC addresses are BMC implementation specific and is outside the scope of this specification.			
The recommended MAC address allocation scheme is stated below.			
Assumptions:			
1. The number of BMCs or virtual BMCs is the same as			
the number of hosts (1:1 relationship between each host and the BMC).			
2. The maximum number of partitions on each port is			
the same.			
Variables:			

 num_ports - Number of Ports on the OCP NIC 3.0 			
card			
 max_parts – Maximum number of partitions on a 			
port			
 num hosts – Number of hosts supported by the 			
NIC ,			
• first addr - The MAC address of the first port			
on the first host for the first partition on that port			
• host addr[i] - base MAC address of i th host (0			
≤ i ≤ num hosts-1)			
• bmc_addr[i] - base MAC address of i th BMC (0			
≤ i ≤ num_hosts-1)			
Formulae:			
host_addr[i] = first_addr +			
i*num_ports*(max_parts+1)			
The assignment of MAC address used by i th host on			
port j for the partition k is out of the scope of this			
specification.			
bmc_addr[i] = host_addr[i] + num_ports*max_parts			
The MAC address used by i th BMC on port j, where 0			
\leq i \leq num_hosts-1 and $0 \leq$ j \leq num_ports -1 is			
bmc_addr[i] + j			
Support at least one of the following mechanism for	Required	Required	Optional
provisioned MC MAC Address retrieval:			
NC-SI Control/RBT (DMTF DSP0222 compliant)			
NC-SI Control/MCTP (DMTF DSP0261 compliant)			
Note: This capability is planned to be included in revision 1.2			
of the DSP0222 NC-SI specification.			
For DMTF DSP0222 1.1 compliant OCP NIC 3.0			
implementations, MC MAC address retrieval shall be			
supported using NC-SI OEM commands. An OCP NIC 3.0			
implementation, that is compliant with DMTF DSP0222 that			
defines standard NC-SI commands for MC MAC address			
retrieval, shall support those NC-SI commands.			

4.4 Temperature Reporting

An OCP NIC 3.0 implementation can have several silicon components including one or more ASICs implementing NIC functions and one or more transceiver modules providing physical network media

connectivity. For the system management, it is important that temperatures of these components can be retrieved over sideband interfaces.

The temperature reporting interface shall be accessible in Aux Power Mode (S5), and Main Power Mode (S0). Table 46 summarizes temperature reporting requirements. These requirements improve the system thermal management and allow the baseboard management device to access key component temperatures on an OCP NIC 3.0 card. When the temperature reporting function is implemented, it is required that the temperature reporting accuracy is within ±3°C.

Table 46: Temperature Reporting Requirements

Requirement	RBT+MCTP	RBT Type	МСТР
	Type		Туре
Component Temperature Reporting for a component with	Required	Required	Required
TDP ≥5 W			
Component Temperature Reporting for a component with	Recommended	Recommended	Recommended
TDP < 5 W			
When the temperature sensor reporting function is	Required	Required	Required
implemented, the OCP NIC 3.0 card shall support PLDM for			
Platform Monitoring and Control (DSP0248 compliant) for			
temperature reporting.			
When the temperature sensor reporting function is	Required	Required	Required
implemented, the OCP NIC 3.0 card shall report upper			
warning, upper critical, and upper fatal thresholds for PLDM			
numeric sensors.			
Note: Refer to DSP0248 for definitions of the upper warning,			
upper critical, and upper fatal thresholds.			
When the temperature reporting function is implemented	Required	Required	Required
using PLDM numeric sensors, the temperature tolerance			
shall be reported as part of the sensor Platform Descriptor			
Record (PDR) format.			
Support for self-shutdown.	Optional	Optional	Optional
The purpose of the self-shutdown feature is to "self-			
protect" the NIC ASIC from permanent damage due to high			
operating temperatures. The NIC may accomplish this by			
reducing the power consumed by the ASIC. A BMC may			
continuously monitor the NIC ASIC temperature and			
shutdown the NIC ASIC as soon as the temperature reaches			
a threshold value.			
There may be scenarios and implementations where the			
OCP NIC ASIC may be required to self-shutdown without			
depending on an external entity like the BMC. For those			
scenarios and implementations, the self-shutdown feature is			
a final effort in preventing permanent damage to the NIC			
ASIC at the expense of potential data loss.			

If the self-shutdown feature is implemented, the NIC ASIC shall monitor its temperature and shut-down itself as soon as the self-shutdown threshold value is reached. The value of the self-shutdown threshold is implementation specific. It is recommended that the self-shutdown threshold value is higher than the maximum junction temperature of the ASIC implementing the NIC function. It is also recommended that the self-shutdown threshold value is between the critical and fatal temperature thresholds of the ASIC.		
If the self-shutdown feature is implemented, care shall be taken to ensure that the board power down state is latched and the board does not autonomously resume normal operation.		
The OCP NIC 3.0 card does not need to know the reason for the NIC ASIC self-shutdown threshold crossing (e.g. fan failure). After the NIC ASIC enters the self-shutdown state, the OCP NIC 3.0 card may not be operational. This might cause the system with the OCP NIC 3.0 card to become unreachable via the NIC.		
In order to recover the NIC ASIC from the self-shutdown state, the OCP NIC 3.0 card shall go through the NIC ID Mode state as described in Section 3.8.1.		
If the self-shutdown feature is implemented, the implementation shall provide a mechanism to enable/disable the feature.		
Note: It is assumed that a system management function will prevent a component from reaching its fatal threshold temperature.		

4.5 Power Consumption Reporting

An OCP NIC 3.0 implementation may be able to report the power consumed at the board level. It is important for the system management that the information about the power consumption can be retrieved over sideband interfaces. Table 47 summarizes power consumption reporting requirements.

Table 47: Power Consumption Reporting Requirements

Requirement	RBT+MCTP	RBT Type	МСТР
	Type		Type
Board Only Estimated Power Consumption Reporting. The	Required	Required	Required
value of this field is encoded into the FRU EEPROM contents.			
This field reports the board max power consumption value			
without transceivers plugged into the line side receptacles.			

Pluggable Transceiver Module Power Reporting. The pluggable transceivers plugged into the line side receptacles shall be inventoried (via an EEPROM query) and the Power Class of the module shall be reported.	Required	Required	Required
Board Runtime Power Consumption Reporting. This value shall be optionally reported over the management binding interface. The runtime power value shall report the card edge power.	Optional	Optional	Optional
PLDM for Platform Monitoring and Control (DSP0248 compliant) shall be used for transceiver and board power consumption reporting.	Required	Required	Required

4.6 Pluggable Transceiver Module Status and Temperature Reporting

A pluggable transceiver module is a compact, hot-pluggable transceiver used to connect the OCP 3.0 NIC to an external physical medium. It is important for proper system operation to know the presence and temperature of pluggable transceiver modules. Table 48 summarizes pluggable module status reporting requirements.

Requirement	RBT+MCTP	RBT Type	MCTP
	Type		Туре
Pluggable Transceiver modules Presence Status and	Required	Required	Required
Temperature Reporting			
PLDM for Platform Monitoring and Control (DSP0248	Required	Required	Required
compliant) for reporting the pluggable transceiver module			
presence status and pluggable transceiver module			
temperature			

Table 48: Pluggable Module Status Reporting Requirements

4.7 Management and Pre-OS Firmware Inventory and Update

An OCP NIC 3.0 implementation can have different types of firmware components for data path, control path, and management path operations. It is desirable that OCP NIC 3.0 implementations support an OS-independent mechanism for the management firmware update. It is desirable that the management firmware update does not require a system reboot for the new firmware image to become active. Table 49 summarizes the firmware inventory and update requirements.

Requirement	RBT+MCTP	RBT Type	MCTP
	Type		Туре
Network boot in UEFI driver (supporting both IPv4 and	Required	Required	Required
IPv6 addressing for network boot)			
UEFI secure boot for UEFI drivers	Required	Required	Required
UEFI Firmware Management Protocol (FMP)	Required	Required	Required
PLDM for Firmware Update (DSP0267 compliant)	Required	Recommended	Required

Table 49: Management and Pre-OS Firmware Inventory and Update Requirements

4.7.1 Secure Firmware

It is highly recommended that an OCP NIC 3.0 card supports a secure firmware feature. In the future versions of the OCP NIC 3.0 specification, the secure firmware feature is intended to be required. When the secure firmware feature is enabled and where export compliance permits, the OCP NIC 3.0 card shall verify firmware components prior to the execution, execute only signed and verified firmware components, and only allow authenticated firmware updates. Where applicable, an OCP NIC 3.0 implementation shall use the guidelines provided in NIST SP 800-193 Platform Resiliency Guidelines for the following secure firmware functions:

- Signed Firmware Updates
- Ensure only valid/authenticated firmware updates can be applied. Refer to: NIST 800-193 Section 3.5 Firmware Update Mechanisms, and 4.1.2 Root of Trust for Update (RTU) and Chain of Trust for Update (CTU)
- Ensure authentication mechanisms cannot be bypassed. Refer to NIST 800-193 Section 4.2 Protection.
- Secure Boot
- Only boot trusted/authenticated firmware: NIST 800-193 4.1.3 Root of Trust for Detection (RTD) and Chain of Trust for Detection (CTD), and Section 4.3 Detection
- Recovery mechanism in case of boot failure: NIST 800-193 Section 4.4 Recovery

4.7.2 Firmware Inventory

The OCP NIC 3.0 card shall allow queries to obtain the firmware component versions, device model, and device ID via in-band and out-of-band interfaces without impacting NIC function and performance of said paths.

4.7.3 Firmware Inventory and Update in Multi-Host Environments

A multi-host capable OCP NIC 3.0 card shall gracefully handle concurrent in-band queries from multiple hosts and out-of-band access from the BMC for firmware component versions, device model, and device ID information.

A multi-host capable OCP NIC 3.0 card shall only permit one entity to perform write accesses to NIC firmware at a time, without creating contention.

A multi-host capable OCP NIC 3.0 card shall gracefully handle exceptions when more than one entity attempts to perform concurrent NIC firmware writes.

4.8 NC-SI Package Addressing and Hardware Arbitration Requirements

NC-SI over RBT is implemented via RMII pins between the MC and the OCP NIC 3.0 card. Protocol and implementation details of NC-SI over RBT can be found in the DMTF DSP0222 standard.

4.8.1 NC-SI over RBT Package Addressing

NC-SI over RBT capable OCP NIC 3.0 cards shall use a unique Package ID per ASIC when multiple ASICs share the single NC-SI physical interconnect to ensure there are no addressing conflicts.

Baseboards use the Slot_ID[1:0] values on the Primary Connector for this identification. The value of Slot_ID[1:0] is determined by the encoding shown in Table 50. SLOT_ID[1:0] is statically set high or low on the baseboard and is available on the OCP Bay portion of the Primary Connector.

Physical Slot (Dec.)	SLOT_I	ID[1:0]	Package ID[2:0]			
	Pin OCP_A6	Pin OCP_B7	Package ID[2]	Package ID[1]	Package ID[0]	
	SLOT_ID1	SLOT_ID0	PhysDev#	SLOT_ID1	SLOT_ID0	
Slot 0	0	0	0/1	0	0	
Slot 1	0	1	0/1	0	1	
Slot 2	1	0	0/1	1	0	
Slot 3	1	1	0/1	1	1	

Table 50: Slot_ID[1:0] to Package ID[2:0] Mapping

Package ID[2:0] is a 3-bit field and is encoded in the NC-SI Channel ID as bits [7:5]. SLOT_ID1 is associated with Package ID[1]. SLOT_ID0 is associated with Package ID[0]. The Package ID[2] value is based on the silicon instance on the same physical OCP NIC 3.0 card. Package ID[2]==0b0 is assigned for physical controller #0. Package ID[2]==0b1 is assigned for physical controller #1. In this case, physical controller #1 on the same card is at an address offset of +0x4. Refer to the specific endpoint device datasheet for details on the Package ID configuration options.

Note: The Package ID[2] field is optionally configurable in the NC-SI specification. If the target silicon hard codes this bit to 0b0, then a card must only implement a single silicon instance to prevent addressing conflicts.

Refer to the DMTF DSP0222 standard for more information on package addressing and Package ID.

4.8.2 Arbitration Ring Connections

For baseboards that implement two or more Primary Connectors, the NC-SI over RBT arbitration ring shall be connected to each other. The arbitration ring shall support operation with one card, or multiple cards installed. Figure 80 shows an example connection with dual Primary Connectors.

4.9 SMBus 2.0 Addressing Requirements

The SMBus provides a low speed management bus for the OCP NIC 3.0 card. The FRU EEPROM is directly connected to the OCP NIC 3.0 card edge on this bus and can be read by the baseboard in the ID Mode, Aux Power Mode and Main Power Mode. Network controllers may utilize the SMBus 2.0 interface for MCTP communications. OCP NIC 3.0 does not support MCTP over I²C due to the use of specific SMBus 2.0 addressing. Proper power domain isolation shall be implemented on the NIC.

4.9.1 SMBus Address Map

OCP NIC 3.0 cards shall support the SMBus Address Resolution Protocol (ARP). This allows for dynamic assignment of slave device addresses. This method automatically resolves address conflicts and eliminates the need for manual address configuration. The SMBus address type can be either a Dynamic and Persistent Address or a Dynamic and Volatile Address. Refer to the SMBus 2.0 specification and Section 6.11 of DSP0237 for details on SMBus address assignment.

A baseboard implementation may choose to only use fixed addresses for OCP NIC 3.0 cards. The assignment of these fixed addresses is system dependent and is outside the scope of this specification.

When fixed addresses are used, then the OCP NIC 3.0 card shall be a "Fixed and Discoverable" SMBus device. Refer to the SMBus 2.0 specification for more details.

All predefined SMBus addresses for OCP NIC 3.0 are shown in Table 51. Baseboard and OCP NIC 3.0 card designers must ensure additional devices do not conflict. The addresses shown are in 8-bit format and represent the read/write address pair.

Physical Slot (Dec.)	SLOT_ID[1:0]		FRU EEPROM Address					
	Pin OCP_A6	Pin OCP_B7	A2	A1	A0	Binary Address	Hex Address	
(Dec.)	SLOT_ID1	SLOT_ID0	SLOT_ID1	SLOT_ID0	Fixed			
Slot 0	0	0	0	0	0	0b1010_000X	0xA0/0xA1	
Slot 1	0	1	0	1	0	0b1010_010X	0xA4/0xA5	
Slot 2	1	0	1	0	0	0b1010_100X	0xA8/0xA9	
Slot 3	1	1	1	1	0	0b1010_110X	0xAC/0xAD	

Table 51: FRU EEPROM Address Map

4.10 FRU EEPROM

4.10.1 FRU EEPROM Address, Size and Availability

The FRU EEPROM provided for the baseboard to determine the card type and is directly connected to the SMBus on the card edge. Only one EEPROM is required for a single physical OCP NIC 3.0 card regardless of the PCIe width or number of physical card edge connectors it occupies. The FRU EEPROM is mandatory and shall be connected to the Primary Connector SMBus.

The EEPROM is addressable at the addresses indicated in Table 51. The write/read pair is presented in 8-bit format. The size of EEPROM shall be at least 4Kbits for the base EEPROM map. OCP NIC 3.0 card suppliers may use a larger size EEPROM if needed to store vendor specific information. The FRU EEPROM shall use double byte addressing. The FRU EEPROM shall be write protected for production cards by pulling the EEPROM WP pin high to +3.3V_EDGE. The FRU shall be writable for manufacturing test and during card development by pulling the EEPROM WP pin low to ground.

The FRU EEPROM is readable in all three power states (ID mode, AUX(S5) mode, and MAIN(S0) mode).

4.10.2 FRU EEPROM Content Requirements

The FRU EEPROM shall follow the data format specified in Section 17 of the IPMI Platform Management FRU Information Storage Definition specification. For OCP NIC 3.0, the FRU Information Device shall, at a minimum, contain the Common Header, Board Info Area, Product Info Area and a MultiRecord Area for storing the OEM record. These fields shall be populated in the FRU EEPROM. Where applicable, fields common to the Board Info and Product Info records shall be populated with the same values so they are consistent.

The OEM record 0xC0 is used to store specific records for the OCP NIC 3.0 and is stored in the MultiRecord area of the FRU layout. For an OCP NIC 3.0 card, the FRU EEPROM OEM record content based on the format defined in Table 52 shall be populated.

Note: Table 52 only shows a portion of the OEM record. The complete record includes a Common Header and valid record checksum as defined in the IPMI Platform Management FRU Information Storage Definition specification.

Table 52: FRU EEPROM Record – OEM Record 0xC0, Offset 0x00

Offset	Length	Description
0	3	Manufacturer ID.
		For OCP NIC 3.0 compliant cards, the value of this field shall be set to the OCP IANA assigned number. This value is 0x7FA600, least significant byte first. (42623 in decimal)
3	1	OCP NIC 3.0 FRU OEM Record Version.
		For OCP NIC 3.0 cards compliant to this specification, the value of this field shall be set to 0x01.
4	1	Card Max power (in Watts) in MAIN (S0) mode.
		The encoded value is the calculated max power of the OCP NIC 3.0 card in the Main Power (S0) mode only and does not include the consumed power by transceivers plugged into the line side receptacle(s).
		0x00 – 0xFE – Card power rounded up to the nearest Watt for fractional values. 0xFF – Unknown
5	1	Card Max power (in Watts) in AUX (S5) mode.
		The encoded value is the calculated max power of the OCP NIC 3.0 card in the Aux Power (S5) mode only and does not include the consumed power by transceivers plugged into the line side receptacle(s).
		0x00 – 0xFE – Card power rounded up to the nearest Watt for fractional values. 0xFF – Unknown
6	1	Hot Aisle Card Cooling Tier.
		The encoded value reports the OCP NIC 3.0 Card Hot Card Cooling Tier as defined in Section 6.6.1.
		0x00 – RSVD 0x01 – Hot Aisle Cooling Tier 1 0x02 – Hot Aisle Cooling Tier 2 0x03 – Hot Aisle Cooling Tier 3 0x04 – Hot Aisle Cooling Tier 4 0x05 – Hot Aisle Cooling Tier 5 0x06 – Hot Aisle Cooling Tier 6 0x07 – Hot Aisle Cooling Tier 7 0x08 – Hot Aisle Cooling Tier 8 0x09 – Hot Aisle Cooling Tier 9 0x0A – Hot Aisle Cooling Tier 10 0x0B – Hot Aisle Cooling Tier 11 0x0C – Hot Aisle Cooling Tier 12 0x0D – 0xFE – Reserved 0xFF – Unknown
7	1	Cold Aisle Card Cooling Tier.
		The encoded value reports the OCP NIC 3.0 Card Cold Aisle Cooling Tier as defined in Section 6.6.2.

		0x00 – RSVD
		0x01 – Cold Aisle Cooling Tier 1
		0x02 – Cold Aisle Cooling Tier 2
		0x03 – Cold Aisle Cooling Tier 3
		0x04 – Cold Aisle Cooling Tier 4
		0x05 – Cold Aisle Cooling Tier 5
		0x06 – Cold Aisle Cooling Tier 6
		0x07 – Cold Aisle Cooling Tier 7
		0x08 – Cold Aisle Cooling Tier 8
		0x09 – Cold Aisle Cooling Tier 9
		0x0A – Cold Aisle Cooling Tier 10 0x0B – Cold Aisle Cooling Tier 11
		0x0C – Cold Aisle Cooling Tier 12
		0x0D – 0xFE – Reserved
		0xFF – Unknown
8	1	Card active/passive cooling.
	-	
		This byte defines if the card has passive cooling (there is no fan on the card) or active cooling (a fan is located on the card).
		,
		0x00 – Passive Cooling
		0x01 – Active Cooling
		0x02 – 0xFE – Reserved 0xFF – Unknown
9	2	Hot aisle standby airflow requirement.
		The encoded value represents the amount of airflow, in LFM, required to cool the card in AUX (S5) mode while operating in a hot aisle environment. Refer to Section 6 for more information about the thermal and environmental requirements.
		Byte 9 is the least significant byte, byte 10 is the most significant byte.
		0x0000-0xFFFE – LFM required for cooling card in Hot Aisle Operation.
		0xFFFF – Unknown.
11	2	Cold aisle standby airflow requirement.
		The encoded value represents the amount of airflow, in LFM, required to cool the card in AUX (S5) mode while operating in a cold aisle environment. Refer to Section 6 for more information about the thermal and environmental requirements.
		Byte 11 is the least significant byte, byte 12 is the most significant byte.
		0x0000-0xFFFE – LFM required for cooling card in Cold Aisle Operation. 0xFFFF – Unknown.
13	1	UART Configuration 1 – Secondary Connector.
		This byte denotes the UART configuration 1. A value 0x00 means no serial connection is implemented on the Secondary Connector card edge.
		Bits [2:0] denotes the UART baud rate per the encoding table below. If implemented, the encoded field value defines the default baud rate of the OCP NIC 3.0 card serial port.
		0b000 – No serial connection 0b001 – 115200 baud
		0b001 – 115200 baud 0b010 – 57600 baud
		0b010 = 37600 badd 0b011 = 38400 badd
		0b100 – 19200 baud

	1	
		0b101 – 9600 baud
		0b110 – 4800 baud 0b111 – 2400 baud
		Bits [4:3] denotes the number of data bits. 0b00 – No serial connection
		0b00 = No serial connection
		0b10 – 8 data bits
		0b11 – Reserved
		Bits [7:5] denotes the parity bit character.
		0b000 – No serial connection
		0b001 – None (N)
		0b010 - Odd (O)
		0b011 – Even (E) 0b100 – Mark (M)
		0b100 - Mark (M) 0b101 - Space (S)
		0b110 – Reserved
		0b111 – Reserved
14	1	UART Configuration 2 – Secondary Connector.
		This byte denotes the UART configuration 2. A value 0x00 means no serial
		connection is implemented on the Secondary Connector card edge.
		Bits [1:0] denotes the number of stop bits.
		0b00 – No serial connection
		0b01 – 1 stop bit 0b10 – 1.5 stop bits
		0b11 – 2 stop bits
		Bits [3:2] denotes the flow control method.
		0b00 – No serial connection
		0b01 – Software handshaking
		0b10 – No handshaking
		0b11 – Reserved
15	1	Bits [7:4] are reserved and shall be encoded to a value of 0b0000. USB Present – Primary Connector.
	1	
		This byte denotes a USB 2.0 connection is implemented on the Primary Connector card edge.
		0x00 – No USB 2.0 is present or is not implemented on the card edge
		0x01 – A USB 2.0 connection is implemented on the card edge.
16	1	Manageability Type.
		This byte denotes the card manageability type and interface used.
		0x00 – No manageability
		0x01 – RBT Type
		0x02 – MCTP Type 0x03 – RBT + MCTP Type
		0x04-0x0FF – Reserved for future use
17:30	14	Reserved for future use.
		Set each byte to 0xFF for this version of the specification.
31	1	Number of physical controllers (N).
<u> </u>	ı	1

		This byte denotes the number of physical controllers on the OCP NIC 3.0 card. If N=0, no controllers exist on this OCP NIC 3.0 card and this is the last byte in the FRU OEM Record.
		If N≥1, then the controller UUID records below shall be included for each controller N. OCP NIC 3.0 cards may implement up to six physical controllers (N=6) for a LFF card.
32:47	16	Controller 1 UUID (if applicable).
		This field reports the Controller 1 Universally Unique Identifier (UUID) and is used to aid in the dynamic slave address assignment over the SMBus Address Resolution Protocol.
		This field shall list the most significant byte first (to align the FRU order to the reported UUID order on the SMBus). This field is populated with the UUID for Controller 1.
48:63	16	Controller 2 UUID (if applicable).
64:79	16	Controller 3 UUID (if applicable).
80:95	16	Controller 4 UUID (if applicable).
96:111	16	Controller 5 UUID (if applicable).
112:127	16	Controller 6 UUID (if applicable).

4.10.3 FRU Template

A FRU template is provided as a baseline implementation example. This FRU template contains the IPMI Platform Management FRU Information Storage Definition Product Info, Board Info records as well as the OEM record for OCP NIC 3.0.

The FRU template file may be downloaded from the OCP NIC 3.0 Wiki site: http://www.opencompute.org/wiki/Server/Mezz.

5 Routing Guidelines and Signal Integrity Considerations

5.1 NC-SI over RBT

For the purposes of this specification, the OCP NIC 3.0 card NC-SI signals min and max electrical trace length shall be between 2 inches and 4 inches on standard FR4 material. Additional trace length may be achieved with the use of lower loss material. This selection is left up to the card vendor when considering board materials. The traces shall be implemented as 50 Ohm ± 10% impedance controlled nets. This requirement applies to both the SFF and LFF OCP NIC 3.0 cards.

NC-SI over RBT isolation buffers are required on the system board. The requirements for additional addin card loading are reduced. OCP NIC 3.0 card and baseboard designers are encouraged to follow the guidelines defined in the RMII and NC-SI specifications for physical routing. Refer to Section 3.4.4 and the DSP0222 specification for example interconnect topologies.

5.1.1 Timing Budget

TBD – need to align on topologies.

5.2 SMBus 2.0

This section is a placeholder for SMBus 2.0 related routing guidelines and SI considerations. The OCP NIC 3.0 subgroup intends to define the bus operational speed range, capacitive loading, and range of pull up resistance values. Doing so allows the baseboard suppliers to design a SMBus interface that is compatible with OCP NIC 3.0 products.

5.3 PCle

OCP NIC 3.0 card suppliers shall follow the PCIe routing specifications. Refer to the PCIe CEM and PCIe Base specifications for end-to-end channel signal integrity considerations.

5.3.1 Channel Requirements

The OCP NIC 3.0 PCIe channel requirements align with the electrical budget and constraints as detailed in the PCI Express® CEM 4.0 Rev 1.0 and PCI Express Base Specification Rev 4.0. Exceptions or clarifications to the referenced specifications are noted in the sections below.

5.3.1.1 REFCLK requirements

REFCLK requirements are detailed in the PCI Express CEM 4.0 Rev 1.0 Section 2.1.

5.3.1.2 Add-in Card Electrical Budgets

This section defines the OCP NIC 3.0 card channel budget from the gold finger edge to the end point silicon. The values listed below are shown for reference and mirrors that of the PCIe CEM 4.0 specification.

Parameter	PCIe CEM 4.0 Rev 1.0 Specification Section
AC coupling capacitors	Section 4.7.1
Insertion Loss Values (Voltage Transfer	Section 4.7.2 and Appendix A.
Function)	Section 4.7.10 for 16 GT/s
Jitter Values	Section 4.7.3 for 8 GT/s and 16 GT/s.
	Also refer to the PCIe Base Specification
	Section 8.3.5
Crosstalk	Section 4.7.4
Lane-to-lane skew (S _A) for Add-in cards	Section 4.7.5
Transmitter Equalization	Section 4.7.6 and PCIe Base Spec Chapter 9
Skew within a differential pair	Section 4.7.7
Differential data trace impedance	Section 4.7.8
Differential data trace propagation delay	Section 4.7.9

Table 53: PCIe Electrical Budgets

5.3.1.3 Baseboard Channel Budget

The baseboard channel budget directly follows the PCI Express CEM 4.0 Rev 1.0 specification. Details of the budget are outside of the scope of this specification.

5.3.1.4 SFF-TA-1002 Connector Channel Budget

Reference the SFF-TA-1002 Revision 1.1 or later.

5.3.1.5 Differential Impedance (Informative)

For PCIe transmit and receive differential pairs, the target impedance is 85 Ohms ± 10%.

For the PCIe REFCLKs, the target impedance is 100 Ohms \pm 10%.

5.3.2 Test Fixtures

Test Fixtures are designed using the PCIe CEM 4.0 CLB and CBB. The fixtures host interface has been modified to the OCP connector standard and there are two version of the fixtures, one for Gen 3 PCIe and one for Gen 4 PCIe. Careful attention has been placed on these fixtures to help insure that standard test equipment automation should work without significant modification.

Test Fixture	PCIe Generation	PCB Material
Load Board	Gen 3	TU863
	Gen 4	TU883
Base Board	Gen 3	TU863
	Gen 4	TBD (+vISI board)

Table 54: PCIe Test Fixtures for OCP NIC 3.0

5.3.2.1 Load Board

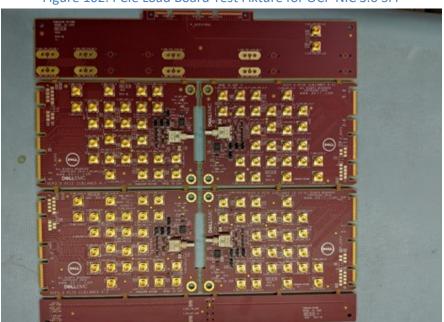


Figure 102: PCIe Load Board Test Fixture for OCP NIC 3.0 SFF

5.3.2.2 Baseboard

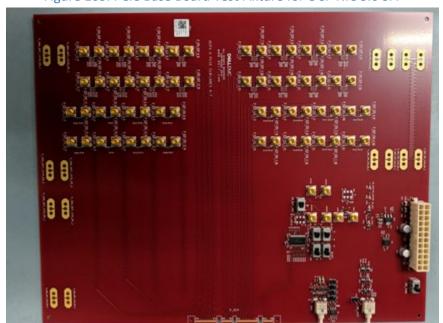


Figure 103: PCIe Base Board Test Fixture for OCP NIC 3.0 SFF

5.3.3 Test Methodology

OCP NIC 3.0 is compliant to the applicable PCIe specifications. The electrical interface may be tested against the PCI Express® Architecture PHY Test Specification Revision 4.0, providing that the appropriate test fixtures from Section 5.3.2 are used.

5.3.3.1 Test Setup

This section is a work-in-progress by the OCP NIC 3.0 SI Subgroup. The following information will be added in a future document release:

- Description of the OCP NIC 3.0 CLB and CBB test figure for use in the PCle Architecture PHY Test Specifications.
- A user guide is in development through UNH.

6 Thermal and Environmental

6.1 Airflow Direction

The OCP NIC 3.0 card is designed to operate in either of two different airflow directions which are referred to as Hot Aisle and Cold Aisle. In both Hot Aisle and Cold Aisle configurations all airflow is directed over the topside of the card. Component placement must assume that there will be no airflow on the bottom side of the card. The local approach air temperature and velocity to the card is dependent on the capability of the system adopting OCP NIC 3.0 card. These parameters may be impacted by the operational altitude and relative humidity in Hot Aisle or Cold Aisle configurations. Design boundary conditions for Hot Aisle and Cold Aisle cooling are included below in Sections 6.1.1 and 6.1.2 respectively.

The two airflow directions of the Hot and Cold Aisle cases should not result in multiple thermal solutions to separately satisfy the varying thermal boundary conditions. Ideally, any specific OCP NIC 3.0 card design should function in systems with either Hot Aisle or Cold Aisle cooling. Thermal analysis in support of this specification have shown the Hot Aisle configuration to be more challenging than Cold Aisle but card vendors should make that determination for each card that is developed.

6.1.1 Hot Aisle Cooling

The airflow in typical server systems will approach from the card edge or heatsink side of the card. This airflow direction is referred to as Hot Aisle cooling and is illustrated below in Figure 104. The term Hot Aisle refers to the card being located at the rear of the system where the local inlet airflow is preheated by the upstream system components (e.g. HDD, CPU, DIMM, etc.).

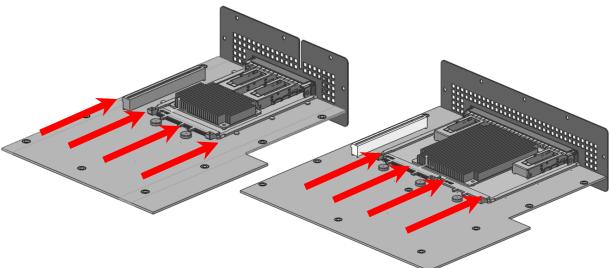


Figure 104: Airflow Direction for Hot Aisle Cooling (SFF and LFF)

The boundary conditions for Hot Aisle cooling are shown below in Table 55 and Table 56. The low temperature is listed at 5°C and assumes fresh air could be ducted to the back of the system from the front. More typically the inlet temperature to the OCP NIC 3.0 card will be in the same range as PCIe cards located at the back of the system (55°C local inlet temperature). Depending on the system design, power density, and airflow the inlet temperature to the OCP NIC 3.0 card may be as high as 60°C or 65°C. The airflow velocities listed in Table 56 represent the airflow velocities typical in mainstream

servers. Higher airflow velocities are available within the Hot Aisle cooling tiers listed in Table 61 but card designers must be sure to understand the system level implications of such high card LFM requirements.

Table 55: Hot Aisle Air Temperature Boundary Conditions

	Low	Typical	High	Max
Local Inlet air	5°C	55°C	60°C	65°C
temperature	(system inlet)	33 C	00 C	05 C

Table 56: Hot Aisle Airflow Boundary Conditions

	Low	Typical	High	Max	
Local inlet air	50 LFM	100-200 LFM	300 LFM	System	
velocity	50 LFIVI	100-200 LFIVI	SUU LFIVI	Dependent	

6.1.2 Cold Aisle Cooling

When installed in the front of a server the airflow will approach from the I/O connector (e.g. SFP, QSFP or RJ45) side of the card. This airflow direction is referred to as Cold Aisle cooling and is illustrated below in Figure 105. The term Cold Aisle refers to the card being located at the front of the system where the local inlet airflow is assumed to be the same temperature as the system inlet airflow.

Figure 105: Airflow Direction for Cold Aisle Cooling (SFF and LFF)

The boundary conditions for Cold Aisle cooling are shown below in Table 57 and Table 58. The temperature values listed in Table 57 assume the inlet temperature to the OCP NIC 3.0 card to be the same as the system inlet. The low, typical, high, and max temperatures listed align with the ASHRAE A1, A2, A3, and A4 environmental classes. Depending on the system, the supported ASHRAE class may limit the maximum temperature to the OCP 3.0 NIC card. However, for more broad industry support, cards should be designed to the upper end of the ASHRAE classes (i.e. A4).

Table 57: Cold Aisle Air Temperature Boundary Conditions

	Low	Typical	High	Max
Local Inlet Air	L ₀ C	25-35°C	40°C	45°C
Temperature	5°C	ASHRAE A1/A2	ASHRAE A3	ASHRAE A4

Low Typical High Max

Local Inlet Air
Velocity 50 LFM 100 LFM 200 LFM Dependent

Table 58: Cold Aisle Airflow Boundary Conditions

6.2 Thermal Design Guidelines

The information in this section is intended to serve as a quick reference guide for OCP NIC 3.0 designers early in the design process. The information should be used as a reference for upfront thermal design and feasibility and should not replace detailed card thermal design analysis. The actual cooling capability of the card shall be defined based on the testing with the OCP NIC 3.0 thermal test fixture as defined in Section 6.4.

6.2.1 SFF Card ASIC Cooling – Hot Aisle

The ASIC or controller chip is typically the highest power component on the card. Thus, as OCP NIC 3.0 cards are developed it is important to understand the ASIC cooling capability. Figure 106 below provides an estimate of the maximum ASIC power that can be supported as a function of the local inlet velocity for the SFF card in a hot aisle cooling configuration. Each curve in Figure 106 represents a different local inlet air temperature from 45°C to 65°C.

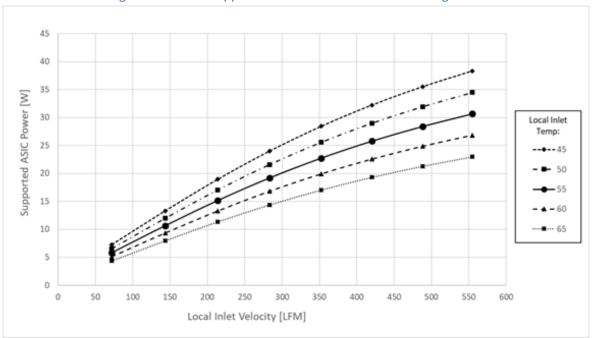


Figure 106: ASIC Supportable Power for Hot Aisle Cooling – SFF

The curves shown in Figure 106 were obtained using CFD analysis of a reference OCP NIC 3.0 SFF card. The reference card has a 20 mm x 20 mm ASIC with two QSFP connectors. Figure 107 shows a comparison of the 3D CAD and CFD model geometry for the reference OCP NIC 3.0 card. Additional card geometry parameters and boundary conditions used in the reference CFD analysis are summarized in Table 59. The OCP NIC 3.0 simulation was conducted within a virtual version of the test fixture defined in Section 6.4.

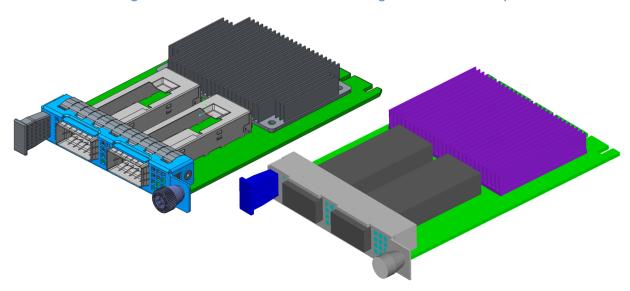


Figure 107: OCP NIC 3.0 SFF Reference Design and CFD Geometry

Table 59: Reference OCP NIC 3.0 SFF Card Geometry

OCD NIC 2 O Form Footor	CEE Cond		
OCP NIC 3.0 Form Factor	SFF Card		
Heatsink Width	65 mm		
Heatsink Length	45 mm		
Heatsink Height	9.24 mm		
Heatsink Base Thickness	1.5 mm		
Fin Count/Thickness	28/0.5 mm		
Heatsink Material	Extruded Aluminum		
ASIC Width	20		
ASIC Length	20		
ASIC Height	2.26		
ASIC Theta-JC	0.17 C/W		
ASIC Theta-JB	10 C/W		
OCP PCB In-Plane Conductivity	34 W/mK		
OCP PCB Normal Conductivity	0.33 W/mK		
ASIC Max T-case	95°C		
OCP NIC 3.0 I/O Connectors	Two QSFP @ 3.5 W each		

An increase in the supported ASIC power or a decrease in the required airflow velocity may be achieved through heatsink size and material changes. For example, a larger heatsink or a heatsink made out of copper could improve ASIC cooling and effectively shift up the supportable power curves shown in Figure 106.

It is important to point out that the curves shown in Figure 106 represent only the maximum ASIC power that can be supported vs. the supplied inlet velocity. Other heat loads on the card may require airflow velocities above and beyond that required to cool the ASIC. SFP or QSFP optical transceivers located downstream of the AISC will in many cases pose a greater cooling challenge than the ASIC cooling.

Cooling the optical transceivers becomes even more difficult as the ASIC power is increased due to additional preheating of the air as it moves through the ASIC heatsink. OCP NIC 3.0 designers must consider all heat sources early in the design process to ensure the card thermal solution is sufficient for the feature set.

Card designers must also consider the airflow capability of the server systems that the cards are targeted for use within. Figure 108 below shows the SFF ASIC supportable power curves with an overlay of three server airflow capability ranges. Designers must ensure that their thermal solutions and resulting card airflow requirements fall within the range of supportable system airflow velocity. Cards that are under-designed (e.g. require airflow greater than the system capability) will have thermal issues when deployed into the server system. Card designers are advised to work closely with system vendors to ensure they target the appropriate airflow and temperature boundary conditions.

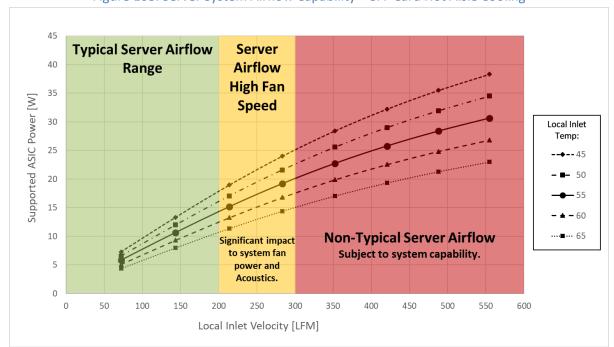


Figure 108: Server System Airflow Capability – SFF Card Hot Aisle Cooling

6.2.2 LFF Card ASIC Cooling – Hot Aisle

Figure 109 below provides an estimate of the maximum ASIC power that can be supported as a function of the local inlet velocity for the LFF card in a hot aisle cooling configuration. Each curve in Figure 109 represents a different local inlet air temperature from 45°C to 65°C.

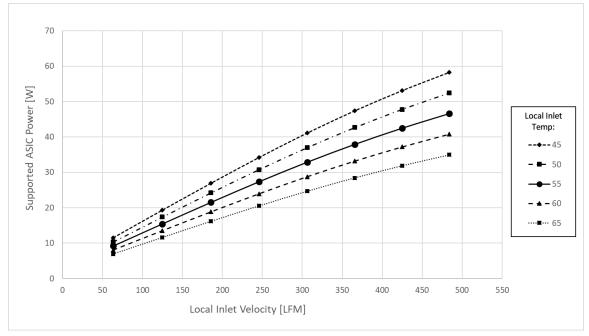


Figure 109: ASIC Supportable Power for Hot Aisle Cooling – LFF Card

The curves shown in Figure 109 were obtained using CFD analysis of the reference OCP NIC 3.0 LFF card. The reference card has a 45 mm x 45 mm ASIC with two QSFP connectors. Additional card geometry parameters and boundary conditions used in the reference CFD analysis are summarized in Table 60. Figure 110 shows a comparison of the 3D CAD and CFD model geometry for the reference OCP NIC 3.0 card.

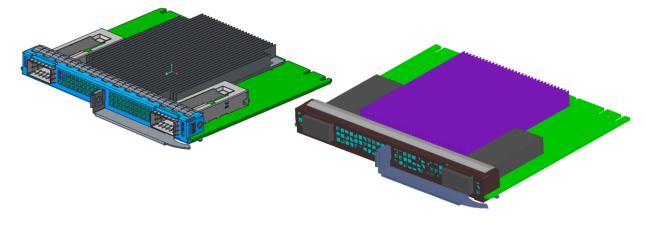


Figure 110: OCP NIC 3.0 LFF Reference Design and CFD Geometry

Table 60: Reference OCP NIC 3.0 LFF Card Geometry

OCP NIC 3.0 Form Factor	LFF Card
Heatsink Width	75 mm
Heatsink Length	85 mm
Heatsink Height	9.3 mm
Heatsink Base Thickness	1.5 mm
Fin Count/Thickness	33/0.5 mm
Heatsink Material	Extruded Aluminum
ASIC Width	45
ASIC Length	45
ASIC Height	2.13
ASIC Theta-JC	0.17 C/W
ASIC Theta-JB	10 C/W
OCP PCB In-Plane Conductivity	34 W/mK
OCP PCB Normal Conductivity	0.33 W/mK
ASIC T-case Max	95°C
OCP NIC 3.0 I/O Connectors	Two QSFP @ 3.5 W each

It is important to note that the supportable power for the LFF card is considerably higher than for the SFF card due to the increased size of the ASIC heatsink. In addition, optics module cooling on the LFF card will also be considerably improved due to the arrangement of the optics in parallel to the ASIC heatsink rather than in series. These thermal advantages are key drivers for the LFF card geometry. The OCP NIC 3.0 simulation was conducted within a virtual version of the LFF card test fixture defined in Section 6.4.

Figure 111 below shows the LFF ASIC supportable power curves with an overlay of three server airflow capability ranges. Designers must ensure that their thermal solutions and resulting card airflow requirements fall within the range of supportable system airflow velocity. Cards that are under-designed (e.g. require airflow greater than the system capability) will have thermal issues when deployed into the server system. Card designers are advised to work closely with system vendors to ensure they target the appropriate airflow and temperature boundary conditions.

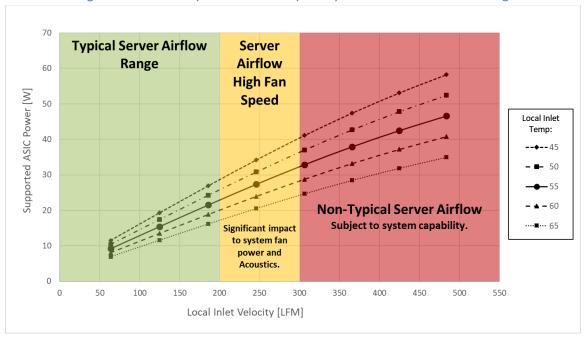


Figure 111: Server System Airflow Capability – LFF Card Hot Aisle Cooling

6.2.3 SFF Card ASIC Cooling – Cold Aisle

Compared to the Hot Aisle cooling configuration, there are several key differences for Cold Aisle ASIC cooling. With Cold Aisle cooling the airflow is pulled from the I/O connector side of the card. The I/O connectors and faceplate venting may affect the airflow through the ASIC heatsink. The I/O connectors may also preheat the airflow by some amount. In a Cold Aisle cooling configuration, other parallel airflow paths may result in less airflow passing over and through the OCP NIC 3.0 card compared to the Hot Aisle.

The ASIC cooling analysis for the SFF Card in the Cold Aisle configuration was conducted utilizing the same geometry and boundary conditions described in Figure 107 and Table 59 with airflow moving from I/O connector to ASIC (opposite to the Hot Aisle analysis). Figure 112 below shows the results of this analysis for the Cold Aisle cooling configuration. Each curve in Figure 112 represents a different system inlet air temperature from 25°C to 45°C.

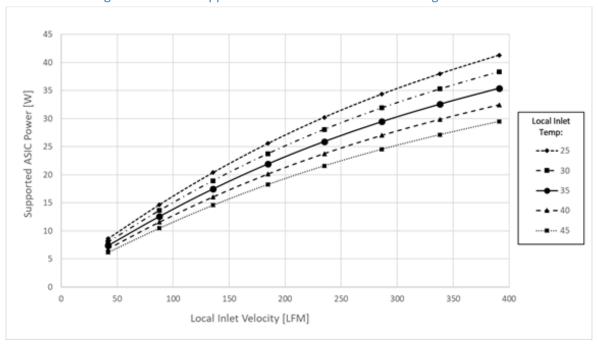


Figure 112: ASIC Supportable Power for Cold Aisle Cooling – SFF Card

Similar to Figure 108 for Hot Aisle cooling, Figure 113 below shows the ASIC supportable power curves with an overlay of three Cold Aisle server airflow capability ranges. Designers must ensure that their thermal solutions and resulting card airflow requirements fall within the range of supportable Cold Aisle system airflow velocity. Cards that are under-designed (e.g. require airflow greater than the system capability) will have thermal issues when deployed into the server system. Card designers are advised to work closely with system vendors to ensure they target the appropriate airflow and temperature boundary conditions for both Hot and Cold Aisle cooling.

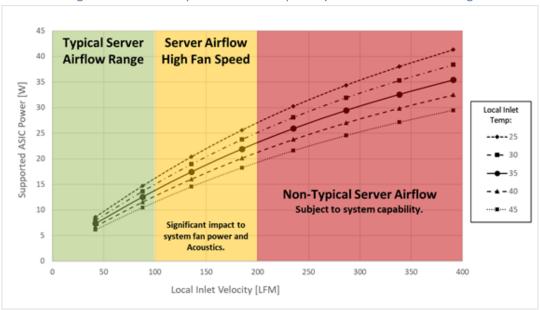


Figure 113: Server System Airflow Capability – SFF Cold Aisle Cooling

A comparison of Hot Aisle (55°C) and Cold Aisle (35°C) SFF ASIC cooling capability curves is shown below in Figure 114. The comparison shows the Hot Aisle ASIC cooling capability at 12 W at 150 LFM while the cold Aisle cooling capability shows support for 19 W at 150 LFM. In general, based on the reference geometry, the Cold Aisle cooling configuration allows for higher supported ASIC power at lower velocities due primarily to the lower inlet temperatures local to the OCP NIC 3.0 card when in the Cold Aisle cooling configuration.

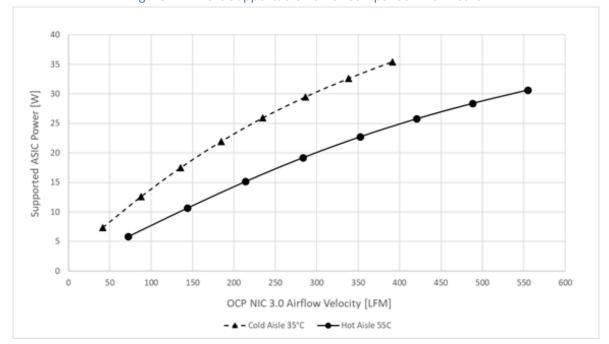


Figure 114: ASIC Supportable Power Comparison – SFF Card

6.2.4 LFF Card ASIC Cooling – Cold Aisle

The ASIC cooling analysis for the LFF card in Cold Aisle configuration was conducted utilizing the same geometry and boundary conditions described in Figure 110 and Table 60 with airflow moving from I/O connector to ASIC (opposite to the Hot Aisle analysis). Figure 115 below shows the results of this analysis for the Cold Aisle cooling configuration. Each curve in Figure 115 represents a different system inlet air temperature from 25°C to 45°C.

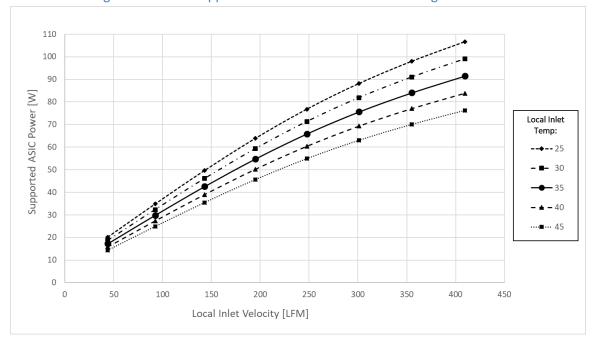


Figure 115: ASIC Supportable Power for Cold Aisle Cooling – LFF Card

Similar to Figure 113 for LFF Hot Aisle cooling, Figure 116 below shows the LFF ASIC supportable power curves with an overlay of three Cold Aisle server airflow capability ranges. Designers must ensure that their thermal solutions and resulting card airflow requirements fall within the range of supportable Cold Aisle system airflow velocity. Cards that are under-designed (e.g. require airflow greater than the system capability) will have thermal issues when deployed into the server system. Card designers are advised to work closely with system vendors to ensure they target the appropriate airflow and temperature boundary conditions for both Hot and Cold Aisle cooling.

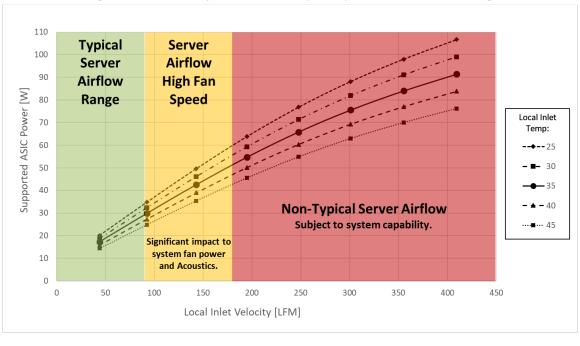


Figure 116: Server System Airflow Capability – LFF Cold Aisle Cooling

A comparison of Hot Aisle (55°C) and Cold Aisle (35°C) LFF ASIC cooling capability curves is shown below in Figure 117. The comparison shows the Hot Aisle ASIC cooling capability at 19 W at 150 LFM while the cold Aisle cooling capability shows support for 42 W at 150 LFM. In general, based on the reference geometry, the Cold Aisle cooling configuration allows for higher supported ASIC power at lower velocities due primarily to the lower inlet temperatures local to the OCP NIC 3.0 card when in the Cold Aisle cooling configuration.

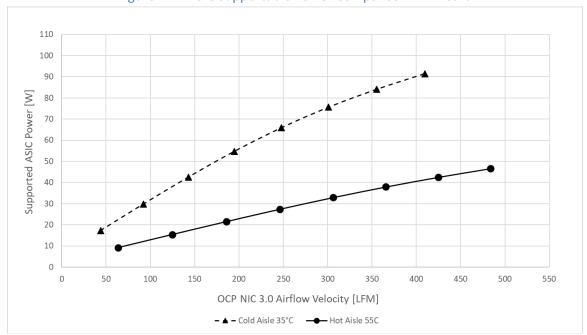


Figure 117: ASIC Supportable Power Comparison – LFF Card

6.3 Thermal Simulation (CFD) Modeling

CFD models of the SFF and LFF cards developed for the analysis detailed in Section 6.2 are available for download on the OCP NIC 3.0 Wiki: http://www.opencompute.org/wiki/Server/Mezz

The thermal models available on the wiki site are in Icepak format. CAD step file exports from those models are also available to aid in re-creation of the models in other CFD software tools. Note that the geometry utilized in the CFD models is based on the OCP NIC 3.0 thermal test fixture detailed in Section 6.4.

Thermal simulation of OCP NIC 3.0 cards using the provided CFD models is recommended. Ideally, vendors developing OCP NIC 3.0 cards would perform CFD analysis to validate card thermal solutions using the provided CFD models prior to building card prototypes. One prototypes are available, vendors would then perform thermal testing on the functional cards using the thermal test fixtures detailed in Section 6.4.

6.4 Thermal Test Fixture

Thermal test fixtures have been developed for SFF and LFF OCP NIC 3.0 cards. The test fixtures are intended to provide a common thermal test platform for card vendors, server vendors, and other industry groups planning to develop or utilize the OCP NIC 3.0 card form factors. Details of the thermal test fixtures are as follows:

- Sheet metal side walls, base, faceplate, and top cover
- Thumbscrew top cover access
- PCB sandwiched between base and side walls
- Intended for attachment to wind tunnel or flow bench such as those available at:

http://www.fantester.com/

- Allows for thermal testing of functional OCP NIC 3.0 cards in a metered airflow environment
- Input power from external power supplies allows for OCP NIC 3.0 card power measurement
- Power connections for 3.3 V, GND, GND, 12 V (SFF)
- Power connections for 3.3 V, GND, GND, GND, 12 V, 12 V (LFF)
- RJ45 connector for NC-SI pass-through
- USB Type-X connector for microprocessor connectivity
- Functions as a remote PCIe extension with intent to position host server under the fixture for connection to system PCIe slot
- Single x16 connection to server host on bottom side of the fixture PCB (SFF)
- Dual x16 connection to server host on bottom side of the fixture PCB (LFF)
- Predefined locations for fixture airflow/temperature sensors on fixture PCB silkscreen. Quantity 3x per board.
- Quantity 4x for LFF see Figure 123

• Candlestick style sensors are available at:

https://www.qats.com/Products/Instruments/Temperature-and-Velocity-Measurement/Sensors/Candlestick-Sensor

- Candlestick sensors must be procured separately, not integrated with fixture PCB
- Blockage above OCP3 card to mimic system geometry and prevent airflow bypass
- Low profile PCIe card for SFF fixture
- Block sheet metal obstruction built into the top cover for the LFF fixture

CAD Files for the current revision of the test fixture are available for download on the OCP NIC 3.0 Wiki: http://www.opencompute.org/wiki/Server/Mezz.

6.4.1 Test Fixture for SFF Card

Images of the SFF thermal test fixture are shown in Figure 118 and Figure 119. The SFF fixture PCB is shown in Figure 120. Note the three candlestick sensor locations directly next to the OCP NIC 3.0 connectors.

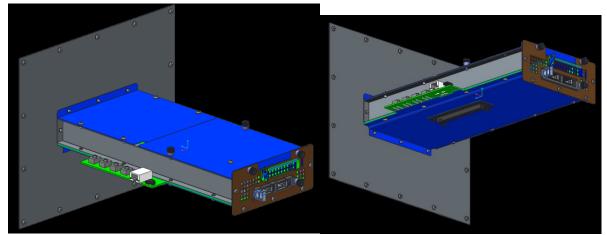


Figure 118: SFF Thermal Test Fixture Preliminary Design

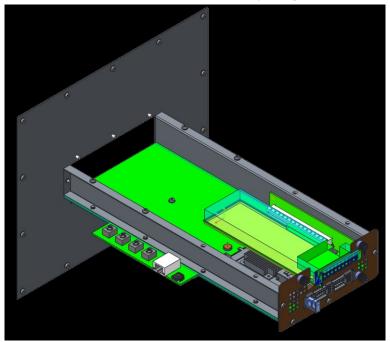
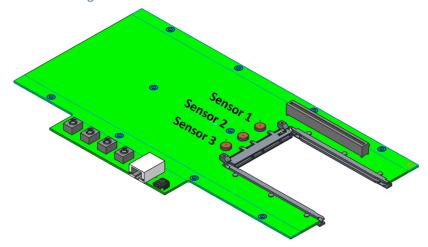


Figure 119: SFF Thermal Test Fixture Preliminary Design – Cover Removed





6.4.2 Test Fixture for LFF Card

Images of the LFF thermal test fixture are shown in Figure 121 and Figure 122. The LFF fixture PCB is shown in Figure 123. Note the three candlestick sensor locations directly next to the OCP NIC 3.0 connectors.

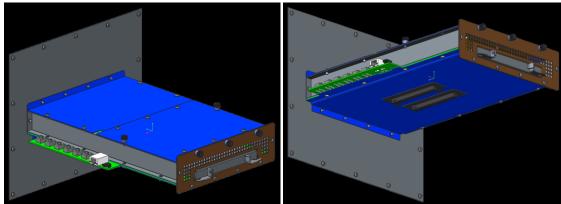


Figure 121: LFF Card Thermal Test Fixture Design

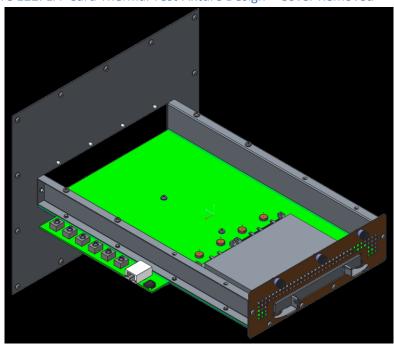
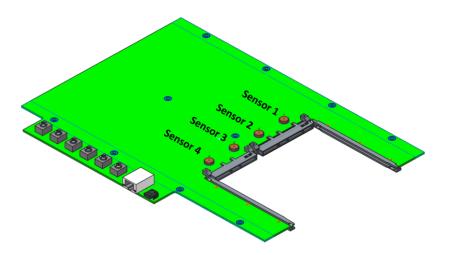


Figure 122: LFF Card Thermal Test Fixture Design – Cover Removed

Figure 123: LFF Card Thermal Test Fixture PCB



6.4.3 Test Fixture Airflow Direction

When utilizing the OCP NIC 3.0 thermal test fixture, the wind tunnel or flow bench must be configured to push airflow for hot aisle cooling or to pull airflow for cold aisle cooling a shown in Figure 124.

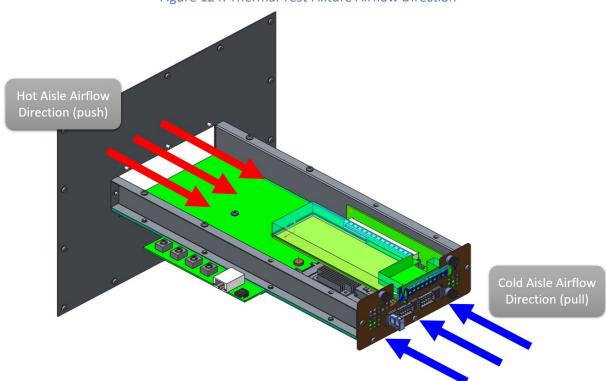


Figure 124: Thermal Test Fixture Airflow Direction

6.4.4 Thermal Test Fixture Candlestick Sensors

As noted in previously, candlestick sensor locations are included on the fixture PCB silkscreen. These candlestick sensors provide point measurements for both airflow velocity (LFM) and air temperature. The airflow at the inlet to the OCP NIC 3.0 will differ from the fixture mean velocity due to the obstructions above the OCP NIC 3.0 cards within the fixture. Thus, the fixture flow rate and cross-sectional area should not be used to determine the local velocity at the OCP NIC 3.0 card. Instead, the candlestick velocity/temperature sensors should be utilized to directly measure the local inlet velocity to the cards for hot aisle cooling.

Figure 125 and Figure 126 below show the air velocity at each sensor location vs. the total fixture flow rate in CFM. The curves shown in these figures are based on the data collected from the CFD models discussed in Section 6.3. Note the error between the velocities obtained from the sensor locations vs. the velocity based on the duct cross-sectional area.

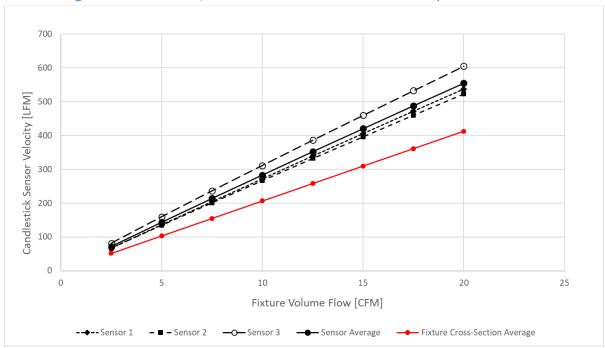
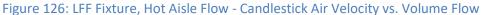
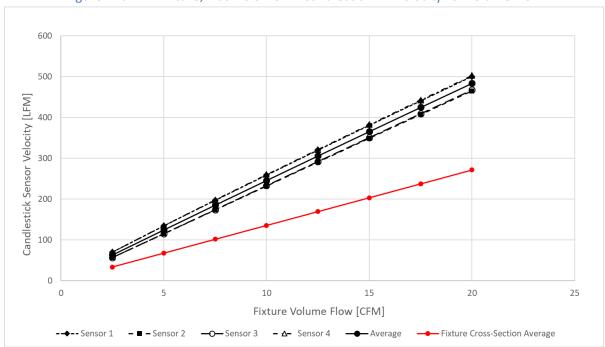


Figure 125: SFF Fixture, Hot Aisle Flow - Candlestick Air Velocity vs. Volume Flow





6.5 Card Sensor Requirements

See Sections 4.4 to 4.6 for information relating to temperature sensor and reporting requirements.

6.6 Card Cooling Tiers

Section 4.10.2 defines a number of registers that may be read by the associated baseboard system. Two of these registers provide the Hot Aisle and Cold Aisle Card Cooling Tiers that may be used for fan speed control. The Card Cooling Tiers relate the card local inlet temperature to the required local inlet velocity which allows the system to set fan speeds according to the cooling requirements of the card.

The Card Cooling Tier registers are particularly useful for systems that do not implement temperature sensor monitoring. The registers may also be used as a backup for cards that do implement temperature sensor monitoring.

6.6.1 Hot Aisle Cooling Tiers

Card Cooling Tiers for Hot Aisle Cooling are defined in Table 61. The values in the table are listed with units shown in LFM. Future releases of this specification will provide more detail to the Card Cooling Tier curve definition.

	Target Operating Region				Server . High Fa	Airflow n Speed	Non-Ty	pical Serv	er Airflo	w - Subject	to System (Capability
OCP NIC 3.0 Local Inlet Temperature [°C]	Tier 1	Tier 2	Tier 3	Tier 4	Tier 5	Tier 6	Tier 7	Tier 8	Tier 9	Tier 10	Tier 11	Tier 12
5												
10												
15			Wor	ا_مانحا	Dra.a.	-O.G.G.						
20			VVOI		TUBI	C33						
25												
30												
35												
40												
45												
50												
55	50	100	150	200	250	300	350	400	450	500	750	1000
60												
65												

Table 61: Hot Aisle Card Cooling Tier Definitions (LFM)

6.6.2 Cold Aisle Cooling Tiers

Card Cooling Tiers for Cold Aisle Cooling are defined in Table 62. The values in the table are listed with units shown in LFM. Future releases of this specification will provide more detail to the Card Cooling Tier curve definition.

Server Airflow Target Operating Region Non-Typical Server Airflow - Subject to System Capability **High Fan Speed** OCP NIC 3.0 Local Tier 1 Tier 2 Tier 3 Tier 4 Tier 5 Tier 6 Tier 7 Tier 8 Tier 9 Tier 10 Tier 11 Tier 12 Inlet Temperat ure [°C] 5 10 15 20 25 30 Work-in-Progress 350 35 400 450 500 750 1000 40 45 50 55 60 65

Table 62: Cold Aisle Card Cooling Tier Definitions (LFM)

6.7 Non-Operational Shock & Vibration Testing

OCP NIC 3.0 components are deployed in various environments. As such, all OCP NIC 3.0 cards shall be subjected to shock and vibration testing to ensure products do not sustain damage during normal operational or transportation conditions. While end customer deployments may require an additional final system level test, this section sets the minimum shock and vibration requirements for an OCP NIC 3.0 card that must also be considered.

Shock and vibration testing shall be done in accordance with the procedures listed below. The tests shall be conducted using a vertical shock table. The OCP NIC 3.0 card shall be secured in the standard test fixture as described in Section 6.7.1.

6.7.1 Shock & Vibe Test Fixture

TBD. Working group to provide description and mechanical details and figures.

6.7.2 Test Procedure

The following procedures shall be followed for the shock and vibration testing:

- A minimum sample size of three OCP NIC 3.0 cards shall be subjected to shock and vibration.
- All samples shall be verified for functionality prior to test.
- The OCP NIC 3.0 card shall be fixtured to simulate how the card will be mounted within a system. For example, the OCP NIC 3.0 card may be fixtured in the horizontal plane with the primary component side facing up for certain chassis configurations.
- The fixture shall be tested on all 6 sides. Each side shall be clearly labeled as 1-6 for test identification purposes. Testing shall be performed in the vertical axis only. The fixture shall be rotated until all six sides have been tested as the product may be dropped from any orientation during handling. Testing shall not be conducted on a three axis slip table.
- Non-operational vibration testing is performed at 1.88 G_{RMS} for a duration of 15 minutes per side for all six surfaces per Table 63.

	_
Frequency (Hz)	G²/Hz
10	0.13
20	0.13
70	0.004
130	0.004
165	0.0018
500	0.0018

Table 63: Random Virbation Testing 1.88 G_{RMS} Profile

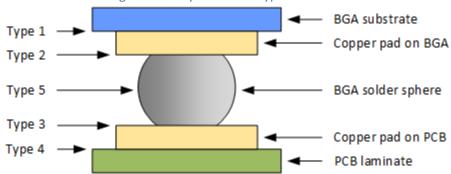
- Non-operational half-sine shock test at 71 G ±5% with a 2 ms duration. All six sides shall be tested.
- Non-operational square wave shock test at 32 G ±5% at a rate of 270 inches/sec. All six sides shall be tested.
- All cards shall be checked for proper operation after the shock and vibration tests have been conducted. All three samples must be in full operating order to consider the product as a pass.

6.8 Dye and Pull Test Method

All Dye and Pull test methods shall be implemented per the IPC-TM-650 method 2.4.53 (Dye and Pull Test Method – formerly known as Dye and Pry). The Dye and Pull test uses a colored dye penetrant to visually indicate cracked solder joints on BGA devices. The test shall only be conducted after the Shock and Vibration testing has been conducted on the test samples. The Dye and Pull Test Method is a destructive test.

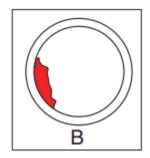
- A minimum sample size of three OCP NIC 3.0 cards shall be subjected to the Dye and Pull Test Method.
- All samples shall be first subjected to the Shock and Vibration testing outlined in Section 6.7.
- All samples shall be subjected to the preparation and test procedures of IPC-TM-650 method 2.4.53.
- Following the pull-test operation, the board sample shall be examined for dye indication at the target BGA area. Separation locations are categorized in to the following five areas:
 - Type 1 Separation between the BGA copper pad and the BGA substrate.
 - Type 2 Separation between the BGA copper pad and the BGA solder sphere.
 - Type 3 Separation between the BGA solder sphere and the copper pad on the PCB.
 - Type 4 Separation between the copper pad on the PCB and the PCB laminate.
 - Type 5 Separation of the BGA solder sphere.

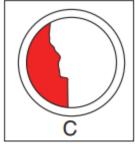
Figure 127: Dye and Pull Type Locations

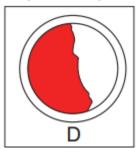


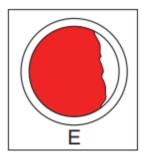
- Samples shall be subjected to the following failure criteria:
 - Dye coverage of >50% ("D" and "E" in Figure 128) of any Type 2 or Type 3 BGA cracks are present in the test sample.
 - One or more Type 1 or Type 4 BGA cracks are present in the test sample.

Figure 128: Dye Coverage Percentage









The following exceptions are allowed:

- For "via-in-pad" designs, dye is allowed on the laminate surface (under the pad), as long as the dye has not entered the inner-via laminate area, or is found on the separated via-barrel wall.
- Allowances for dye indications exceeding the 50% limit on mechanical (non-electrical) BGA corner locations or multiple use locations (grounds, powers) may be determined by the appropriate Engineering Team.

6.9 Gold Finger Plating Requirements

This section defines the minimum plating/quality requirements for the OCP NIC 3.0 gold fingers.

6.9.1 Host Side Gold Finger Plating Requirements

Per Section 6.4 (Environmental Requirements) of the PCIe CEM specification, the minimum host side gold finger plating is 30 microinches of gold over 50 microinches of nickel. OCP NIC 3.0 card vendors shall individually evaluate the minimum plating required.

The recommendation for OCP NIC 3.0 is to 30 microinches of gold over 150 microinches of nickel.

6.9.2 Line Side Gold Finger Durability Requirements

The line side connectors must be designed to support a minimum of 250 error free insertion cycles. In order to accomplish this, it is required that the minimum contact plating be as follows:

- SFP and QSFP connectors: 30 microinches of gold over 50 microinches of nickel
- RJ45 connectors have a minimum of 50 microinches of gold over 50 microinches of nickel

7 Regulatory

7.1 Required Compliance

An OCP NIC 3.0 card shall meet the following Environmental, EMC and safety requirements.

Note: Emissions and immunity tests in Section 7.1.4 are to be completed at the system level. The OCP NIC 3.0 vendors should work with the system vendors to achieve the applicable requirements listed in this section.

7.1.1 Required Environmental Compliance

- China RoHS Directive
- **EU RoHS 2 Directive (2011/65/EU)** aims to reduce the environmental impact of electronic and electrical equipment (EEE) by restricting the use of certain hazardous materials. The substances banned under RoHS are lead, mercury, cadmium, hexavalent chromium, polybrominated biphenyls, polybrominated diphenyl ether, and four phthalates.
- **EU REACH Regulation (EC) No 1907/2006** addresses the production and use of chemical substances and their potential impact on human health and the environment.
- **EU Waste Electrical and Electronic Equipment ("WEEE")** Directive (2012/19/EU) mandates the treatment, recovery and recycling of EEE.
- The Persistent Organic Pollutants Regulation (EC) No. 850/2004 bans production, placing on the market and use of certain persistent organic pollutants.
- The California Safe Drinking Water and Toxic Enforcement Act of 1986 ("Prop 65") sets forth a list of regulated chemicals that require warnings in the State of California.
- The Packaging and Packaging Waste Directive 94/62/EC limits certain hazardous substances in the packaging materials
- Batteries Directive 2006/66/EC regulates the manufacture and disposal of all batteries and accumulators, including those included in appliances.

7.1.2 Required EMC Compliance

• Radiated and Conducted Emissions requirements are based on deployed geographical locations. Refer to Table 64 for details.

Table 64: FCC Class A Radiated and Conducted Emissions Requirements Based on Geographical Location

Targeted Geography	Applicable Specifications
USA	FCC, 47 CFR Part 15, Class A digital device (USA)
Canada	ICES-003, class A (CAN)
EU	EN 55032: 2015+AC:2016 Class A Radiated and Conducted Emissions requirements for European Union
	EN 55024: 2010+A1:2015 Immunity requirements for European Union (EU)
Australia/New Zealand	AS/NZS CISPR 32:2015 Class A
	CISPR 32:2015 for Radiated and Conducted Emissions requirements
Japan	VCCI 32-1 Class A Radiated and Conducted Emissions requirements

Korea	KN32 – Radiated and Conducted Emissions	
	KN35- Immunity	
Taiwan	BSMI CNS13438: 2006 (complete) Class A Radiated and Conducted Emissions requirements	

- **CE** Equipment must pass the CE specification
- All technical requirements covered under EMC Directive (2014/30/EU)

7.1.3 Required Product Safety Compliance

• Safety - requirements are listed in Table 65.

Table 65: Safety Requirements

Targeted Category	Applicable Specifications
Safety	UL 60950-1/CSA C22.2 No. 60950-1-07, 2nd Edition + Amendment 1 + Amendment 2, dated 2011/12/19.
	The Bi-National Standard for Safety of Information Technology Equipment, EN60950-1: 2006+A11:2009+A1:2010+A12:2010+A2:2013
	IEC 60950-1 (Ed 2) + A1 + A2.
	62368-1 may also be co-reported depending on region

7.1.4 Required Immunity (ESD) Compliance

The OCP NIC 3.0 card shall meet or exceed the following ESD immunity requirements listed in Table 66.

Table 66: Immunity (ESD) Requirements

Targeted Category	Applicable Specifications
Immunity (ESD)	EN 55024 2010, and IEC 61000-4-2 2008 for ESD. Required ±4 kV contact charge and ±8 kV air discharge
NEBS Level 3 (optional)	Optionally test devices to NEBS Level 3 –
	Required ± 8 kV contact charge and ± 15 kV air discharge with interruptions not greater than 2 seconds. The device shall self-recover without operator intervention.
	Note: NEBS compliance is part of the system level testing. The OCP NIC 3.0 specification is providing a baseline minimum recommendation for ESD immunity.

7.2 Recommended Compliance

All OCP NIC 3.0 cards are required to meet the requirements specified in Section 7.1. Card vendors should also consider meeting the requirements below.

7.2.1 Recommended Environmental Compliance

- **Halogen Free:** IEC 61249-2-21 Definition of halogen free: 900ppm for Bromine or Chlorine, or 1500ppm combined total halogens.
- Arsenic: 1000 ppm (or 0.1% by weight)

• Emerging: US Conflict Minerals law: section 1502 of the Dodd-Frank Act requires companies using tin, tantalum, tungsten, and gold ("3TG") in their products to verify and disclose the mineral source. While this does not apply to products that are used to provide services, such as Infrastructure hardware products, the OCP NIC Subgroup is considering voluntarily reporting of this information.

7.2.2 Recommended EMC Compliance

• FCC, 47 CFR Part 15, Subpart B Class A digital device (USA) with 10dB margin. Refer to the baseline requirements shown in Section 7.1.2 for details.

8 Revision History

Author	Description	Revision	Date
OCP NIC 3.0 Subgroup	Initial public review.	0.70	01/25/2018
OCP NIC 3.0 Subgroup	 Implemented comments from 0.70 review. LED implementation updated. Gold finger lengths updated. All pins are full length except for PCIe TX/RX, REFCLKS and PRSNT pins. 	0.71	02/06/2018
OCP NIC 3.0 Subgroup	- Updates to Section 4.x per the working group session.	0.72	02/21/2018
OCP NIC 3.0 Subgroup	- Change NC-SI over RBT RXD/TXD pins to a pull-up instead of a pull down. - Update power sequencing diagram. REFCLK is disabled before silicon transitions to AUX Power Mode. - Merge pinout sections 3.4 and 3.5 together for structural clarity. - Add text to gate WAKE# signal on AUX_PWR_GOOD (internal) assertion; updated diagrams with WAKE# signals to reflect implementation. - Add initial signal integrity outline to document (WIP) - Add Initial draft of the Shock and Vibration, and Dye and Pull test requirements. - Rearrange Section 2 for structure; changed section name to Mechanical Card Form Factor - Move non-NIC use cases to Section 1.5. - Moved Port numbering and LED definitions to Section 3.8. - Add secondary side LED placement for 4x SFP and 2x QSFP implementations in Section 3.8. - Revised labeling section (Section 2.9). - Optimize the scan chain LED bit stream for dual port applications. - Add SLOT_ID[1]. Updated text and diagrams for mapping SLOT_ID[1:0] to Package ID[2:0] and FRU EEPROM A[2:0] fields. - Reduce ID Mode power consumption on +12V_EDGE	0.73	05/01/2018
OCP NIC 3.0 Subgroup	 Text clean up. All minor / generally agreed upon items within the OCP NIC 3.0 Workgroup have been accepted. Clarify PCIe bifurcation is on a per-slot basis. Add 1x32 and 2x16 implementation examples for a Large Form Factor card. Removed reference to a x24 PCIe width LFF card from Table 5 – OCP NIC 3.0 Card Definitions. Move SLOT_ID[1] to OCP_A6 for immediate power on indication of the card physical location for RBT and FRU EEPROM addressing. Updated RBT addressing and Scan Chain definition to match. Updated diagrams and text in Section 6.x based on feedback from the OCP NIC 3.0 Thermal Workgroup. Updated diagrams and text in Section 2.0 based on feedback received from the OCP NIC 3.0 Mechanical Workgroup. 	0.74	06/04/2018
OCP NIC 3.0 Subgroup	0v80 public release	0.80	06/04/2018
OCP NIC 3.0 Subgroup	Ov81 public release. Changes are as follows: - Section 1.3 - Update Figure 1 with latest thumbscrew design Section 2.4.2 - Mechanical corrections to BOM items 5, 6A/B, 8 & 11 Section 3.4.3 - Add statement to isolate SMRST# if target device voltage is not powered from +3.3V_EDGE Section 3.4.4 - Clarified the RBT_ARB_IN and RBT_ARB_OUT pin descriptions.	0.81	07/06/2018

	 Section 3.4.4 - Clarified SLOT_ID[1:0] description and example diagrams; move SLOT_ID[1:0] isolation to NIC and use direct connection to FRU EEPROM. Section 3.4.5 - DATA_IN bit PRSNTB[3:0] definition to optionally use pull up/down to match PRSNTB[3:0]# card edge connections. Section 3.4.7 - Add USB 2.0 definition to the Primary Connector. Section 3.4.8 - Add UART definition to the Secondary Connector. Section 3.4.9 - Changed Miscellaneous pins to RFU[1:2] pins. Section 3.8 - Clarified LED placement. Section 3.9.x - Clarified ID-Aux and Aux-Main Power Mode transition requirements to prevent sampling health status pins until cards have fully entered into Aux and Main modes to prevent false indication. Section 3.11 - Updated hot swap consideration text to highlight available hot swap mechanisms. Actual hot swap design is outside the scope of this specification. Section 4 - Update MCTP Type management description. Section 4.9 - Clarified the FRU EEPROM is directly connected to the card edge. No isolation is used for the FRU EEPROM. 		
OCP NIC 3.0 Subgroup	 Minor editorial changes. Changed names to "SFF" and "LFF" when referencing the two board form factors for uniformity. Section 3.4.1 – Changed PERST[3:0]# to be asserted low until the platform is ready to bring cards out of reset. Section 3.5.3 – Corrected typos in the PCle Bifurcation Decoder (Table 31) for hosts that implement 4 x2 links on the first 8 lanes when using a 4 x4 OCP NIC 3.0 card. Section 3.5.5.3 & 3.5.5.4 – Corrected the BIF[2:0] values in the diagrams. Section 3.7 – Corrected typos in the PCle Bifurcation result and REFCLK mapping (Table 38 and Table 41) for single host/quad host cases with PCle on the first 8 lanes. This change was due to propagating corrections from Table 31 from Section 3.5.3. Section 3.8.3 – Changed faceplate LED placement for 2xQSFP to primary side. Section 4.10.2 – Added FRU field to identify the card manageability type. 	0.82	08/03/2018
OCP NIC 3.0 Subgroup	- Section 5.3.4 – Removed subheadings for the PCIe test methodology. Replaced with reference text to the PCIe test specifications.	0.83	08/29/2018
OCP NIC 3.0 Subgroup	- Minor editorial changes Add appropriate trademarks per entity usage guidelines - Section 1.x – Reorganized section, added list of acronyms Section 1.5, 2.x – Mechanical updates from ME team. Updates to Vendor PN, pull tab/thumbscrew color Section 3.4.1, Section 3.5.x – Updated for LFF and applications with 32 lanes of PCIe. Included TX/RX lane indices for lanes[16:31], REFCLK[4:5], PERST[4:5]# and PWRBRK1 on the Secondary Connector Section 3.4.9 – Changed RFU[1:2] to RFU[3:4] for the Secondary Connector Section 3.7 – Removed bifurcation expansion tables. Redirected readers to the pinout/bifurcation spreadsheet on the OCP Mezz Wiki site instead. Merged Section 3.6 and 3.7 together as they both discuss PCIE REFCLK mapping. Add new diagrams depicting single, dual and quad host implementations with 1, 2, and 4 links. Diagrams show association of the link to the REFCLK and PERST signals Section 3.12 – Add RBT_ISOLATE# to the power up/down sequencing diagrams. Changed BIF[2:0]# pins to 'low' state when AUX_PWR_EN is	0.84	10/19/2018

deasserted. Add timing value "T4" from DSP0222 to power up diagram and sequencing parameters table.

- Section 7.1.4 – Corrected typo on NEBS air discharge value for ESD testing. Changed from 16 kV to 15 kV.